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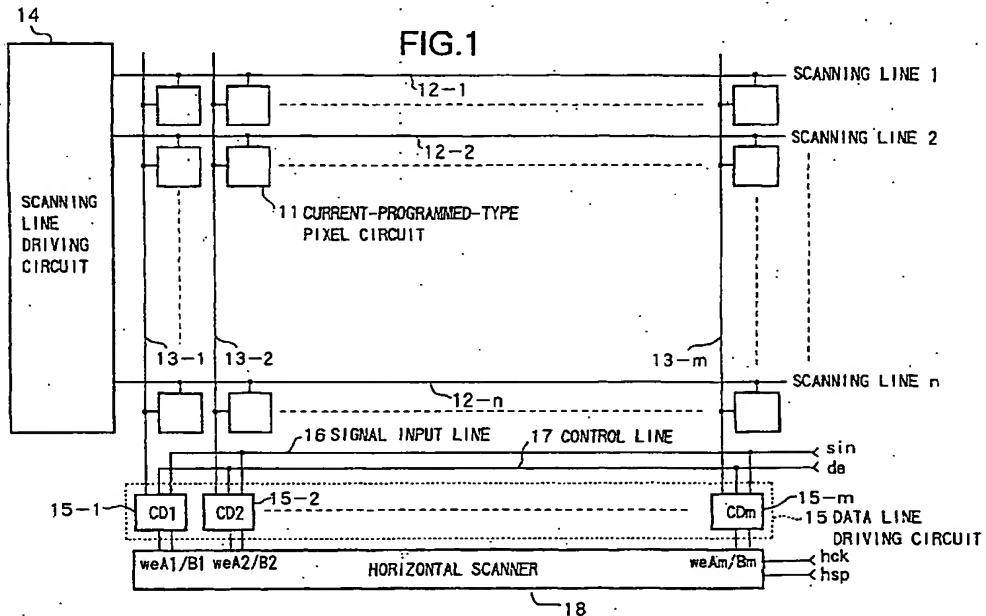
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(54) ACTIVE MATRIX DISPLAY AND ACTIVE MATRIX ORGANIC ELECTROLUMINESCENCE DISPLAY

(57) An active-matrix display device employs current-programmed-type pixel circuits and performs the writing data to each of pixels on a line-by-line basis. The active-matrix display device having a matrix of current-programmed-type pixel circuits includes a data line driving circuit 15 formed of m current driving circuits (CD)

15-1 to 15-m arranged corresponding to respective data lines 13-1 to 13-m. The data line driving circuit (CD) 15-1 to 15-m holds image data (luminance data herein) in the form of voltage, and then converts the voltage of the image data into a current signal. The current signal is then fed to the data lines 13-1 to 13-m at a time. The image information is thus written on the pixel circuits 11.



Description

TECHNICAL FIELD

5 [0001] The present invention relates to an active-matrix display device which has an active element on a per pixel basis and controls a display thereof on a per pixel basis by the active element. More particularly, the present invention relates to an active-matrix display device which employs, as a display element, an electrooptical element that changes the luminance level thereof in response to a current flowing therethrough, and an active-matrix organic electroluminescent (EL) display device which employs, as an electrooptical element, an organic electroluminescent element.

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BACKGROUND ART

15 [0002] A display device, using for example, liquid-crystal cells as display elements, includes a matrix of numerous pixels, and controls light intensity on a per pixel basis in response to image information to be displayed, thereby presenting a display on the pixels. An organic EL display employing organic EL elements is also driven in the same way.

20 [0003] However, the organic EL display, which is a self-emitting-type display using an emitting element as a display pixel, presents advantages of a high visibility of an image, compared with that provided by a liquid-crystal display, of requiring no backlight, and of a high response speed. The organic EL display is different from the liquid-crystal display in that the organic EL display is of a current control type while the liquid-crystal display is of a voltage control type.

25 Specifically, luminance of the organic EL element is controlled by a current flowing therethrough.

26 [0004] A simple (passive) matrix method and an active-matrix method are available to drive the organic EL display in the same as a liquid-crystal display. Although being simple in structure, the former method cannot be used in a large-scale and high-definition display. For this reason, active-matrix displays are now actively being developed in which a current flowing through an emitting element in each pixel is controlled by an active element (a thin-film transistor (TFT)) arranged within a pixel.

27 [0005] FIG. 33 shows a pixel circuit (a circuit for a unit pixel) in a conventional active-matrix organic EL display (disclosed in United States Patent No. 5,684,365 and Japanese Unexamined Patent Application Publication No. 8-234683).

28 [0006] Referring to FIG. 33, the conventional pixel circuit includes an organic EL element 101 with the anode thereof connected to a positive power source Vdd, a TFT 102 with the drain thereof connected to the cathode of the organic EL element 101 and the source thereof grounded, a capacitor 103 connected between the gate of the TFT 102 and ground, and a TFT 104 with the drain thereof connected to the gate of the TFT 102, with the source thereof connected to a data line 106, and with the gate thereof connected to a scanning line 105.

29 [0007] The organic EL element has a rectification feature, in many cases, so is sometimes referred to as an OLED (organic light emitting diode). Accordingly, the OLED is represented by a diode symbol in FIG. 33 and other figures. However, in the discussion that follows, rectification features are not a requirement.

30 [0008] The pixel circuit thus constructed operates as follows. Now, the scanning line 105 is in a selection state (at a high level, here) and the data line 106 is supplied with a writing potential Vw. The TFT 104 is turned on, charging or discharging the capacitor 103, and thereby the potential of the gate of the TFT 102 becomes the writing potential Vw. When the scanning line 105 is driven to a deselection potential (at a low level, here), the scanning line 105 is electrically disconnected from the TFT 102, but the gate voltage of the TFT 102 is reliably maintained by the capacitor 103.

35 [0009] A current flowing through the TFT 102 and the OLED 101 responds to a value of gate-source voltage Vgs of the TFT 102. The OLED 101 continuously emits light at a luminance level determined by the current value responsive to the gate-source voltage Vgs. In the following discussion, a "writing operation" refers to an operation to transfer luminance information, given to the data line 106, to within a pixel when the scanning line 105 is selected. As described above, in the pixel circuit shown in FIG. 33, once the writing operation is performed at the writing potential Vw, the OLED 101 continuously emits light at a constant luminance level.

40 [0010] Such pixel circuits (hereinafter also referred to as pixels) 111 are arranged in a matrix as shown in FIG. 34. A scanning line driving circuit 113 successively selects scanning lines 112-1 through 112-n while a data line driving circuit (a voltage driver) 114 of a voltage driving type writes data on data lines 115-1 through 115-m. The active-matrix display device (the organic EL display) is thus driven. The active-matrix display device here includes a matrix of n rows by m columns of pixels. In this case, the number of data lines is m, while the number of scanning lines is n.

45 [0011] In the passive-matrix display device, each emitting element emits light only at the moment it is selected. In the active-matrix display device, an emitting element continuously emits light even after the end of data writing. For this reason, the active-matrix display device outperforms the passive-matrix display device particularly in the field of large-scale and high-definition displays, because a low peak luminance and a low peak current of each light emitting element work in the active-matrix display device.

50 [0012] In the active-matrix organic EL display device, an insulated gate thin-film field-effect transistor (TFT) formed

on a glass substrate is typically used as an active element. Since amorphous silicon or polysilicon used in the formation of the TFT generally suffers from poor crystallinity, and a poor controllability in the conductive mechanism thereof, a resulting TFT is subject to large variations in the characteristics thereof.

[0013] When the polysilicon TFT is formed on a relatively large-sized glass substrate, crystallization is usually performed using laser annealing subsequent to the formation of an amorphous silicon layer to control a thermal deformation of the glass substrate. However, it is difficult to uniformly irradiate a relatively large-sized glass substrate with laser energy, and the polysilicon suffers from localized variations in the crystallization state thereof. As a result, the threshold voltage V_{th} of the TFTs formed on the same substrate vary within a range of several hundreds of mV, in certain cases, 1V or more.

[0014] In this case, even if the same potential V_w is written on different pixels, the threshold value V_{th} of the TFT varies from pixel to pixel. The current I_{ds} flowing through the OLED greatly varies from pixel to pixel, and the display device cannot be expected to present a high-quality image. Variations take place not only in the threshold value V_{th} but also in the mobility μ of the carrier.

[0015] The inventor of the present invention has proposed a current-programmed-type pixel circuit as shown in FIG. 35 to resolve the above problem (reference is made to International Publication No. WO01-06484).

[0016] A current-programmed-type pixel circuit includes an OLED 121 with the cathode thereof connected to a negative power source V_{ss} ; a TFT 122 with the drain thereof connected to the anode of the OLED 121, and with the source thereof connected to ground, which serves as a reference potential point, a capacitor 123 connected between the gate of the TFT 122 and ground, a TFT 124 with the gate thereof connected to the gate of the TFT 122 and with the source thereof grounded, a TFT 125 with the drain thereof connected to the drain of the TFT 124, with the source thereof connected to a data line 128, and with the gate thereof connected to a scanning line 127, and a TFT 126 with the drain thereof connected to each of the gates of the TFT 122 and the TFT 124, with the source thereof connected to each of the drains of the TFT 124 and the TFT 125, and with the gate thereof connected to the scanning line 127.

[0017] In this circuit, the TFT 122 and the TFT 124 are PMOS field-effect transistors, and the TFT 125 and the TFT 126 are NMOS type. FIGS. 36A to 36C are timing diagrams of the pixel circuit in the driving operation thereof.

[0018] The pixel circuit shown in FIG. 35 is different from that shown in FIG. 33. Luminance data is given in the form of voltage in the pixel circuit shown in FIG. 33, while the same data is given in the form of current in the pixel circuit shown in FIG. 35. The operation of the circuit shown in FIG. 35 will now be discussed.

[0019] To write the luminance information, the scanning line 127 is set to a selection state and a current I_w corresponding to the luminance information flows through the data line 128. The current I_w flows through the TFT 124 via the TFT 125. The gate-source voltage generated between the gate and the source of the TFT 124 is referred to as V_{gs} . During the writing operation, the TFT 124 operates in the saturation region thereof because the TFT 126 shorts the gate and the drain of the TFT 124.

[0020] The following well-known equation of the MOS transistor holds.

$$I_w = \mu_1 C_{ox1} W_1 / L_1 / 2 (V_{gs} - V_{th1})^2 \quad (1)$$

[0021] In equation (1), V_{th1} is a threshold value of the TFT 124, μ_1 is the mobility of the carrier, C_{ox1} is the gate capacitance per unit area, W_1 is the channel width, and L_1 is the channel length.

[0022] A current flowing through the OLED 121 is referred to as I_{drv} , the current I_{drv} is controlled the value by the TFT 122 connected in series with the OLED 121. In the pixel circuit shown in FIG. 35, the gate-source voltage of the TFT 122 agrees with V_{gs} in the equation (1). On the assumption that the TFT 122 operates in the saturation region thereof, the following equation (2) holds.

$$I_{drv} = \mu_2 C_{ox2} W_2 / L_2 / 2 (V_{gs} - V_{th2})^2 \quad (2)$$

[0023] The condition under which the MOS transistor operates in the saturation region thereof is expressed by the following equation (3).

$$IV_{ds1} > IV_{gs} - V_{th1} \quad (3)$$

[0024] The symbols in the equations (2) and (3) are identical to those used in the equation (1). Since the TFT 124 and the TFT 122 are formed closely in a small area within the pixel, in practice, $\mu_1 = \mu_2$, $C_{ox1} = C_{ox2}$, and $V_{th1} = V_{th2}$. From the equations (1) and (2),

$$I_{drv}/I_w = (W_2/W_1)/(L_2/L_1) \quad (4)$$

[0025] Even if the mobility μ of the carrier, the gate capacitance C_{ox} per unit area, and the threshold value V_{th} are varied within a panel, or from panel to panel, the luminance of the OLED 121 is precisely controlled because the current I_{drv} flowing through the OLED 121 is accurately proportional to the writing current I_w . For example, if the transistors are designed with the conditions of $W_2=W_1$ and $L_2=L_1$ satisfied, $I_{drv}/I_w=1$. Specifically, the writing current I_w equals the current I_{drv} flowing through the OLED 121 regardless of variations in the TFT characteristics.

[0026] In the active-matrix display device, the writing of the luminance data to each pixel is basically performed on a scanning line by scanning line basis. For example, in a liquid-crystal display using amorphous silicon TFTs, the writing of the luminance data is performed on the pixels arranged on a selected scanning line at a time basis. The writing on a per scanning line basis is now referred to a line-by-line writing operation.

[0027] In the display device working on a line at a time writing operation, the data line driver is manufactured using a typical monolithic semiconductor technology in a manufacturing process different from the manufacturing process of the pixel circuit (TFT) in the display panel. A data line driving circuit having reliable characteristics is thus easily manufactured. On the other hand, since it is necessary to have a plurality of data line drivers, the number of which is equal to the number of data lines in the display device, the entire system becomes bulky in size and costly. To manufacture a display device having a large number of pixels or pixels arranged in a narrow pitch, the number of lines and connections of a display panel with the drivers external to the panel become large. The effort to develop a large-scale and high-definition display device is subject to a limitation in terms of the reliability of the connections and the wiring pitch.

[0028] The "drivers external to the panel" are literally arranged outside the display panel (the glass substrate), and are occasionally connected to the panel using a flexible cable. The drivers external to the panel are sometimes mounted on the panel (the glass substrate) using the TAB (Tape Automated Bonding) technology. The phrase "drivers external to the panel" is and will be used in the context of the above two arrangements.

[0029] With its high transistor driving performance, the liquid-crystal display using the polysilicon TFT writes data on a single pixel for a short period of time, and a dot-by-dot writing operation is typically adopted. FIG. 37 shows the construction of a display device working on a dot-by-dot writing operation and FIGS. 38A to 38F are timing diagrams of the display device. Note that in FIG. 37, the same parts as those of FIG. 34 are indicated by the same symbols as those of FIG. 34.

[0030] Referring to FIG. 37, horizontal switches HSW1-HSWm are respectively connected between the ends of data lines 115-1 through 115-m and a signal input line 116. The horizontal switches HSW1-HSWm are turned on and off by selection pulses $we1-wem$ that are successively output from a horizontal scanner (HSCAN) 117. The horizontal switches HSW1-HSWm and the horizontal scanner 117 are formed of TFTs, and are manufactured in the same manufacturing process as that of a pixel circuit 111.

[0031] The horizontal scanner 117 receives a horizontal start pulse hsp and a horizontal clock hck . Referring to FIGS. 38A to 38F, subsequent to the input of the horizontal start pulse hsp , the horizontal scanner 117 successively generates the selection pulses $we1-wem$ to select the horizontal switches HSW1-HSWm, in response to the transition of the horizontal clock hck (the rising edge or the falling edge of the horizontal clock hck).

[0032] Each of the horizontal switches HSW1-HSWm becomes conductive when the corresponding one of the selection pulses $we1-wem$ is fed, thereby transferring image data (a voltage value) sin to each of the data lines 115-1 through 115-m through the signal input line 116. In this way, the writing of the data on the pixels of the scanning line selected by the scanning line driving circuit 113 is performed on a dot-by-dot basis. The voltage given to the data lines 115-1 through 115-m is held by a capacitive component such as a stray capacity of each of the data lines 115-1 through 115-m even after the horizontal switches HSW1-HSWm becomes non-conductive.

[0033] When m clocks of the horizontal clock hck are fed, the data is written on all pixels on the selected scanning line. Since the display device working on a dot-by-dot basis uses the single signal input line 116 on a time sharing manner, the number of connection points between the display panel and the data line drivers (a circuit for feeding the image data sin) external to the display panel is small in number, and the number of the external drivers is accordingly small.

[0034] When the current-programmed-type pixel circuit shown in FIG. 35 is adopted as the pixel circuit, however, it is impossible to normally write the data on the pixels 111 in the display device shown in FIG. 37. The reason for this will be discussed.

[0035] When the signal input line 116 is driven by a current source with a particular horizontal switch HSW being selected and conductive in FIG. 37, a normal current writing is performed on a pixel on a data line of the selected horizontal switch HSW. When the current writing starts on another data line with the horizontal clock hck input to the horizontal scanner 117 thereafter, the horizontal switch HSW, which was selected until then, becomes conductive at the moment of writing. The current flowing into the corresponding data line becomes zero.

[0036] To perform the normal writing, a predetermined writing current needs to be fed to all pixels on the scanning

line when the scanning lines are switched from the selection state to the deselection state thereof. In other words, when the current-programmed-type pixel circuit is adopted, the data writing on the pixels needs to be performed on a line-by-line basis. Referring to FIG. 39, a data line driver 118 arranged external to the display panel needs to be used to concurrently write the data onto the pixels on the selected scanning line.

[0037] The circuit shown in FIG. 39 is essentially identical in construction to the circuit of a line-by-line driving method shown in FIG. 34. As a result, the circuit shown in FIG. 39 has the problem that the number of current drivers CD1-CDm forming the data line driving circuit 118 and the number of connection points between the current drivers and the display panel increase.

10 DISCLOSURE OF THE INVENTION

[0038] Accordingly, it is an object of the present invention to provide an active-matrix display device and an active-matrix organic EL display device which can realize a normal current writing operation with connection points between a display panel and external data line drivers reduced in number with a current-programmed-type pixel circuit incorporated.

[0039] An active-matrix display device of the present invention includes a display section including a matrix of pixel circuits of a current-programmed-type which writes image information by a current, a plurality of scanning lines for selecting each pixel circuit, and a plurality of data lines which supplies each pixel circuit with the image information, and a driving circuit which holds the image information for each pixel circuit in the form of voltage, and then writes the image information onto each of the plurality of data lines after converting the voltage image information in the form of voltage into the information in the form of current.

[0040] Even if active elements in the current-programmed-type pixel circuit varies in characteristics in the above-referenced active-matrix display device, luminance of the display element is precisely controlled because the current flowing through the display element is accurately proportional to the writing current. The driving circuit holds image information, and then gives the image information to the data lines in the form of current. In this way, the driving circuit writes the image information on pixel circuits on a line-by-line basis.

BRIEF DESCRIPTION OF THE DRAWINGS

30 [0041]

FIG. 1 is a block diagram showing an active-matrix display device according to a first embodiment of the present invention;
 FIGS. 2A to 2K are timing diagrams for explaining the circuit operation of the active-matrix display device according to the first embodiment;
 FIG. 3 is a cross-sectional view of an example of the configuration of an organic EL element;
 FIG. 4 is a circuit diagram showing a first circuit example of the data line driver;
 FIGS. 5A to 5D are timing diagrams illustrating the operation of the first circuit example of the data line driver;
 FIG. 6 is a circuit diagram showing a second circuit example of the data line driver;
 FIG. 7 is a circuit diagram showing a modification of the second circuit example of the data line driver;
 FIG. 8 is a block diagram showing an example of the configuration of an active-matrix display device according to a second embodiment of the present invention;
 FIGS. 9A to 9J are timing diagrams for explaining the circuit operation of the active-matrix display device according to the second embodiment;
 FIG. 10 is a circuit diagram showing a third circuit example of the data line driver;
 FIG. 11 is a block diagram showing an example of the configuration of an active-matrix display device according to a modification of the second embodiment;
 FIG. 12 is a block diagram showing an example of the configuration of an active-matrix display device according to another modification of the second embodiment;
 FIG. 13 is a block diagram showing an example of the configuration of an active-matrix display device according to yet another modification of the second embodiment;
 FIG. 14 is a circuit diagram showing a fourth circuit example of the data line driver;
 FIGS. 15A to 15C are timing diagrams illustrating the circuit operation of the fourth circuit example of the data line driver;
 FIG. 16 is a circuit diagram showing a modification of the fourth circuit example of the data line driver;
 FIG. 17 is a circuit diagram of a fifth circuit example of the data line driver;
 FIG. 18 is a block diagram showing an example of the configuration of an active-matrix display device according to a third embodiment of the present invention;

FIG. 19 is a circuit diagram showing a sixth circuit example of the data line driver;
 FIGS. 20A to 20G are timing diagrams illustrating the circuit operation of the sixth circuit example of the data line driver;
 FIG. 21 is a timing diagram showing seventh circuit example of the data line driver;
 FIG. 22 is a circuit diagram showing an eighth circuit example of the data line driver;
 FIGS. 23A to 23D are timing diagrams illustrating the circuit operation of the eighth circuit example of the data line driver;
 FIG. 24 is a circuit diagram showing a modification of the eighth circuit example of the data line driver;
 FIG. 25 is a circuit diagram showing another modification of the eighth circuit example of the data line driver;
 FIGS. 26A to 26D are timing diagrams illustrating the circuit operation of another modification of the eighth circuit example of the data line driver;
 FIG. 27 is a block diagram showing an example of the configuration of an active-matrix display device according to a fourth embodiment of the present invention;
 FIGS. 28A to 28C are views for explaining the operation of the active-matrix display device of the fourth embodiment;
 FIG. 29 is a block diagram showing an example of the configuration of an active-matrix display device according to a fifth embodiment of the present invention;
 FIG. 30 is a view for explaining the effect of a leakage (LK) element in the active-matrix display device of the fifth embodiment;
 FIG. 31 is a block diagram showing an example of the configuration of an active-matrix display device according to a sixth embodiment of the present invention;
 FIG. 32 is a view for explaining the effect of a precharge (PC) element in the active-matrix display device of the sixth embodiment;
 FIG. 33 is a circuit diagram showing a pixel circuit of a conventional art;
 FIG. 34 is a block diagram showing the configuration of an active-matrix display device working on a line-by-line basis;
 FIG. 35 is a circuit diagram showing the configuration of a current-programmed-type pixel circuit of a conventional art;
 FIGS. 36A to 36C are timing diagrams for explaining the circuit operation of the conventional current-programmed-type pixel circuit;
 FIG. 37 is a block diagram showing an example of the configuration of an active-matrix display device working on a dot-by-dot basis;
 FIGS. 38A to 38F are timing diagrams for explaining the circuit operation of an active-matrix display device working on a dot-by-dot driving method; and
 FIG. 39 is a block diagram showing an example of the configuration of an active-matrix display device employing a current-programmed-type pixel circuit.

BEST MODE FOR CARRYING OUT THE INVENTION

[0042] Referring to the drawings, the embodiments of the present invention will now be discussed.

First Embodiment

[0043] FIG. 1 is a block diagram showing an example of the configuration of an active-matrix display device according to a first embodiment of the present invention. As shown in FIG. 1, a plurality of pixel circuits 11 is arranged in a matrix, forming a display area (a display unit). The display area includes a matrix of n rows by m columns of pixels. The display area includes n scanning lines 12-1 through 12- n for selecting each pixel (each pixel circuit) and m data lines 13-1 through 13- m for supplying each pixel with image data such as luminance data.

[0044] A scanning line driving circuit 14 for selecting the scanning lines 12-1 through 12- n and a data line driving circuit 15 for driving the data lines 13-1 through 13- m are arranged external to the display area. The scanning line driving circuit 14 is formed of a shift register, for example, and output terminals of stages thereof are respectively connected to the ends of the scanning lines 12-1 through 12- n . As will be discussed later, the data line driving circuit 15 is composed of m current-programmed-type current drivers (CDs) 15-1 through 15- m . The output terminals of the current-programmed-type current drivers (hereinafter simply referred to as current drivers) 15-1 through 15- m are respectively connected to the ends of the data lines 13-1 through 13- m .

[0045] The current drivers 15-1 through 15- m in the data line driving circuit 15 are supplied with the image data (the luminance data) sin from the external via a signal input line 16 while being supplied with a driving control signal de from the external via a control line 17. The current drivers 15-1 through 15- m respectively arranged for the data lines

13-1 through 13-m share the single signal input line 16, and receives the image data through the signal input line 16 in a time sharing manner. The current drivers 15-1 through 15-m are supplied with two series of writing control signals weA1-weAm and weB1-weBm by a horizontal scanner (HSCAN) 18.

[0046] The horizontal scanner 18 receives a horizontal start pulse hsp and a horizontal clock hck. Referring to FIGS. 5 2A to 2K, the horizontal scanner 18 is composed a shift register, for example, and, subsequent to the reception of the horizontal start pulse hsp, the horizontal scanner 18 successively generates the writing control signals weA1-weAm and weB1-weBm in response to the level transition of the horizontal clock hck (the rising edge and the falling edge of the horizontal clock hck). The writing control signals weA1-weAm are respectively slightly delayed from the writing control signals weB1-weBm.

[0047] The active-matrix display device having the above configuration according to the first embodiment employs the current-programmed-type pixel circuit shown in FIG. 35 as the pixel circuit 11, for example.

[0048] The current-programmed-type pixel circuit includes an organic EL element (OLED) with luminance level thereof controlled by the current, as a display element of the pixel circuit 11, four TFTs (insulated gate thin-film field-effect transistors), and one capacitor. The luminance data is given in the form of current. The pixel circuit 11 is not limited to the one shown in FIG. 35, and any pixel circuit is acceptable as long as it is of a current-programmed-type.

[0049] The construction of one example of the organic EL element will now be discussed. FIG. 3 is a cross-sectional view of an organic EL element. The organic EL element shown in FIG. 3 includes a first electrode 22 (an anode for example), manufactured of an electrically conductive, transparent layer, on a substrate 21 manufactured of transparent glass, an organic layer 27, including a hole transfer layer 23, a light emission layer 24, an electron transfer layer 25, and an electron injection layer 26, successively formed on the first electrode 22, and a second electrode 28 (such as a cathode), of a metal, formed on the organic layer 27. By applying a direct current E between the first electrode 22 and the second electrode 28, the light emission layer 24 emits light in the course of recombination of holes and electrodes therewithin.

[0050] The pixel circuit including an organic EL device (OLED) typically employs a TFT as an active element formed on a glass substrate. The scanning line driving circuit 14 is formed of circuit elements such as TFTs on the glass substrate (a display panel) bearing the pixel circuit. The current drivers 15-1 through 15-m may also be produced of circuit elements such as TFTs on the same display panel (the glass substrate). It is not a requirement that the current drivers 15-1 through 15-m be formed on the display panel. The current drivers 15-1 through 15-m may be arranged external to the panel.

First Circuit Example

[0051] FIG. 4 is a circuit diagram specifically showing one of the current drivers 15-1 through 15-m forming the data line driving circuit 15. All the current drivers 15-1 through 15-m are identical to each other in configuration.

[0052] The current driver in the first embodiment includes four TFTs 31-34, and one capacitor 35. In this circuit example, all the TFTs 31-34 are manufactured of NMOS transistors, but the present invention is not limited this type of transistor.

[0053] In FIG. 4, the TFT 31 with the source thereof grounded functions as a converting unit. The drain of the TFT 31 are the sources of the TFT 32 and the TFT 33, and the drain of the TFT 34. The TFT 32 is a first switching element with the drain thereof connected to the signal input line 16, and with the gate thereof receiving a first writing control signal weA. The TFT 33 with the drain thereof connected to a data line 13 functions as a driving unit, and receives, at the gate thereof, a driving control signal de through the control line 17. The TFT 34, with the source thereof connected to the gate of the TFT 31, functions as a second switching element, and receives, at the gate thereof, a second writing control signal weB. The capacitor 35, forming a holding unit, is arranged between the node of the gate of the TFT 31 and the source of the TFT 34 and ground.

[0054] Next, the circuit operation of the current driver thus constructed will now be discussed, referring to waveform diagrams of FIGS. 5A to 5D.

[0055] To perform a writing operation to the current driver, both the first writing control signal weA and the second writing control signal weB are set to be in a selection state. Here, the selection state is that both signals are at a high-level state. The driving control signal de is in a deselection state (at a low level here). The writing current I_w flows into the TFT 31 from the source of the TFT 32 by connecting the current source CS of the writing current I_w to the signal input line 16.

[0056] Since the TFT 34 shorts the gate and the drain of the TFT 31, the equation (3) holds, and the TFT 31 operates in the saturation region thereof. The gate-source voltage V_{gs} is generated between the gate and the source of the TFT 31 as expressed in the following equation (5).

$$I_w = \mu \text{Cox} W/L/2 (V_{gs}-V_{th})^2 \quad (5)$$

5 where V_{th} is the threshold value of the TFT 31, μ is the carrier mobility, Cox is the gate capacitance per unit area, W is the channel width, and the L is the channel length.

10 [0057] Next, the first writing control signal weA and the second writing control signal weB are set to be in a deselection state. Specifically, the second writing control signal weB is driven low, turning off the TFT 34. The voltage V_{gs} generated between the gate and the source of the TFT 31 is held by the capacitor 35. The first writing control signal weA is then driven low, turning off the TFT 32, and thereby electrically isolating the current driver from the current source CS . The current source CS is then able to perform a writing operation on another current driver. The TFT 33 drives the data line 13 based on the voltage V_{gs} held in the capacitor 35.

15 [0058] At the end of the writing to the current driver, the TFT 34 is first turned off, and the TFT 32 is then turned off. By turning off the TFT 34 prior to the TFT 32, the luminance data is reliably written. The data driven by the current source CS has to be effective when the second writing control signal weB is in a deselection state. Thereafter, the data can be at any level (for example, can be write data to the next current driver).

20 [0059] When the driving control signal de is in a selection state (at a high level here), the current flowing through TFT 31 operating in the saturation region thereof is expressed by the following equation (6).

$$I_d = \mu \text{Cox} W/L/2 (V_{gs}-V_{th})^2 \quad (6)$$

25 [0060] This current flows through the data line 13, and agrees with the above-mentioned writing current I_w .

30 [0061] The circuit shown in FIG. 4 converts the luminance data sin written in the form of current into a voltage, and holds the voltage in the capacitor 35, and drives the data line 13 with a current substantially equal to the written current in response to the voltage held in the capacitor 35 even after the writing. In this operation, the absolute values of the carrier mobility μ and the threshold value V_{th} in the equations (5) and (6) are not a problem. In other words, the circuit shown in FIG. 4 is able to drive the data line 13 with the current accurately equal to the written current regardless of variations in the TFT characteristics.

35 [0062] The active-matrix display device shown in FIG. 1 according to the first embodiment now includes the current-programmed-type pixel circuit shown in FIG. 35 as the pixel circuit 11, and the current-programmed-type drivers shown in FIG. 4 as the current drivers 15-1 through 15-m. The operation of the active-matrix display device shown in FIG. 1 will now be discussed, with reference to a timing diagram shown in FIGS. 2A to 2K.

40 [0063] As explained above, subsequent to the input of the horizontal start pulse hsp , the horizontal scanner 18 successively generates the first and second series writing control signals $weA1-weAm$ and $weB1-weBm$ in response to the level transition of the horizontal clock hck . The writing control signals $weA1-weAm$ are respectively slightly delayed from the writing control signals $weB1-weBm$. The luminance data sin is input in synchronization with the writing control signals $weA1-weAm$ and $weB1-weBm$ from the signal input line 16 in the form of current.

45 [0064] When m clocks of the horizontal clock hck are input, the luminance data sin is written on the m current drivers 15-1 through 15-m. During the data writing, the driving control signal de remains in a deselection state. At the moment the writing of all current drivers 15-1 through 15-m is complete, the driving control signal de is set to a selection state, and the data lines 13-1 through 13-m are thus driven. Since a k -th scanning line 12-k is selected during the selection state of the driving control signal de , a line-by-line writing operation is performed on the pixel circuits 11 connected to the scanning line 12-k.

50 [0065] The data writing is complete at the moment the scanning line 12-k is deselected. However, the driving control signal de remains in a selection state at that moment in the timing diagram shown in FIGS. 2A to 2K, and effective write data (writing current) is thus maintained until the end of the writing. However, since the writing onto the current drivers 15-1 through 15-m and the driving of the data lines 13-1 through 13-m are performed serially within one scanning period (typically one frame period/the number of scanning lines) in this driving method, it is sometimes difficult to assure sufficient time for the writing and the driving of the data line.

Second Circuit Example

55 [0066] FIG. 6 is a circuit diagram showing another circuit example of the current drivers 15-1 through 15-m. In the figure, the same parts as those of FIG. 4 are indicated by the same symbols as those of FIG. 4.

[0067] The current driver of this example further includes, besides the circuit elements shown in FIG. 4, an impedance transforming Transistor, that is a PMOS type TFT 40 having a different conductive type from that of the TFT 31, arranged between the TFT 31 and the current source CS , and operating in the saturation region thereof during the writing of the

luminance data sin. The impedance transforming TFT 40 is actually connected to the TFT 31 through the TFT 32. With this arrangement, the writing of the luminance data sin onto the current driver is performed faster than the circuit shown in FIG. 4. The reason for this will be discussed.

[0068] In the current writing, there is a problem that the time required to the writing is typically longer. When the current I_w is written on the current driver shown in FIG. 4, the output resistance of the current source CS is theoretically infinite, and the resistance of the circuit is determined by the TFT 31 shown in FIG. 4. On the other hand, the driving capability of the TFT in the panel is typically small, in other words, input resistance thereof is high. For this reason, it takes time for the signal input line 16 to reach a steady state.

[0069] The time required to complete the writing in the circuit shown in FIG. 4 is now determined. During the writing, the TFT 34 shorts the gate and the drain of the TFT 31, and the TFT 31 operates in the saturation region thereof. By differentiating both sides of the equation (1) of the MOS transistor with the gate-source voltage V_{gs} , the following equation (7) results.

$$1/R_n = \mu n Cox Wn/Ln (V_{gsn}-V_{th}) \quad (7)$$

[0070] Since the TFT 31 is an NMOS transistor, each symbol is suffixed with the letter n. R_n represents a differentiated resistance viewed from the signal input line 16 of the TFT 31. This is the input resistance of the signal input line 16. The TFT 32 is an analog switch, having resistance characteristics. However, the resistance of the TFT 32 is set to be small enough compared with that of the TFT 31, and is actually neglected.

[0071] The following equation (8) is obtained from the equations (1) and (7).

$$R_n = 1/\sqrt{2\mu n Cox Wn/Ln \cdot I_w} \quad (8)$$

[0072] The input resistance R_n of the TFT 31 is inversely proportional to the square root of the writing current I_w , and becomes large value if the writing current I_w is small. Let C_s represent the capacitance C_s associated with the signal input line 16, and the time constant in the writing operation is expressed by the following equation (9) in the vicinity of the steady state.

$$\tau = C_s \times R_n \quad (9)$$

[0073] Since the current source CS for supplying the signal input line 16 with a signal current is typically formed of parts external to the panel, the current source CS is typically spaced apart from the data line driving circuit 15. The capacitance C_s tends to be large. The input resistance R_n of the TFT 31 increases with the writing current I_w decreasing. A long writing time required to write a small current becomes a serious problem.

[0074] To shorten the writing time, the input resistance R_n of the TFT 31 needs to be reduced from the equation (9). By setting the current corresponding to the maximum luminance value to be larger, the writing current I_w is prevented from becoming too small at a small luminance value. However, this arrangement increases power consumption. The increasing of Wn/Ln of the TFT 31 is contemplated. Since this arrangement causes the TFT 31 to be used with a smaller gate voltage amplitude, the driving current is more easily affected by a low-level noise.

[0075] The circuit operation of the circuit shown in FIG. 6 is now considered. The current source CS is connected to the signal input line 16, and a relatively large parasitic capacitance capacitor C_s is present between the current source CS and the current driver. Now, the writing operation of writing current I_w is now considered. When the impedance transforming TFT 40 operates in the saturation region thereof, the following equation (10) holds in the steady state in accordance with the equation (1).

$$I_w = \mu p Cox Wp/Lp/2 (V_{gs}-V_{tp})^2 \quad (10)$$

where the symbols here are suffixed with the letter p because the impedance transforming TFT 40 is a PMOS transistor.

[0076] Considering that the signal input line 16 is the source of the impedance transforming TFT 40 in the circuit example of FIG. 6, the following equation (11) holds.

$$I_w = \mu p Cox Wp/Lp/2 (V_{in}-V_g-V_{tp})^2 \quad (11)$$

where V_{in} and V_g respectively represent the voltage of the signal input line 16 and the gate voltage of the impedance transforming TFT 40, each with respect to ground.

[0077] If both sides of the equation (11) is differentiated with the voltage V_{in} of the signal input line 16, the following equation (12) results.

5

$$1/R_p = \mu_p C_{ox} W_p / L_p (V_{in} - V_g - IV_{tp1}) \quad (12)$$

where R_p is a differentiated resistance viewed from the signal input line 16 of the impedance transforming TFT 40, and is an input resistance of the signal input line 16. The following equation (13) is obtained from the equations (11) and (12).

10

$$R_p = 1 / (2\mu_p C_{ox} W_p / L_p \cdot I_w) \quad (13)$$

15

[0078] The time constant in the writing operation is expressed by the following equation (14) in the vicinity of steady state.

20

$$\tau = C_s \times R_p \quad (14)$$

[0079] It is noted that the time constant in the writing operation is determined by the P-channel TFT 40 regardless of the parameters (W_n , L_n , etc.) relating to the TFT 31. Specifically, if the W_p / L_p of the impedance transforming TFT 40 is set to be large, the input resistance R_p of the signal input line 16 decreases in accordance with the equation (13), and the time constant in the writing operation decreases in accordance with the equation (14). The writing operation is thus expedited without modifying the magnitude of the writing current I_w or the parameters of the TFT 31, in other words, without an increase in power consumption and an increase in susceptibility to noise.

[0080] With the writing operation expedited, the signal input line 16 is used in a time sharing manner for a predetermined duration of time to write many pieces of data on a row of data line drivers. This arrangement reduces the number of connection points between the panel and the current source C_s external to the panel, and the number of the current sources C_s .

[0081] A method of operating the impedance transforming TFT 40 in the saturation region thereof will now be discussed. The condition under which the MOS transistor operates in the saturation region thereof is determined by the equation (3). The condition of the PMOS transistor may be rewritten as follows:

35

$$V_d < V_g + IV_{tp1} \quad (15)$$

where V_d and V_g respectively represent the drain voltage and the gate voltage of the PMOS transistor referenced to ground.

[0082] The writing time becomes a concern when the writing current I_w is small. Now, a writing current I_w close to zero is considered. The TFT 34 electrically shorts the gate and the drain of the TFT 31, and a current flowing therethrough is nearly zero. For this reason, the drain voltage is approximately V_{tn} , and also equals the drain voltage V_d of the impedance transforming TFT 40. The equation (15) may be rewritten as the following equation (16).

45

$$V_{tn} < V_g + IV_{tp1} \quad (16)$$

[0083] To allow the TFT 40 to operate in the saturation region thereof, the equation (16) must hold. Specifically, the relationship of $V_{tn} < IV_{tp1}$ must hold if the gate voltage $V_g = 0$, or the gate voltage V_g must be higher than zero.

[0084] As described above, by connecting the impedance transforming transistor (the P-channel TFT 40 here) operating in the saturation region thereof when the luminance data sin is written, between the TFT 31 and the current source C_s , it is possible to write the luminance data sin on the current driver faster than the circuit shown in FIG. 4. This arrangement enables the signal input line 16 to write many pieces of data on the row of data line drivers in a time sharing manner within a constant duration of time. The number of connection points between the panel and the current source C_s external to the panel and the number of the current sources C_s are reduced.

[0085] In this circuit example, the P-channel TFT 40 together with the TFT 32 is arranged between the TFT 31 and the current source C_s . Alternatively as shown in FIG. 7, the P-channel TFT 40 operating in the saturation region thereof

5 during the writing of the luminance data sin may replace the TFT 32 in order to allow the P-channel TFT 40 itself to perform both functions of impedance transformation and switching (performed by the TFT 32 in FIG. 6). This modification presents the same advantages as those of the circuit. In the case of the modification example, since the number of transistors is reduced with one per current driver, the circuit arrangement becomes simplified and less costly.

10 Second Embodiment

[0086] FIG. 8 is a block diagram of an example of the configuration of an active-matrix display device according to a second embodiment of the present invention. In the figure, the same parts as those of FIG. 1 are indicated by the same symbols as those of FIG. 1. The active-matrix display device of the second embodiment is different from that of the first embodiment in the construction of a data line driving circuit 15'.

[0087] In the first embodiment, the data line driving circuit 15 is composed of a single row of current drivers 15-1 through 15-m, while the data line driving circuit 15' of the second embodiment includes two rows of current drivers 15A-1 through 15A-m and 15B-1 through 15B-m. The two rows of current drivers 15A-1 through 15A-m and 15B-1 through 15B-m are supplied with the image data (the luminance data here) sin through the signal input line 16.

[0088] The two rows of current drivers 15A-1 through 15A-m and 15B-1 through 15B-m are respectively supplied with two driving control signals de1 and de2 through two control lines 17-1 and 17-2. With reference to the timing diagram shown in FIGS. 9A to 9J, the two driving control signals de1 and de2 are inverted in polarity and are mutually opposite in phase every scanning period.

[0089] Referring to FIGS. 9A to 9J, subsequent to the input of the horizontal start pulse hsp, the horizontal scanner 18 successively generates a series of writing control signals we1-wem in response to the level transition of the horizontal clock hck (the rising edge and the falling edge of the horizontal clock hck). This series of writing control signals we1-wem are fed to the two rows of current drivers 15A-1 through 15A-m and 15B-1 through 15B-m.

25 Third Circuit Example

[0090] FIG. 10 is a circuit diagram showing a concrete circuit example of the current drivers 15A-1 through 15A-m and 15B-1 through 15B-m. In the figure, the same parts of those of FIG. 4 are indicated by the same symbols as those of FIG. 4. The current driver according to the present example is identical to the current driver shown in FIG. 4 in that it includes the four TFTs 31-34 and the single capacitor 35.

[0091] The current driver shown in FIG. 10 is different from that shown in FIG. 4 in a circuit controlling the TFT 32 and the TFT 34. The control circuit includes three inverters 36, 37, and 38 and an NOR circuit 39. The inverter 36 inverts the polarity of the writing control signal we supplied from the horizontal scanner 18, and then feeds the writing control signal we to one input of the NOR circuit 39. The NOR circuit 39 receives, at the other input, a driving control signal de1 (or de2) supplied through a control line 17-1 (or 17-2) from outside.

[0092] The driving control signal de1 (or de2), transferred through the NOR circuit 39, is directly fed to the gate of the TFT 34 while being input to the gate of the TFT 32 through the inverters 37 and 38. The inverters 37 and 38 present a delay time equal to the delay time by which the first writing control signal weA is delayed from the second writing control signal weB shown in FIGS. 2A to 2K. The driving control signal de1 (or de2), transferred through the NOR circuit 39, is input to the gate of the TFT 32 after being delayed by that delay time.

[0093] In the current driver having the above-mentioned configuration, the circuit operation of the current driver is basically identical to that of the current driver shown in FIG. 4. Specifically, the luminance data sin in the form of current is converted into a voltage, which is then held in the capacitor 35. After the writing of the data, the data line 13 is driven by a current substantially equal to the written current based on the voltage held in the capacitor 35.

[0094] In the current driver according to the present example, it is possible to write the luminance data sin by setting the driving control signal de1 (or de2) to a deselection state (at a low level) and the writing control signal we to a selection state (at a high level). By setting the driving control signal de1 (or de2) to a selection state, the data line 13 is driven, regardless of the state of the writing control signal we.

[0095] The inverters 37 and 38 form a delay circuit, as already described. Because of the delay function of the inverters 37 and 38, the TFT 34 is turned off before the TFT 32 when the writing to the current driver ends. The data writing is thus reliably performed.

[0096] The active-matrix display device of the second embodiment shown in FIG. 8 thus includes the current-programmed-type pixel circuit shown in FIG. 35 as the pixel circuit 11 and the current-programmed-type current driver shown in FIG. 10. The operation of the active-matrix display device thus constructed will now be discussed with reference to a timing diagram shown in FIGS. 9A to 9J.

[0097] During a selection period of a k-th scanning line 12-k, the driving control signal de1 is set to a deselection state, and the device becomes capable of writing the luminance data sin onto the first row of data line drivers (the current drivers 15A-1 through 15A-m) from the signal input line 16. Meanwhile, the writing control signals we1-wem

are successively output from the horizontal scanner 18 in response to the horizontal clock hck, and in synchronization with the writing control signals we1-wem, the luminance data sin in the form of current is given to the signal input line 16, and the luminance data is then written onto the first row of data line drivers.

[0098] When a (k+1)-th scanning line 12-(k+1) is selected, the driving control signal de1 is set to a selection state, and the data lines 13-1 through 13-m are driven by data written on the current drivers 15A-1 through 15A-m. At this time, the driving control signal de2 is then set to a deselection state, and the luminance data sin is written onto the second row of the current driver (the current drivers 15B-1 through 15B-m). The second row of the current drivers 15B-1 through 15B-m drive the data lines 13-1 through 13-m when a (k+2)-th scanning line 12-(k+2) is selected in the next scanning cycle.

[0099] In this way, by alternating the first and second rows of the data line drivers (the current drivers 15A-1 through 15A-m and 15B-1 through 15B-m) between a written state and a driving state each time the scanning lines 12-1 through 12-n are successively selected, the writing time to the data line driving circuit 15' and the driving time for the data lines 13-1 through 13-m are generally kept to within one scanning period. Accordingly, the writing to the data line driving circuit 15' and the driving of the data lines 13-1 through 13-m are reliably performed.

[0100] Note that, in the present embodiment, the current drivers 15A-1 through 15A-m and 15B-1 through 15B-m were explained based on an example of using the current-programmed-type current driver shown in FIG. 10, however, the present invention is not limited to this. The present invention can be applied to the current-programmed-type current drivers shown in FIG. 4, FIG. 6, and FIG. 7, it is possible to obtain the same operations and the same advantages. The circuit shown in FIG. 10, using a single signal line for inputting the writing control signal we1-wem, works with a reduced number of wires between the data line driving circuit 15 and the horizontal scanner 18, in comparison with the circuits shown in FIG. 4, FIG. 6, and FIG. 7 which needs two signal lines.

[0101] When it is difficult to complete the writing on the current drivers 15A-1 through 15A-m and 15B-1 through 15B-m within one scanning period in the active-matrix display device according to the present embodiment, a plurality of signal input lines 16 may be employed to perform parallel writing (a modification of the second embodiment).

[0102] Specifically as shown in FIG. 11, two signal input lines 16-1 and 16-2 are arranged, and the current drivers 15A-1 through 15A-m and 15B-1 through 15B-m are divided into two blocks as a left half and a right half. The signal input line 16-1 writes data onto the left half of the current drivers 15A-1 through 15A-m and 15B-1 through 15B-m and the signal input line 16-2 writes data onto the right half of the current drivers 15A-1 through 15A-m and 15B-1 through 15B-m.

[0103] In this arrangement, since the luminance data sin can be written onto the current drivers 15A-1 through 15A-m and 15B-1 through 15B-m on a two at a time basis (in parallel), and the writing time per data line driver is doubled, the writing operation is thus facilitated. It is also possible to arrange three or more signal input line 16.

[0104] It is also possible to implement the fast luminance data writing concept discussed with reference to FIG. 6 in the active-matrix display device in which the current drivers 15A-1 through 15A-m and 15B-1 through 15B-m are divided into the left-half block and the right-half block. In this case, the circuit shown in FIG. 4 is used as the current-programmed-type current driver.

[0105] Referring to FIG. 12, impedance transforming transistors such as P-channel TFTs 40-1 and 40-2 are respectively connected to inputs of the signal input lines 16-1 and 16-2. The TFTs 40-1 and 40-2 are biased with bias voltage Vbias higher than ground potential. Parasitic capacitances Cs1 and Cs2 are respectively associated with the signal input lines 16-1 and 16-2. By setting the bias voltage Vbias to an appropriate value, the P-channel TFTs 40-1 and 40-2 are operated in the saturation region thereof.

[0106] In this way, the current drivers 15A-1 through 15A-m and 15B-1 through 15B-m are divided into two blocks, and the impedance transforming transistors, that is, the P-channel TFTs 40-1 and 40-2, operating in the saturation region thereof during the writing of the luminance data are arranged commonly on a plurality of current drivers in the respective blocks. By setting the value of Wp/Lp of the TFTs 40-1 and 40-2 to be large, the writing of the luminance data is expedited without modifying the circuit arrangement and constants of the current drivers 15A-1 through 15A-m and 15B-1 through 15B-m by the same reason as that of the explanation of the circuit in FIG. 6.

[0107] A circuit arrangement shown in FIG. 13 may be implemented as another modification of the second embodiment. Further to the arranged shown in FIG. 11, the active-matrix display device shown in FIG. 13 divides the data lines 13-1 through 13-m at the center thereof into two, and data line driving circuits 15U and 15D are arranged above and below the display area.

[0108] In this case, horizontal scanners 18U and 18D are also arranged above and below the display area. Since the circuit arrangement shown in FIG. 11 is also partly employed, the upper data line driving circuit 15U is provided with two signal input line 16U-1 and 16U-2, and the lower data line driving circuit 15D is provided with two signal input lines 16D-1 and 16D-2.

[0109] In this arrangement, data lines 13U-1 through 13U-m and data lines 13D-1 through 13D-m respectively driven by the data line driving circuits 15U and 15D have wiring length as half as that in the circuit arrangement shown in FIG. 11. Capacitances of the data lines 13U-1 through 13U-m and the data lines 13D-1 through 13D-m are thus half those

of the circuit arrangement shown in FIG. 11. The driving time of the data line is accordingly short.

[0110] Since the selection and the writing are concurrently performed on two of the scanning lines 12-1 through 12-n, one in the top half and the other in the bottom half of the display screen, the writing time per scanning line is doubled. For this reason, the driving of the data lines 13U-1 through 13U-m and the data lines 13D-1 through 13D-m and the data writing to the data line driving circuits 15U and 15D can be reliably performed.

Fourth Circuit Example

[0111] FIG. 14 is a circuit diagram of another circuit example of the current driver. The current driver here may be employed as each of the current drivers 15-1 through 15-m in the data line driving circuit 15 of the first embodiment (see FIG. 1) or as each of the current drivers 15A-1 through 15A-m and 15B-1 through 15B-m in the data line driving circuit 15' in the second embodiment.

[0112] As seen from FIG. 14, the current driver according to the present example includes four TFTs 41-44 and a capacitor 45. In this current driver, the TFTs 41 and 42 are NMOS transistors and the TFTs 43 and 44 are PMOS transistors. The present invention is not limited to this arrangement.

[0113] The TFT 41 is configured with the source thereof grounded and with the drain thereof connected to a data line 13. A capacitor C is connected between the gate of the TFT 41 and ground. The gate of the TFT 41 is respectively connected to the gate of the TFT 42 and the drain of the TFT 44. The TFT 41 and the TFT 42 are arranged in a close vicinity with the gates thereof connected to each other, thereby forming a current mirror.

[0114] The source of the TFT 42 is grounded. The drain of the TFT 42, the drain of the TFT 43, and the source of the TFT 44 are connected together. The TFT 43 is configured with the source thereof connected to a signal input line 16, and with the gate thereof receiving a first writing control signal weA. The TFT 44 receives a second writing control signal weB at the gate thereof.

[0115] The circuit operation of the current driver thus constructed will now be discussed, referring to a driving waveform diagram shown in FIGS. 15A to 15C.

[0116] To write the data onto the current driver, both the first writing control signal weA and the second writing control signal weB are set to a selection state. Here, the selection state is that both signals are at a low level. At this state, by connecting the current source CS providing a writing current Iw to the signal input line 16, the writing current Iw flows through the TFT 42 from the TFT 43. At this time, since the gate and the drain of the TFT 42 are electrically shorted by the TFT 44, the equation (3) holds and the TFT 42 operates in the saturation region thereof. The voltage Vgs expressed by the equation (1) is generated between the gate and the source of the TFT 42.

[0117] Next, the first and second writing control signals weA and weB are set to a deselection state. More specifically, the second writing control signal weB is driven high, thereby turning off the TFT 44. The voltage Vg generated between the gate and the source of the TFT 42 is held in the capacitor 45.

[0118] Next, the first writing control signal weA is driven high, turning off the TFT 43. Since the current driver is electrically isolated from the current source CS, the current source CS thereafter is able to perform writing on another current driver. The data from the current source CS has to be effective at the moment the second writing control signal weB is in a deselection state. Thereafter, the data from the current source CS can be at any level (for example, write data to the next current driver).

[0119] The current mirror is formed of the TFT 41 and the TFT 42 with the gates thereof mutually connected. If the TFT 41 operates in the saturation region thereof, the current flowing through the TFT 41 is expressed by the equation (2). This becomes a current flowing through the data line 13, and is proportional to the writing current Iw.

[0120] Like the circuit shown in FIG. 4, the circuit shown in FIG. 14 converts the luminance data sin in the form of current into a voltage, and holds the voltage in the capacitor 45, and drives the data line 13 with a current substantially proportional to the written current based on the voltage held in the capacitor 45 even after writing. In this operation, the TFT 41 and the TFT 42 are substantially identical in carrier mobility and threshold value Vth because the two transistors are arranged in a close vicinity, and the absolute values of these are not important. In other words, the circuit shown in FIG. 14 drives the data line 13 with the current accurately equal to the written current regardless of variations in the TFT characteristics.

[0121] The relationship between the writing current Iw to the current driver and the driving current Id to the data line 13 is set to a desired value by properly setting the channel width W to the channel length L of each of the two transistors, in other words, by setting a mirror ratio of the current mirror.

[0122] If the ratios of W/L of the TFT 41 and the TFT 42 are set to be equal to each other, the writing current Iw equals the driving current Id. If the W/L ratio of the TFT 42 is set to be larger than that of the TFT 41, the writing current Iw becomes larger than the driving current Id. The latter setting is effective when an external current source CS has difficulty in driving the current driver because of its small current output, or when the writing of the current driver needs to be expedited.

[0123] FIG. 16 shows a modification of the current driver. The current driver shown according to the modification

example is different from the circuit shown in FIG. 14 only in the connection of the TFT 44. Specifically, the TFT 44 is connected between the gate of the TFT 41 and the gate of the TFT 42. The circuit operation of the modification remains unchanged from that of the circuit shown in FIG. 14.

5 Fifth Circuit Example

[0124] FIG. 17 is a circuit diagram showing yet another circuit example of the current driver. The current driver here may be employed as each of the current drivers 15-1 through 15-m in the data line driving circuit 15 of the first embodiment (see FIG. 1) or as each of the current drivers 15A-1 through 15A-m and 15B-1 through 15B-m in the data line driving circuit 15' in the second embodiment.

[0125] The current driver according to the present example is basically identical to the first circuit example of the current driver (see FIG. 4) in circuit arrangement, and the discussion that follows focuses on the difference therebetween. In FIG. 17, the same parts as those of FIG. 4 are indicated by the same symbols as those of FIG. 4.

[0126] Referring to FIG. 17, a TFT 46 is inserted between the drain of the TFT 41 and the data line 13. A TFT 47 is connected between the gate and the drain of the TFT 46. The TFT 47 receives a second writing control signal weB at the gate thereof. A capacitor 48 is connected between the gate of the TFT 46 and ground.

[0127] The circuit operation of the current driver thus constructed will now be discussed. Since the circuit operation of the fifth circuit example remains unchanged from that of the circuit shown in FIG. 4, the waveform diagram shown in FIGS. 5A to 5D are referred to.

[0128] To perform writing onto the current driver, the driving control signal de is set to a deselection state (at a low level) to prevent a current from flowing into the data line 13. The first writing control signal weA and the second writing control signal weB are then set to a selection state (at a high level). The writing current I_w flows through the TFT 41 and the TFT 46 from the TFT 42. At this time, since the gate and the source of the TFT 41 and the gate and the source of the TFT 46 are respectively shorted by the TFT 44 and the TFT 47, the two transistors thus operate in the saturation regions thereof.

[0129] Next, the second writing control signal weB is set to a deselection state. In response, the voltage V_{gs} generated between the gate and the source of the TFT 41 is held in the capacitor 45, and the voltage V_{gs} generated between the gate and the source of the TFT 46 is held in the capacitor 48. The first writing control signal weA is then set to a deselection state, thereby electrically isolating the current driver from the signal input line 16. Thereafter, the writing operation is performed on another current driver through the signal input line 16.

[0130] The data line driving control signal de is driven high. Since the gate-source voltage V_{gs} of the TFT 41 is held in the capacitor 45, the current flowing through the TFT 41 coincides with the writing current I_w expressed by the equation (5) if the TFT 41 operates in the saturation region thereof. This becomes the current I_d flowing through the data line 13. In other words, the writing current I_w agrees with the driving current I_d of the data line 13.

[0131] The operation of the TFT 46 will now be discussed. In the circuit shown in FIG. 4, as mentioned above, the writing current I_w and the driving current I_d of the data line 13 are determined by the TFT 41, and from the equations (5) and (6), the relationship of $I_w=I_{drv}$ holds. But this is based on the assumption that the current I_{ds} flowing through the TFT 41 is not dependent on the drain-source voltage V_{ds} in the saturation region.

[0132] In an actual transistor, there are times when the drain-source current I_{ds} is large as the drain-source voltage V_{ds} becomes large even if the gate-source voltage V_{gs} remains constant. This is due to the short-channel effect in which an effective channel length is shortened when a pinch-off point in the vicinity of the drain region shifts toward the source side as the drain-source voltage V_{ds} becomes larger, or due to the back gate effect in which the conductivity of the channel changes when the voltage of the drain affects the voltage of the channel.

[0133] In this case, the drain-source current I_{ds} flowing through a transistor depends on the drain-source voltage V_{ds} as expressed by the following equation (17).

$$I_{ds} = \mu C_{ox} W/L/2 (V_{gs} - V_{th})^2 \times (1 + \lambda V_{ds}) \quad (17)$$

50 where λ is a positive constant. In the circuit shown in FIG. 4, the writing current I_w does not coincide with the I_{drv} flowing through the OLED if the drain-source voltage V_{ds} is not equal during the writing and during driving operations.

[0134] Contrary to this, the circuit shown in FIG. 17 is now considered: To note in the operation of the TFT 46 of FIG. 17, the voltage of the drain thereof during writing and that during driving are not equal. For example, when the drain potential during driving is higher, the drain-source voltage V_{ds} of the TFT 46 also becomes higher. From the equation (17), the drain-source current I_{ds} increases during driving even if the gate-source voltage V_{gs} remains constant regardless of the writing and driving operations. In other words, the current I_{drv} flowing through the OLED is not equal to but becomes larger than the writing current I_w .

[0135] Since the current Id_{rv} flowing through the OLED also flows through the TFT 41, the voltage drop through the TFT 41 increases, thereby raising the drain potential thereof (i.e., the source potential of the TFT 46). As a result, the gate-source voltage V_{gs} of the TFT 46 becomes lower, working in the direction to reduce the current Id_{rv} flowing through the OLED. The drain potential of the TFT 46 is unable to greatly vary. To note the TFT 41, the drain-source current Id_s of the TFT 41 does not greatly vary between the writing operation and the driving operation. Consequently, the writing current I_w and the current Id_{rv} flowing through the OLED coincide with each other with a relatively high accuracy.

[0136] To allow the circuit to perform better the above-referenced operation, the drain-source current Id_s needs to be less dependent on the drain-source voltage V_{ds} in each of the TFT 41 and the TFT 46. To this end, the two transistors preferably operate in the saturation regions thereof. Since each of the TFT 41 and the TFT 46 is shorted between the gate and drain thereof during the writing operation, the two transistors are forced to operate in the saturation region thereof regardless of written luminance data. To allow the two transistors to operate in the saturation region thereof even during driving, the data line 13 needs to be at a sufficiently high potential. In this way, the current Id flowing through the data line 13 accurately coincides with the writing current I_w regardless of variations in the TFT characteristics.

15 Third Embodiment

[0137] FIG. 18 is a block diagram showing an example of the configuration of an active-matrix display device according to a third embodiment of the present invention. In the figure, the same parts as those of FIG. 1 are indicated by the same symbols as those of FIG. 1. The active-matrix display device according to the present embodiment is different from that of the first embodiment in the construction of the data line driving circuit for driving the data lines.

[0138] More specifically, the first embodiment employs a current-programmed-type current driver for the data line driving circuit 15, while the present embodiment employs voltage-programmed-type current drivers (CD) 19-1 through 19-m as a data line driving circuit 19. The output terminals of the voltage-programmed-type current drivers (hereinafter simply referred to as current drivers) 19-1 through 19-m are respectively connected to ends of the data lines 13-1 through 13-m.

Sixth Circuit Example

[0139] FIG. 19 is a circuit diagram showing a concrete circuit example of the voltage-programmed-type current drivers 19-1 through 19-m forming the data line driving circuit 19. The current drivers 19-1 through 19-m are identical to each other in circuit arrangement.

[0140] As seen from FIG. 19, the current driver according to the present example includes two TFTs 51 and 52, and a single capacitor 53. The TFT 51 is connected between a data line 13 and ground. The TFT 52 is connected between the gate of the TFT 51 and a signal input line 16. The capacitor 53 is connected between the gate of the TFT 51 and ground. In this circuit example, the TFTs 51 and 52 are NMOS type, however, the circuit is discussed for exemplary purposes only, and the present invention is not limited to this arrangement.

[0141] The feature of the current driver thus constructed lies in that a voltage source VS feeds luminance data sin through a signal input line 16 in the form of voltage. When a voltage V_w is applied to the signal input line 16 with a writing control signal we set to a selection state (at a high level) during writing the luminance data sin, the TFT 52 is turned on, causing the gate-source voltage V_{gs} of the TFT 51 to be the writing voltage V_w .

[0142] The writing voltage V_w is held in the capacitor 53 even when the writing control signal we shifts to a deselection state. With the TFT 51 operating in the saturation state thereof, the current Id flowing through the TFT 51 is expressed as follows:

$$Id = \mu Cox W/L/2 (V_w - V_{th})^2 \quad (18)$$

[0143] The driving current Id of the data line 13 is controlled by the writing voltage V_w .

[0144] FIGS. 20A to 20G illustrate a timing diagram of the operation of the active-matrix display device shown in FIG. 18 with the data line driving circuit 19 formed of the current driver thus constructed. The operation of the active-matrix display device remains unchanged from that of the circuit shown in FIG. 1, and the discussion thereof is thus skipped.

55 Seventh Circuit Example

[0145] FIG. 21 is a circuit diagram showing a concrete circuit example of the voltage-programmed-type current driver.

In the figure, the same parts as those of FIG. 19 are indicated by the same symbols as those of FIG. 19. The current driver according to the present example is identical to the voltage-programmed-type current driver shown in FIG. 19 except that a TFT 54 to be controlled by a driving control signal de is added. The TFT 54 is connected between the data line 13 and the drain of a TFT 51 and receives the driving control signal de at the gate thereof. In this circuit example, the TFTs 51, 52 and 53 are NMOS type, however, this circuit is discussed for exemplary purposes only, and the present invention is not limited to this arrangement.

[0146] In this way, each of the active-matrix display devices shown in FIG. 1, FIG. 8, FIG. 11, and FIG. 12 can be produced using the current driver that includes the TFT 54, connected between the data line 13 and the drain of the TFT 51, to be controlled by the driving control signal de. In case of the active-matrix display devices shown in FIG. 8, FIG. 11, and FIG. 12, the two rows of data line drivers are employed, and the writing of the data line drivers and the driving of the data lines 13-1 through 13-m are performed alternately. This arrangement permits a substantial time margin in operation times.

Eighth Circuit Example.

[0147] FIG. 22 is a circuit diagram showing another circuit example of the voltage-programmed-type current driver. In the figure, the same parts as those of FIG. 21 are indicated by the same symbols as those of FIG. 21. The current driver according to the present example includes, in addition to the circuit shown in FIG. 21, a reset TFT 57 connected between the gate and the drain of the TFT 51, and a data writing capacitor 58 connected between the gate of the TFT 51 and the source of the TFT 52.

[0148] In the circuit shown in FIG. 22, luminance data is given in the form of voltage and is held in the capacitor 53 as is. In response to the held voltage, the TFT 51 allows a current to flow through the data line. In the configuration, when the threshold value of the TFT 51 varies, the driving current varies in accordance with the equation (1), thereby degrading the quality of image on the screen.

[0149] In the voltage-programmed-type current driver according to the present circuit example, in contrast, the TFT 57 electrically shorts the gate and the drain of the TFT 51 for a predetermined duration of time, and the gate of the TFT 51 is then capacitively coupled to the signal input line 16 through the data writing capacitor 58. Even when the threshold value of the TFT 51 varies, the driving current is free from variations, and the image is not degraded. The operation of the current driver will be discussed referring to a timing diagram shown in FIGS. 23A to 23D.

[0150] When the TFT 54 is on, the TFT 57 is turned on in response to a high-level reset signal rst coming to the gate thereof. The gate and the drain of the TFT 51 are shorted. At this time, since the TFT 54 is on with a current flowing through the TFT 54 and the TFT 51 from the data line to the ground, the gate-source voltage Vgs of the TFT 51 becomes higher than the threshold value Vth of the TFT 51.

[0151] The driving control signal de given to the gate of the TFT 54 is driven low, thereby turning off the TFT 54. The current flowing through the TFT 51 becomes zero after a predetermined duration of time. Since the gate and the drain of the TFT 51 are shorted by the TFT 57, the potential of the drain and the gate of the TFT 51 is gradually lowered, and reaches a steady state at the threshold value Vth of the TFT 51. Since a high-level writing control signal we is applied to the gate of the TFT 52, the signal input line 16 is kept to a predetermined potential (a ground level here) (hereinafter this state is referred to as a reset operation). The writing voltage Vw is applied to the signal input line 16.

[0152] The gate of the TFT 51 is capacitively coupled to the signal input line 16 through the data writing capacitor 58. Let Co and Cd represent the capacitances of the capacitors 53 and 58, and the gate potential voltage of the TFT 51 rises by ΔVg as follows:

$$\Delta Vg = Vw \times Cd / (Cd + Co) \quad (19)$$

[0153] Since $Vg = Vth$ prior to the application of the signal voltage Vw, the gate-source voltage Vgs of the TFT 51 is

$$Vgs = Vth + \Delta Vg$$

$$= Vth + Vw \times Cd / (Cd + Co) \quad (20)$$

[0154] (Hereinafter, this operation is referred to as a written operation.)

[0155] The TFT 52 is turned off subsequent to the application of the signal voltage Vw. The TFT 54 is turned on in response to the driving control signal de coming to the gate thereof. The TFT 51 allows a current to flow through the data line. From the equations (1) and (20), that current Id is

$$Id = \mu \cdot Cox \cdot W/L/2 \cdot \{Vw \times Cd/(Cd+Vo)\}^2 \quad (21)$$

5 (Hereinafter, this operation is referred to as a driving operation.) Since the equation (21) does not contain the threshold value V_{th} , the driving current Id is clearly free from variations in the threshold value V_{th} of the TFT 51.

10 [0155] FIG. 24 is a circuit diagram showing a modification of the eighth circuit example of the current driver. In the figure, the same parts as those of FIG. 22 are indicated by the same symbols as those of FIG. 22. The modification of the eighth circuit example includes the capacitor 53 connected between the input terminal of the data writing capacitor 58 and ground, in contrast to the eighth circuit example in which the capacitor 53 is connected between the output terminal of the data writing capacitor 58 and ground. The rest of the construction and the operation timing diagram remain unchanged.

15 [0156] As the capacitor 53 is connected between the input terminal of the data writing capacitor 58 and ground in this way, the gate-source voltage V_{gs} of the TFT 51 subsequent to the application of the signal voltage Vw becomes approximately $V_{th}+Vw$. In other words, given the same signal voltage Vw , a larger gate-source voltage V_{gs} results in comparison with the current driver according to the eighth circuit example.

20 [0157] FIG. 25 is a circuit diagram showing yet another modification of the eighth circuit example. In the figure, the same parts as those of FIG. 24 are indicated by the same symbols as those of FIG. 24. The current driver according to the modification of the circuit example is different from the current driver shown in FIG. 24 in that a switching element, such as a TFT 59, is newly connected between the node of the data writing capacitor 58 with the signal input line and a point at a predetermined potential (a ground level here), and in the reset operation thereof.

25 [0158] The operation of the current driver according to the modification of the circuit example will now be discussed with reference to a timing diagram shown in FIGS. 26A to 26D. As the same way as in the circuit example of FIG. 24, upon receiving a high-level reset signal rst at the gate during the reset operation, the TFT 57 is turned on. The gate and the drain of the TFT 51 are thus electrically shorted to each other.

30 [0159] When the TFT 54 is turned off in response to the transition of the driving control signal de to a low level at the gate thereof, the gate and the drain of the TFT 51 becomes stabilized at the threshold value V_{th} thereof as the same way as in the circuit example of FIG. 24. The writing control signal we given to the gate of the TFT 52 remains at a low level, and the newly added TFT 59 is turned on in response to the reset signal rst . The potential of the drain of the TFT 59 is driven to a predetermined potential (a ground level in present example).

35 [0160] When the reset signal rst is driven low, the TFT 59 is turned off, and the writing control signal we is then driven high. The signal voltage Vw , applied to the signal input line 16, is transferred to the gate of the TFT 51 through the data writing capacitor 58. The gate-source voltage V_{gs} of the TFT 51 becomes approximately $V_{th}+Vw$ as in the circuit shown in FIG. 24.

40 [0161] The current driver shown in FIG. 25 operates in substantially the same way as that shown in FIG. 24. The advantage of the current driver shown in FIG. 25 lies in that control of the voltage of the signal input line 16 is easy and that the writing speed becomes fast. Specifically, in the circuit shown in FIG. 24, the potential of the signal input line 16 needs to be controlled in the arrangement in which the capacitor 53 is reset to a reference potential (a ground level in the present example) through the signal input line 16 and the TFT 52 in the reset operation.

45 [0162] In contrast, the circuit shown in FIG. 25 does not need to provide a reference potential to the signal input line 16, because the TFT 59 easily resets the capacitor 53. The control of the signal input line 16 is thus facilitated. Referring to FIGS. 26A to 26D, the signal input line 16 may be set to any potential, for example, to a signal voltage for the next write cycle, subsequent to the writing of the signal voltage Vw to the current driver. The writing of the signal voltage Vw is thus quickly performed.

45 Fourth Embodiment

50 [0163] FIG. 27 is a block diagram showing an example of the configuration of an active-matrix display device according to a fourth embodiment of the present invention. In the figure, the same parts as those of FIG. 18 are indicated by the same symbols as those of FIG. 18. The active-matrix display device according to the present embodiment is different from the active-matrix display device of the third embodiment in the construction of the data line driving circuit 19.

55 [0164] The active-matrix display device according to the third embodiment includes the single row of voltage-programmed-type current drivers (CDs) 19-1 through 19-m in the data line driving circuit 19. In contrast, the active-matrix display device according to the present embodiment includes three rows of voltage-programmed-type current drivers 19A-1 through 19A-m, 19B-1 through 19B-m, and 19C-1 through 19C-m in the data line driving circuit 19.

55 [0165] Employed as each of the three rows of voltage-programmed-type current drivers 19A-1 through 19A-m, 19B-1 through 19B-m, and 19C-1 through 19C-m is the eighth circuit example of the voltage-programmed-type current

driver. The feature of the eighth circuit example is that the gate of the TFT 51 is capacitively coupled to the signal input line 16 subsequent to the electrically shorting action of the gate and the drain of the TFT 51 so that the driving current remains stabilized even with the threshold value of the TFT 51 varied.

[0166] The reason why the three rows of voltage-programmed-type current drivers are used for each data line is as follows. The current driver according to the eighth circuit example performs a required function by repeating a reset operation, a written operation, and a driving operation. The active-matrix display device according to the present embodiment thus switches the three operations every scanning line switching period so that a first row of the data line during circuits perform the reset operation, a second row performs the written operation, and a third row performs the driving operation as shown in FIGS. 28A to 28C.

[0167] In this way, the active-matrix display device repeats the three types of operations of resetting, being written, and driving through the voltage-programmed-type current drivers. The three rows of voltage-programmed-type current drivers are arranged for every data line. In a given scanning cycle, the first row of current drivers perform the reset operation, the second row of current drivers performs the written operation, and the third row of current drivers performs the driving operation. The active-matrix display device thus uses one scanning line switching period (1H) for each operation, thereby reliably performing each operation.

Fifth Embodiment

[0168] FIG. 29 is a block diagram showing an example of the configuration of an active-matrix display device according to a fifth embodiment of the present invention. In the figure, the same parts as those of FIG. 1 are indicated by the same symbols as those of FIG. 1. The active-matrix display device according to the present embodiment is substantially identical to that of the first embodiment. The difference therebetween is that the active-matrix display device of the fifth embodiment is provided with a leakage (LK) element 55 of a NMOS transistor connected between a signal input line 16 and ground.

[0169] The operation of the leakage element 55 will now be discussed. The writing of a "black" level corresponds to zero current in a current-programmed-type pixel circuit. If a "white" level, i.e., a relatively large current has been written onto the signal input line 16 in an immediately preceding writing cycle, the potential of the signal input line 16 may be left to be at a relatively high level. It takes time for write a "black" level immediately subsequent to the white level.

[0170] The writing of the "black" level in the current driver shown in FIG. 4, for example, means that an initial charge stored in the capacitor Cs of the signal input line 16 is discharged through the TFT 31 with the voltage of the signal input line 16 becoming the threshold value of the TFT 31 as shown in FIG. 30. When the voltage of the signal input line 16 drops close to the threshold value of the TFT 31, impedance of the TFT 32 rises, and the writing of the "black" level theoretically never ends. In practice, however, the writing is performed within a finite time, and the black level ends not sinking down to the intended level thereof. This too-high brightness phenomenon degrades contrast of the display.

[0171] In contrast, the active-matrix display device according to the present embodiment includes the leakage element 55, namely, the NMOS transistor, between the signal input line 16 and a point at a predetermined potential (a ground potential, for example). The leakage element 55 is supplied with a constant bias as the gate voltage Vg thereof at the gate thereof. Referring to FIG. 30, the data line voltage drops at a relatively fast speed even in the vicinity of the threshold value of the TFT 31 during the writing of the black level, thereby avoiding the too-high brightness phenomenon.

[0172] The leakage element 55 may be a simple resistor. However, the data line potential rises during the writing of the "white" level, a current flowing through the resistor increases accordingly. This leads to a drop in current flowing through the TFT 31 or an increase in power consumption in the current driver shown in FIG. 4.

[0173] If the NMOS transistor as the leakage element 55 is set to operate in the saturation region thereof, the transistor works on a constant-current mode, and these disadvantages will be minimized. In another circuit arrangement, the gate potential may be controlled so that the NMOS transistor as the leakage element 55 may be turned on as necessary (during the writing of the black level, for example).

[0174] The circuit arrangement in which the leakage element 55 is connected between the signal input line 16 and ground is not limited to the active-matrix display device of FIG. 1 in which the current-programmed-type current driver shown in FIG. 4 is employed. This circuit arrangement may be applied to another current-programmed-type current driver or the active-matrix display device shown in FIG. 19 incorporating the voltage-programmed-type current driver. The leakage element 55 may be formed of a TFT or an external component manufactured in a process different from a TFT manufacturing process.

Sixth Embodiment

[0175] FIG. 31 is a block diagram showing an example of the configuration of an active-matrix display device ac-

5 cording to a sixth embodiment of the present invention. In the figure, the same parts as those of FIG. 1 are indicated by the same symbols as those of FIG. 1. The active-matrix display device according to the present embodiment is basically identical in construction to that of the first embodiment. The active-matrix display device of the present embodiment includes, in addition to the construction of the first embodiment, a precharge element (PC) 56 of a PMOS transistor, as an initial value setting element, between the signal input line 16 and a positive power source Vdd.

10 [0176] The operation of the precharge element 56 will now be discussed. There are times when it takes a long time to write a blackish gray level in a current-programmed-type pixel circuit. Referring to FIG. 32, the potential of the data line is zero at the start of the writing. This can occur when the "black" level has been written in the immediately preceding cycle, and the threshold value of the TFT 31 in the current driver (in FIG. 4, for example) is as low as zero volt or the black level is also now written, and the leakage element 55 for controlling the too-high brightness phenomenon is incorporated.

15 [0177] It takes time to reach a balanced voltage because a blackish gray, i.e., an extremely small current, starting with an initial value of zero, is written. It is considered that the voltage of the data line fails to reach the threshold value of the TFT 31 within a predetermined time. In this case, the TFT 31 is turned off at the driving of the data line 13, thereby causing a too-low brightness phenomenon in the display.

20 [0178] In the active-matrix display device according to the present embodiment, the PMOS transistor as the pre-charge element 56 is connected between the data line 13 and the power source potential Vdd. The precharge element 56 is supplied with a pulse as the gate voltage Vg at the start of a writing cycle. In response to the pulse, the voltage of the signal input line 16 rises above the threshold value of the TFT 31, and relatively fast reaches a balanced potential determined between the balance between the writing current Iw and the operation of the TFT in the data line driving circuit. Accurate luminance data writing is quickly performed.

25 [0179] The circuit arrangement in which the precharge element 56 is connected between the signal input line 16 and the positive power supply source Vdd is not limited to the active-matrix display device shown in FIG. 1 including the current-programmed-type current driver shown in FIG. 4. This circuit arrangement may be applied to an active-matrix display device incorporating another current-programmed-type current driver. The leakage element 55 may be formed of a TFT or an external component manufactured in a process different from a TFT manufacturing process.

30 [0180] The above-referenced embodiments have been discussed in connection with the active-matrix organic EL devices employing the organic EL element as a display element in the current-programmed-type pixel circuit 11. The present invention is not limited to this arrangement. The present invention is generally applied to active-matrix display devices which uses, as a display element, an electrooptical element that changes the luminance level thereof in response to a current flowing therethrough.

35 [0181] In each of the above-referenced circuit examples in each of the above embodiments, a first field-effect transistor as a converting unit for converting the writing current into a voltage and a second field-effect transistor as a driving unit for converting the voltage held in the capacitor (a holding unit) into a driving current to drive the data line are formed of different transistors. Alternatively, the same transistor may be used as the first and second field-effect transistors so that the current-to-voltage converting operation and the driving operation of the data line may be performed in a time sharing manner. With this arrangement, theoretically, no variations take place from operation to operation.

40 INDUSTRIAL APPLICABILITY

45 [0182] In accordance with the present invention, the active-matrix display device using the current-programmed-type pixel circuit holds the image information in the form of voltage, then converts the voltage into a current, and then drives the plurality of data lines (at a time). In this way, the image information is written on the pixel circuits. Since the image information is written on the pixel circuits on a line-by-line basis, the number of the connection points between the display panel and the data line driving circuit external to the display panel is reduced, and a current writing operation is reliably performed.

50 Claims

1. An active-matrix display device comprising:

55 a display section including a matrix of pixel circuits to which image information is given in the form of current, a plurality of scanning lines for selecting each pixel circuit, and a plurality of data lines for supplying each pixel circuit with the image information; and a driving circuit which holds the image information, and then writes the image information onto each pixel circuit by feeding the image information in the form of current to each of the plurality of data lines.

2. An active-matrix display device according to claim 1, wherein each pixel circuit comprises an electrooptical element that changes the luminance level thereof in response to a current flowing therethrough, and
 5 wherein the driving circuit writes the image information by causing a current, having a magnitude corresponding to the level of luminance, to flow through the pixel circuit via the plurality of data lines.

3. An active-matrix display device according to claim 1, wherein the driving circuit, arranged for every plural number of data lines, comprises a holding unit for holding the image information in the form of voltage, and a driving unit for supplying the image information in the form of current to each of the plurality of data lines after converting the voltage stored in the holding unit into the current.
 10

4. An active-matrix display device according to claim 3, wherein the driving circuit comprises a converting unit which converts the image information supplied in the form of current into a voltage, and which holds the voltage converted by the converting unit in the holding unit.
 15

5. An active-matrix display device according to claim 4, wherein the converting unit comprises a first field-effect transistor which generates a voltage between the gate and the source thereof by supplying the image information in the form of current when the drain and the gate thereof are electrically shorted,
 20 wherein the holding unit comprises a capacitor which holds the voltage generated between the gate and the source of the first field-effect transistor, and
 wherein the driving unit comprises a second field-effect transistor which drives each of the plurality of data lines based on the voltage held in the capacitor.
 25

6. An active-matrix display device comprising:
 a display section including a matrix of pixel circuits to which image information given in the form of current, a plurality of scanning lines for selecting each pixel circuit, and a plurality of data lines for supplying each pixel circuit with the image information; and
 a driving circuit which holds the image information, and then writes the image information onto each pixel circuit by feeding the image information in the form of current to each of the plurality of data lines,
 30

35 wherein the driving circuit comprises a converting unit which converts the image information supplied in the form of current into a voltage, a holding unit which holds the voltage converted by the converting unit, and a driving unit for supplying the image information in the form of current to each of the plurality of data lines after converting the voltage stored in the holding unit into the current, and
 wherein the active-matrix display device comprises an impedance transforming transistor which is arranged between the converting unit and a current source for supplying the driving circuit with the image information, and which operates in a saturation region thereof when the image information is written.
 40

7. An active-matrix display device according to claim 6, wherein the converting unit comprises a first field-effect transistor which generates a voltage between the gate and the source thereof by supplying the image information in the form of current when the drain and the gate thereof are electrically shorted,
 45 wherein the holding unit comprises a capacitor which holds the voltage generated between the gate and the source of the first field-effect transistor, and
 wherein the driving unit comprises a second field-effect transistor which drives each of the plurality of data lines based on the voltage held in the capacitor, and
 wherein the active-matrix display device comprises an impedance transforming transistor which is arranged between the first field-effect transistor and a current source for supplying the driving circuit with the image information, and which operates in a saturation region thereof when the image information is written.
 50

8. An active-matrix display device according to claim 7, wherein the impedance transforming transistor is a transistor that is of a conductive type different from that of the first field-effect transistor and is arranged on a per driving circuit basis.
 55

9. An active-matrix display device according to claim 7, wherein the driving circuits, arranged for every plural number of data lines, are organized in blocks, and
 wherein the impedance transforming transistor is thus shared by a plurality of driving circuits within each block.

10. An active-matrix display device according to claim 5, wherein the driving circuit uses a single transistor which serves as the first and second field-effect transistors, thus performing a current-voltage conversion by the first field-effect transistor and the driving of the data line by the second field-effect transistor based on the current-voltage conversion, in a time sharing manner.

5

11. An active-matrix display device according to claim 5, wherein the driving circuit comprises a first switching element which connects and cuts a connection between a signal input line for receiving the image information and the first field-effect transistor, and a second switching element which connects and cuts a connection between the drain and the gate of the first field-effect transistor, and

10 wherein when the image information is input, the first and second switching elements connect the respective connections thereof, and when the inputting of the image information ends, the second switching element cuts the connection thereof, followed by a connection cutting by the first switching element.

12. An active-matrix display device according to claim 5, wherein the driving circuit employs transistors having substantially identical characteristics as the first and second field-effect transistors, and

15 wherein the first and second field-effect transistors form a current mirror.

13. An active-matrix display device according to claim 12, wherein the driving circuit comprises a first switching element which connects and cuts a connection between a signal input line for receiving the image information and the first field-effect transistor, and a second switching element which connects and cuts a connection between the gate of the first field-effect transistor and the gate of the second field-effect transistor, and

20 wherein when the image information is input, the first and second switching elements connect the respective connections thereof, and when the inputting of the image information ends, the second switching element cuts the connection thereof, followed by a connection cutting by the first switching element.

25

14. An active-matrix display device according to claim 13, wherein the channel width and the channel length of the first field effect-transistor are respectively wider and longer than the channel width and the channel length of the second field-effect transistor.

30

15. An active-matrix display device according to claim 11, wherein the driving circuit comprises a third field-effect transistor connected between the first switching element and the first field-effect transistor, a third switching element which connects and cuts a connection between the drain and the gate of the third field-effect transistor, and a second capacitor connected to the gate of the third field-effect transistor, and

35 wherein when the drain and the gate of the first field-effect transistor are connected to each other by the second switch, and when the drain and the gate of the third field-effect transistor are connected to each other by the third switching element, the image information is fed in the form of current between the drain and the source of each of the first field-effect transistor and the third field-effect transistor via the first switching element.

40

16. An active-matrix display device according to claim 3, wherein the plurality of driving circuits, each arranged for every plural number of data lines, shares a single signal input line, and uses the signal input line on a time sharing manner to receive the image information.

45

17. An active-matrix display device according to claim 3, wherein the driving circuit comprises a holding unit for holding, in the form of voltage, the image information supplied in the form of voltage.

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18. An active-matrix display device according to claim 17, wherein the holding unit comprises a capacitor for holding the voltage responsive to the image information,

wherein the driving circuit comprises a field-effect transistor for driving each of the plurality of data lines based on the voltage held in the capacitor, and

wherein the field-effect transistor is supplied with the image information with the gate thereof capacitively coupled to the signal input line through a writing capacitor subsequent to an electrically shorting of the connection between the gate and the drain thereof.

55

19. An active-matrix display device according to claim 18, wherein the driving circuit comprises a switching element connected between a node of the writing capacitor with the signal input line and a point at a predetermined potential, and

wherein the node of the writing capacitor with the signal input line becomes the predetermined potential with the switching element electrically shorted while the gate and the drain of the field-effect transistor are electrically

connected to each other.

20. An active-matrix display device according to claim 3, wherein a plurality of rows of driving circuits shares each data line.

5 21. An active-matrix display device according to claim 20, wherein the driving circuits comprise two rows of driving circuits sharing each data line, and
wherein one row of driving circuits drives the data line while the other row of driving circuits receives the image information.

10 22. An active-matrix display device according to claim 20, wherein the driving circuits comprise three rows of driving circuits sharing each line, and

wherein, in a given scanning cycle, a first row of driving circuits performs a reset operation, a second row of driving circuits performs a data written operation, and a third row of driving circuits performs a data line driving operation.

15 23. An active-matrix display device according to claim 1, wherein the transistor forming the driving circuit is a thin-film transistor that is manufactured at the same time when the transistor forming the pixel circuit is manufactured.

20 24. An active-matrix display device according to claim 1, further comprising a leakage element connected between a signal input line for receiving the image information and a point at a predetermined potential.

25 25. An active-matrix display device according to claim 1, comprising an initial value setting element, connected between a signal input line for receiving the image information and a point at a predetermined potential, for setting the potential of the signal input line to the predetermined value prior to the supplying of the image information to the driving circuit through the signal input line.

26. An active-matrix display device comprising:

30 a display section including a matrix of pixel circuits, a plurality of scanning lines for selecting each pixel circuit, and a plurality of data lines for supplying each pixel circuit with image information; and
a driving circuit which performs a writing operation for writing the image information on each pixel circuit through the plurality of data lines,

35 wherein the pixel circuit includes an electrooptical element which changes the luminance level thereof in response to a current flowing therethrough, a first field-effect transistor which is configured with one of the source or the drain thereof connected to the data line and with the gate thereof connected to the scanning line, a second field-effect transistor which generates a voltage between the gate and the source thereof with the drain and the gate thereof connected to each other when a current is fed through the data line via the first field-effect transistor, a capacitor which holds the voltage generated by the second field-effect transistor, a third field-effect transistor which holds a voltage held state of the capacitor, and a fourth field-effect transistor which converts the voltage held in the capacitor into a driving current and allows the driving current to flow into the electrooptical element, and

40 wherein the driving circuit includes a fifth field-effect transistor which generates a voltage between the gate and the source thereof with the drain and the gate thereof electrically connected to each other when the image information is fed in the form of current, a capacitor which holds the voltage generated between the gate and the source of the fifth field-effect transistor, and a sixth field-effect transistor which converts the voltage held in the capacitor into a current and feeds the current to each of the plurality of data lines.

45 27. An active-matrix display device according to claim 26, comprising an impedance transforming transistor which is arranged between the first field-effect transistor in the driving circuit and a current source for supplying the driving circuit with the image information, and which operates in a saturation region thereof when the image information is written.

50 28. An active-matrix display device according to claim 27, wherein the impedance transforming transistor is a transistor that is of a conductive type different from that of the first field-effect transistor.

55 29. An active-matrix display device according to claim 27, wherein the impedance transforming transistors are arranged for a per driving circuit basis.

30. An active-matrix display device according to claim 27, wherein the driving circuits, arranged for every plural number of data lines, are organized in blocks, and
 wherein the impedance transforming transistor is thus shared by a plurality of driving circuits within each block.

5 31. An active-matrix display device according to claim 26, wherein the driving circuit uses a single transistor which serves as the first and second field-effect transistors, thus performing a current-voltage conversion by the first field-effect transistor and the driving of the data line by the second field-effect transistor based on the current-voltage conversion, in a time sharing manner.

10 32. An active-matrix display device according to claim 26, wherein the driving circuit comprises a first switching element which connects and cuts a connection between a signal input line for receiving the image information and the first field-effect transistor, and a second switching element which connects and cuts a connection between the drain and the gate of the first field-effect transistor, and
 15 wherein when the image information is input, the first and second switching elements connect the respective connections thereof, and when the inputting of the image information ends, the second switching element cuts the connection thereof, followed by a connection cutting by the first switching element.

20 33. An active-matrix display device according to claim 26, wherein the driving circuit employs transistors having substantially identical characteristics as the first and second field-effect transistors, and
 wherein the first and second field-effect transistors form a current mirror.

25 34. An active-matrix display device according to claim 33, wherein the driving circuit comprises a first switching element which connects and cuts a connection between a signal input line for receiving the image information and the first field-effect transistor, and a second switching element which connects and cuts a connection between the gate of the first field-effect transistor and the gate of the second field-effect transistor, and
 30 wherein when the image information is input, the first and second switching elements connect the respective connections thereof, and when the inputting of the image information ends, the second switching element cuts the connection thereof, followed by a connection cutting by the first switching element.

35 35. An active-matrix display device according to claim 34, wherein in the driving circuit, the channel width and the channel length of the first field effect-transistor are respectively wider and longer than the channel width and the channel length of the second field-effect transistor.

40 36. An active-matrix display device according to claim 32, wherein the driving circuit comprises a third field-effect transistor connected between the first switching element and the first field-effect transistor, a third switching element which connects and cuts a connection between the drain and the gate of the third field-effect transistor, and a second capacitor connected to the gate of the third field-effect transistor, and
 wherein when the drain and the gate of the first field-effect transistor are connected to each other by the second switch, and when the drain and the gate of the third field-effect transistor are connected to each other by the third switching element, the image information is fed in the form of current between the drain and the source of each of the first field-effect transistor and the third field-effect transistor via the first switching element.

45 37. An active-matrix organic electroluminescent display device comprising:
 a display section including a matrix of pixel circuits to which image information is given in the form of current, each pixel circuit employing as a display element an organic electroluminescent element including a first electrode, a second electrode, and an organic layer laminate including a light emission layer between the first and second electrodes, a plurality of scanning lines for selecting each pixel circuit, and a plurality of data lines for supplying each pixel circuit with luminance information; and
 50 a driving circuit which holds image information, and then writes the image information onto each of the plurality of pixel circuits by feeding the image information in the form of current to each of the plurality of data lines.

55 38. An active-matrix organic electroluminescent display device according to claim 37, wherein the driving circuit, arranged for every plural number of data lines, comprises a holding unit for holding the image information in the form of voltage, and a driving unit for supplying the image information in the form of current to each of the plurality of data lines after converting the voltage stored in the holding unit into the current.

39. An active-matrix organic electroluminescent display device according to claim 38, wherein the driving circuit comprises a converting unit which converts the image information supplied in the form of current into a voltage, and which holds the voltage converted by the converting unit in the holding unit.

5 40. An active-matrix organic electroluminescent display device according to claim 39, wherein the converting unit comprises a first field-effect transistor which generates a voltage between the gate and the source thereof in response to the image information supplied in the form of current when the drain and the gate thereof are electrically shorted,
 10 wherein the holding unit comprises a capacitor which holds the voltage generated between the gate and the source of the first field-effect transistor, and
 wherein the driving unit comprises a second field-effect transistor which drives each of the plurality of data lines based on the voltage held in the capacitor.

41. An active-matrix organic electroluminescent display device comprising:

15 a display section including a matrix of pixel circuits to which image information is given in the form of current, each pixel circuit employing as a display element an organic electroluminescent element including a first electrode, a second electrode, and an organic layer laminate including a light emission layer between the first and second electrodes, a plurality of scanning lines for selecting each pixel circuit, and a plurality of data lines for supplying each pixel circuit with luminance information; and
 20 a driving circuit which holds image information, and then writes the image information onto each of the plurality of pixel circuits by feeding the image information in the form of current to each of the plurality of data lines,

25 wherein the driving circuit comprises a converting unit which converts the image information supplied in the form of current into a voltage, a holding unit which holds the voltage converted by the converting unit, and a driving unit for supplying the image information in the form of current to each of the plurality of data lines after converting the voltage stored in the holding unit into the current, and

30 wherein the active-matrix display device comprises an impedance transforming transistor which is arranged between the converting unit and a current source for supplying the driving circuit with the image information, and which operates in a saturation region thereof when the image information is written.

42. An active-matrix organic electroluminescent display device according to claim 41, wherein the converting unit comprises a first field-effect transistor which generates a voltage between the gate and the source thereof in response to the image information supplied in the form of current when the drain and the gate thereof are electrically shorted,

35 wherein the holding unit comprises a capacitor which holds the voltage generated between the gate and the source of the first field-effect transistor,

40 wherein the driving unit comprises a second field-effect transistor which drives each of the plurality of data lines based on the voltage held in the capacitor, and

45 wherein the active-matrix display device comprises an impedance transforming transistor which is arranged between the first field-effect transistor and a current source for supplying the driving circuit with the image information, and which operates in a saturation region thereof when the image information is written.

43. An active-matrix organic electroluminescent display device according to claim 42, wherein the impedance transforming transistor is a transistor that is of a conductive type different from that of the first field-effect transistor and is arranged on a per driving circuit basis.

44. An active-matrix organic electroluminescent display device according to claim 42, wherein the driving circuits, arranged for every plural number of data lines, are organized in blocks, and

50 wherein the impedance transforming transistor is thus shared by a plurality of driving circuits within each block.

45. An active-matrix organic electroluminescent display device according to claim 40, wherein the driving circuit uses a single transistor which serves as the first and second field-effect transistors, thus performing a current-voltage conversion by the first field-effect transistor and the driving of the data line by the second field-effect transistor in response to the current-voltage conversion, in a time sharing manner.

46. An active-matrix organic electroluminescent display device according to claim 40, wherein the driving circuit com-

prises a first switching element which connects and cuts a connection between a signal input line for receiving the image information and the first field-effect transistor, and a second switching element which connects and cuts a connection between the drain and the gate of the first field-effect transistor, and

5 wherein when the image information is input, the first and second switching elements connect the respective connections thereof, and when the inputting of the image information ends, the second switching element cuts the connection thereof, followed by a connection cutting by the first switching element.

47. An active-matrix organic electroluminescent display device according to claim 40, wherein the driving circuit employs transistors having substantially identical characteristics as the first and second field-effect transistors, and
10 wherein the first and second field-effect transistors form a current mirror.

48. An active-matrix organic electroluminescent display device according to claim 47, wherein the driving circuit comprises a first switching element which connects and cuts a connection between a signal input line for receiving the image information and the first field-effect transistor, and a second switching element which connects and cuts a connection between the gate of the first field-effect transistor and the gate of the second field-effect transistor, and
15 wherein when the image information is input, the first and second switching elements connect the respective connections thereof, and when the inputting of the image information ends, the second switching element cuts the connection thereof, followed by a connection cutting by the first switching element.

20 49. An active-matrix organic electroluminescent display device according to claim 48, wherein the channel width and the channel length of the first field effect-transistor are respectively wider and longer than the channel width and the channel length of the second field-effect transistor.

25 50. An active-matrix display organic electroluminescent device according to claim 46, wherein the driving circuit comprises a third field-effect transistor connected between the first switching element and the first field-effect transistor, a third switching element which connects and cuts a connection between the drain and the gate of the third field-effect transistor, and a second capacitor connected to the gate of the third field-effect transistor, and
30 wherein when the drain and the gate of the first field-effect transistor are connected to each other by the second switch, and when the drain and the gate of the third field-effect transistor are connected to each other by the third switching element, the image information is fed in the form of current between the drain and the source of each of the first field-effect transistor and the third field-effect transistor via the first switching element.

35 51. An active-matrix display organic electroluminescent device according to claim 37, wherein the plurality of driving circuits, each arranged for every plural number of data lines, shares a single signal input line, and uses the signal input line on a time sharing manner to receive the image information.

40 52. An active-matrix organic electroluminescent display device according to claim 37, wherein the driving circuit comprises a holding unit for holding, in the form of voltage, the image information supplied in the form of voltage.

45 53. An active-matrix organic electroluminescent display device according to claim 52, wherein the holding unit comprises a capacitor for holding the voltage responsive to the image information,
wherein the driving circuit comprises a field-effect transistor for driving each of the plurality of data lines based on the voltage held in the capacitor, and
50 wherein the field-effect transistor is supplied with the image information with the gate thereof capacitively coupled to the signal input line via a writing capacitor subsequent to an electrically shorting of the connection between the gate and the drain thereof.

55 54. An active-matrix organic electroluminescent display device according to claim 53, wherein the driving circuit comprises a switching element connected between a node of the writing capacitor with the signal input line and a point at a predetermined potential, and
wherein the node of the writing capacitor with the signal input line becomes the predetermined potential in voltage level with the switching element electrically shorted while the gate and the drain of the field-effect transistor are electrically connected to each other.

56. An active-matrix organic electroluminescent display device according to claim 37, wherein a plurality of rows of driving circuits shares each data line.

56. An active-matrix organic electroluminescent display device according to claim 55, wherein the driving circuits com-

prise two rows of driving circuits sharing each data line, and
wherein one row of driving circuits drives the data line while the other row of driving circuits receives the image information.

5 57. An active-matrix organic electroluminescent display device according to claim 55, wherein the driving circuits comprise three rows of driving circuits sharing each data line, and
wherein, in a given scanning cycle, a first row of driving circuits performs a reset operation, a second row of driving circuits performs a data written operation, and a third row of driving circuits performs a data line driving operation.

10 58. An active-matrix organic electroluminescent display device according to claim 37, wherein the transistor forming the driving circuit is a thin-film transistor that is manufactured at the same time when the transistor forming the pixel circuit is manufactured.

15 59. An active-matrix organic electroluminescent display device according to claim 37, further comprising a leakage element connected between a signal input line for inputting the image information and a point at a predetermined potential.

20 60. An active-matrix organic electroluminescent display device according to claim 37, further comprising an initial value setting element, connected between a signal input line for receiving the image information and a point at a predetermined potential, for setting the voltage of the signal input line to the predetermined value prior to the supplying of the image information to the driving circuit through the signal input line.

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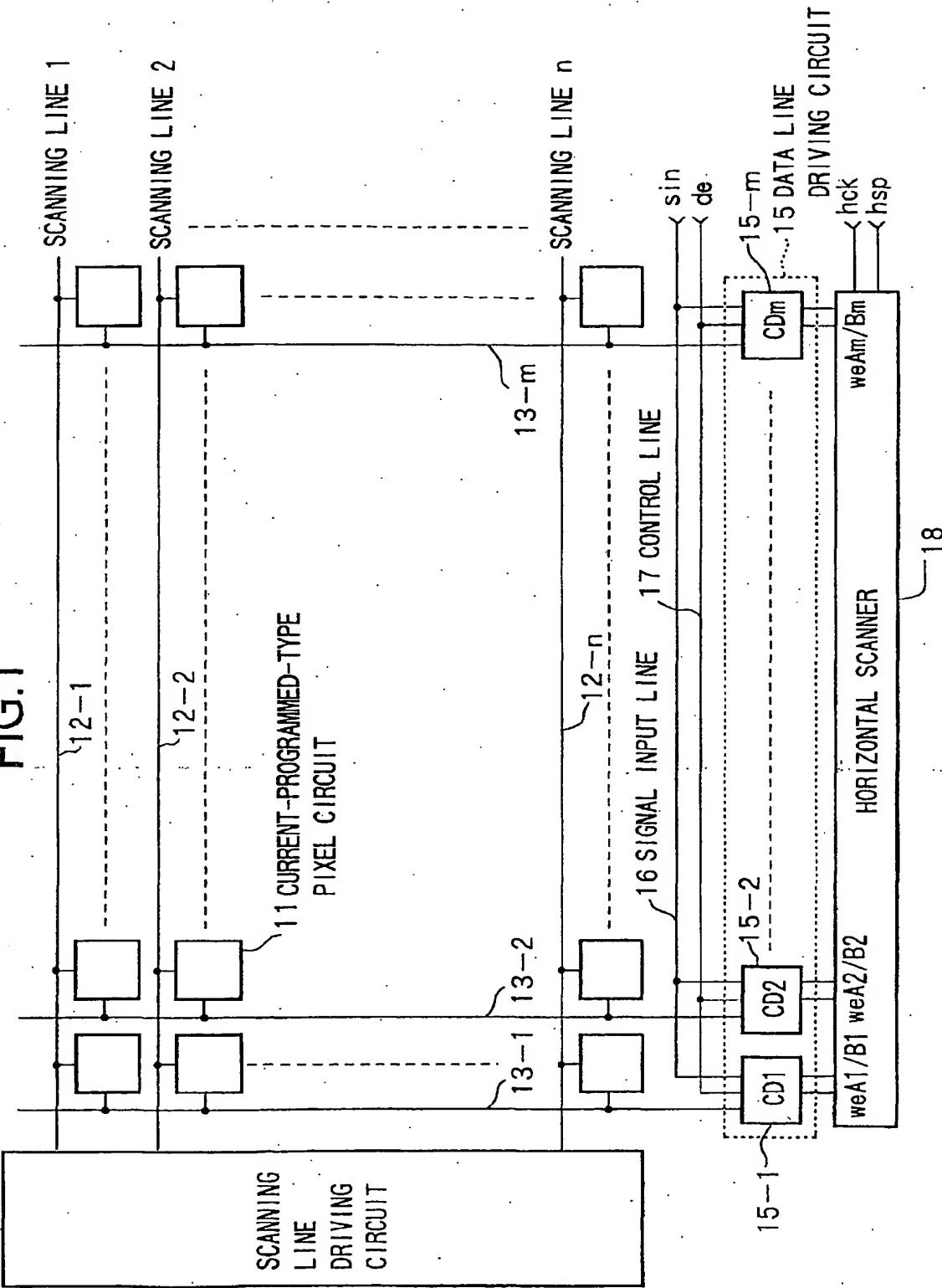
45

50

55

14

FIG.1



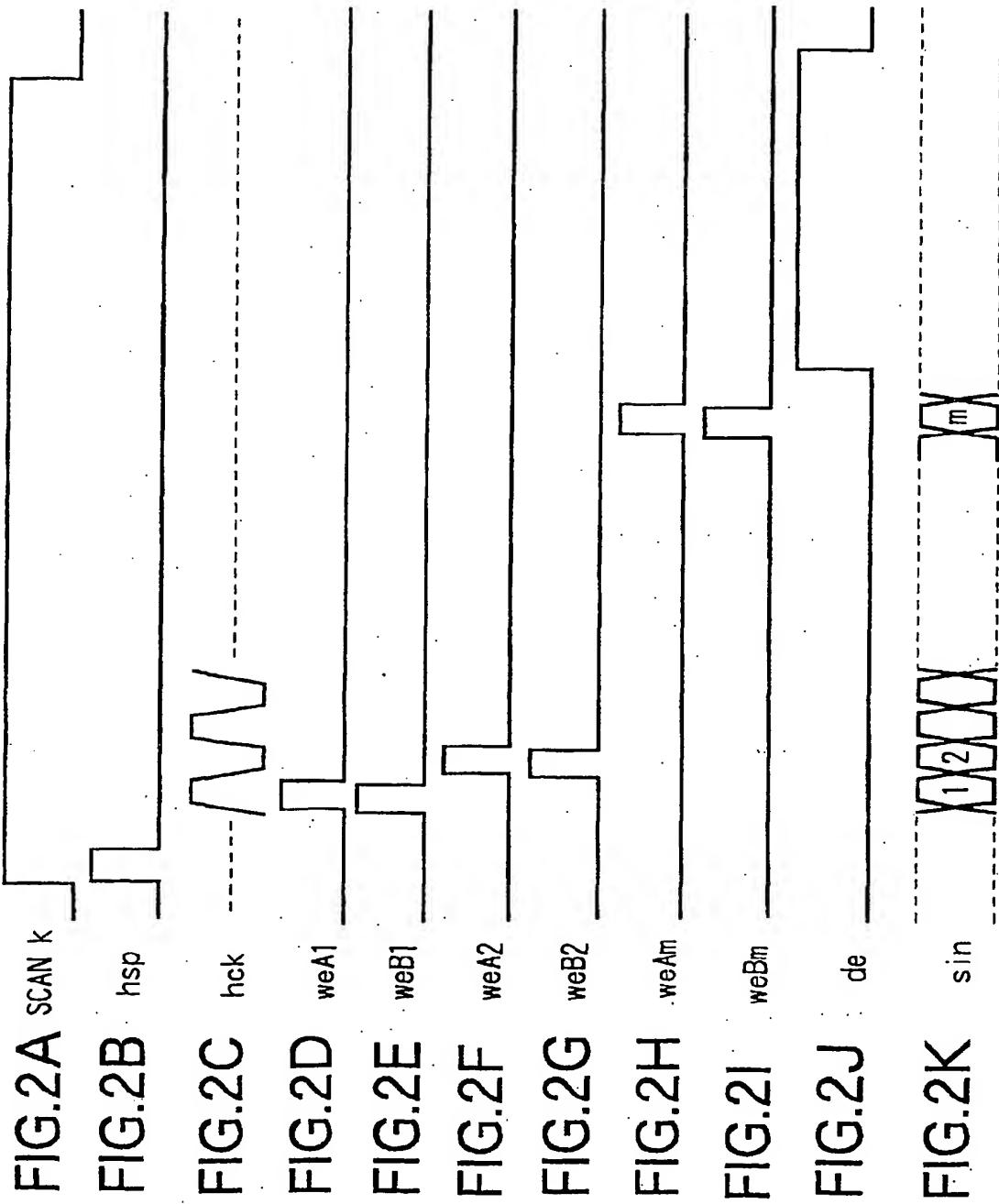


FIG.3

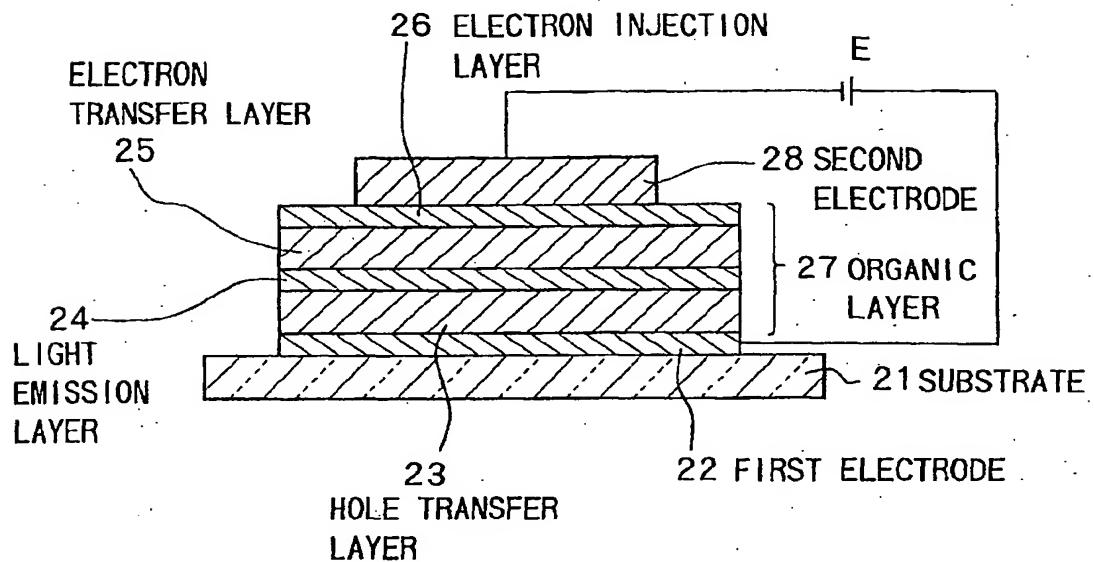
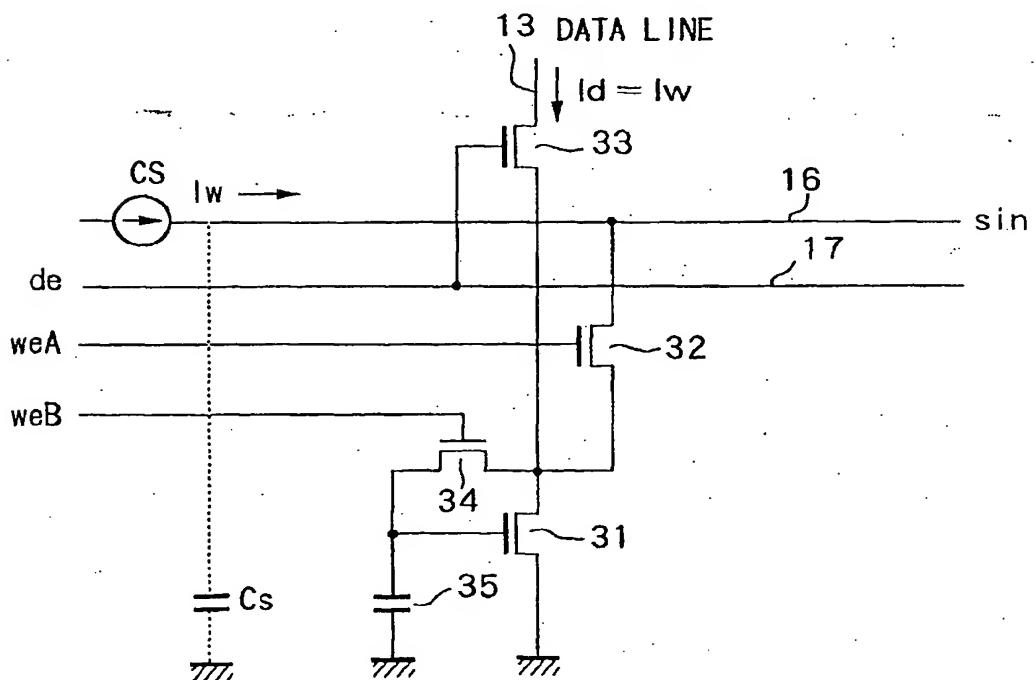


FIG.4



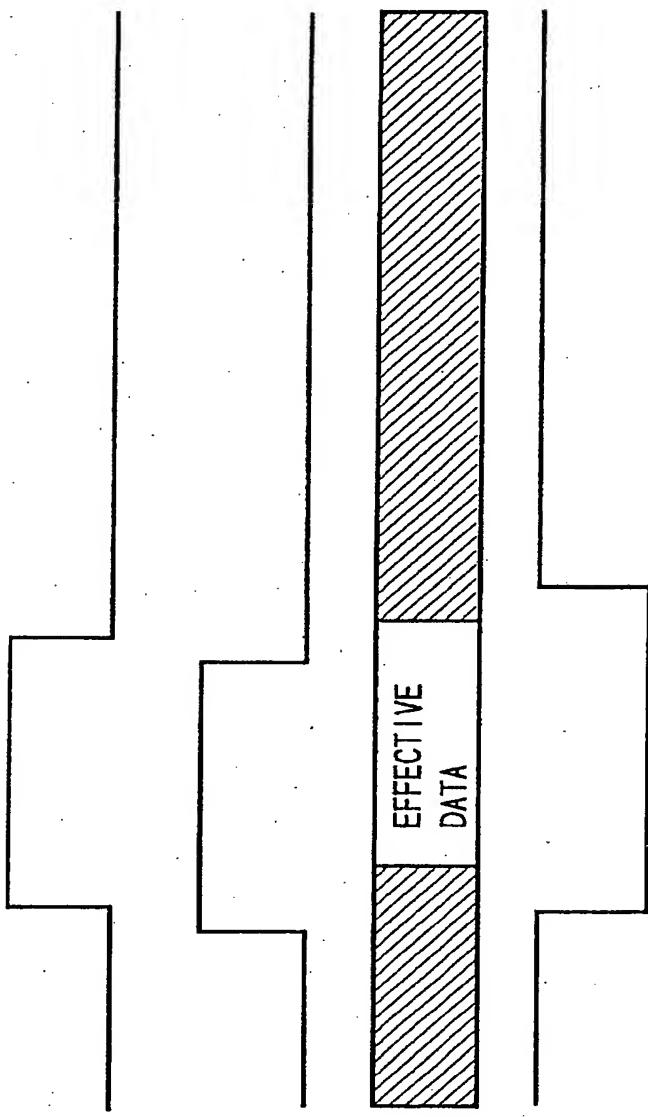


FIG.5A _{weA}

FIG.5B _{weB}

FIG.5C _{lw}

FIG.5D _{de}

FIG.6

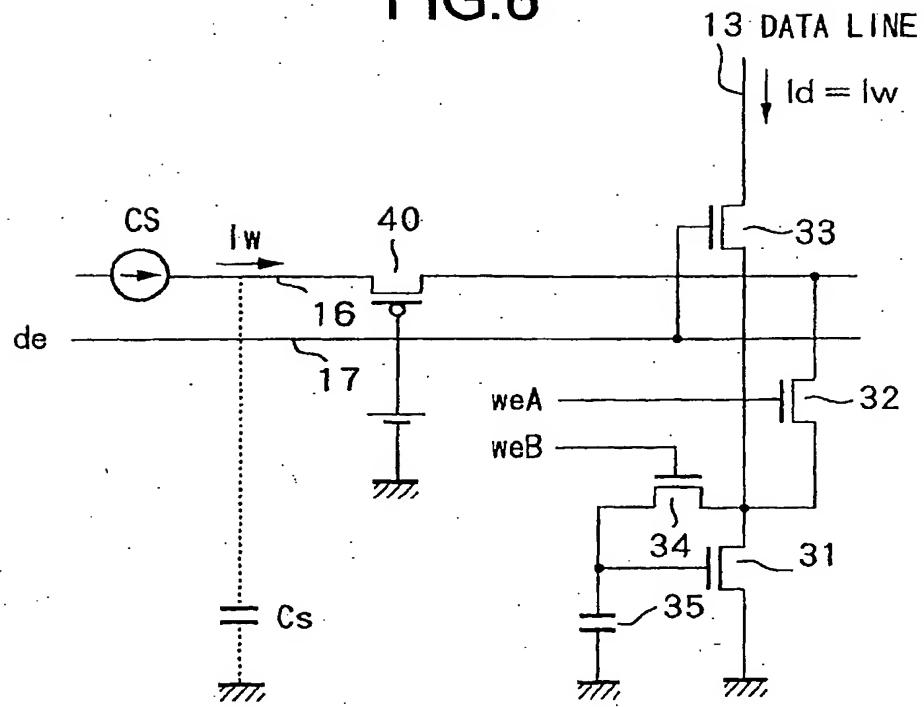


FIG.7

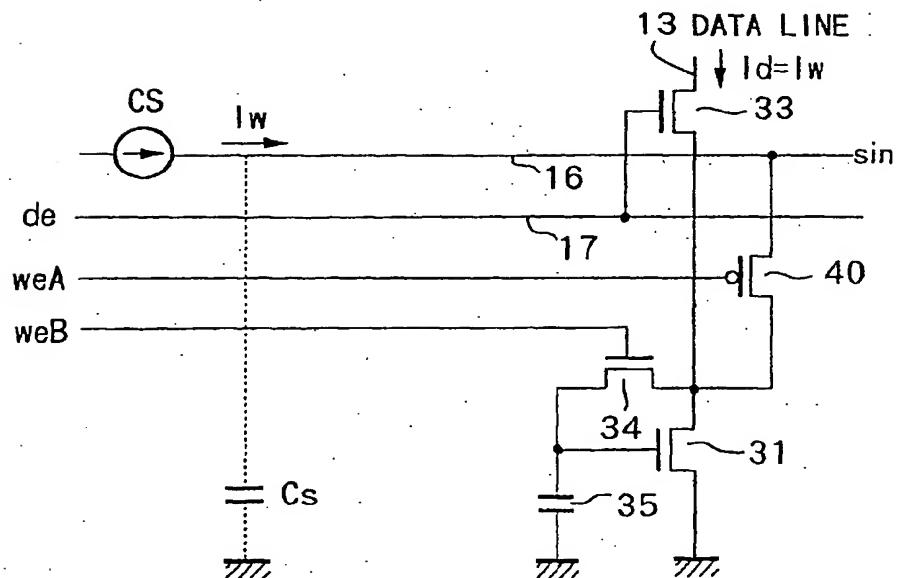


FIG.8

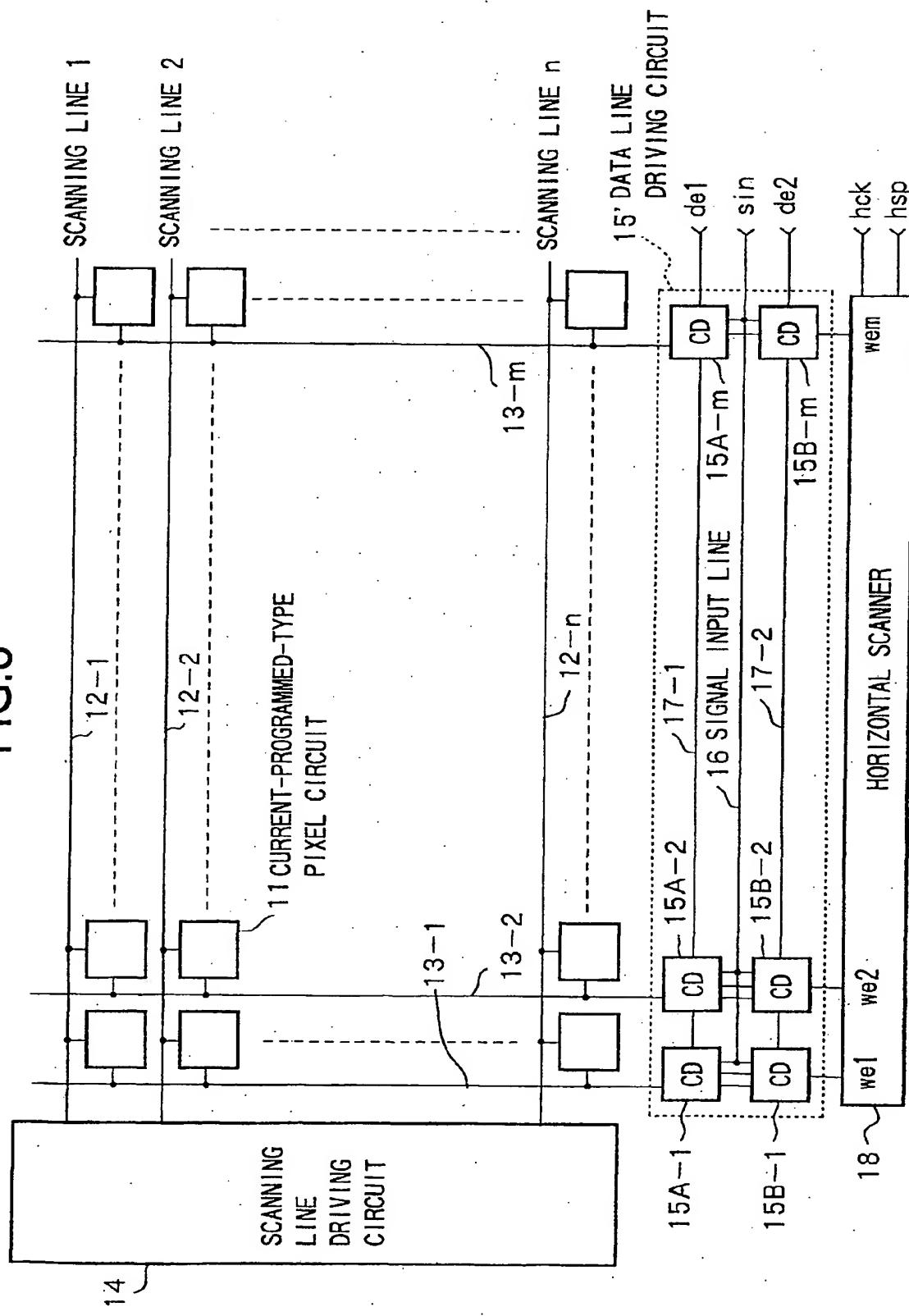


FIG.9A

SCAN k



FIG.9B

SCAN k+1



FIG.9C

hsp



FIG.9D

hck



FIG.9E

we1



FIG.9F

we2



FIG.9G

wem

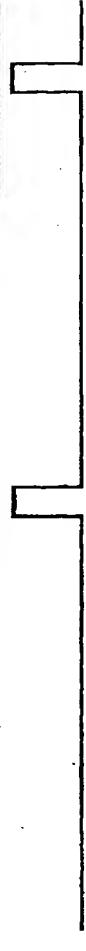


FIG.9H

de1



FIG.9I

de2



FIG.9J

sin

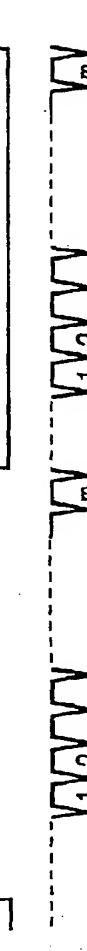


FIG.10

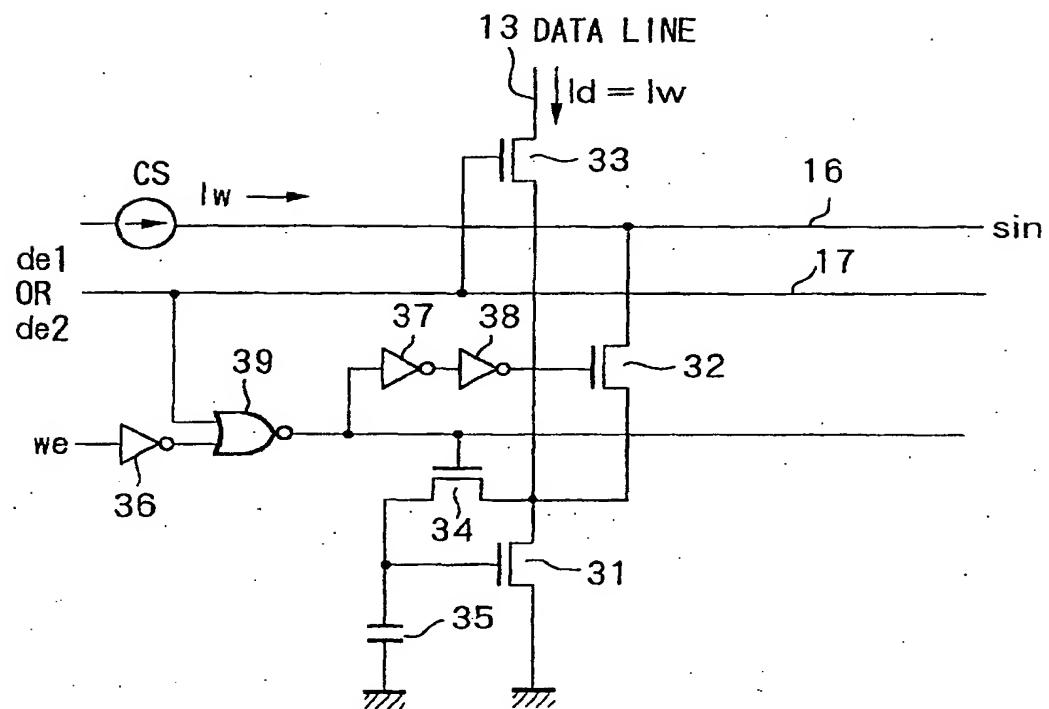


FIG. 11

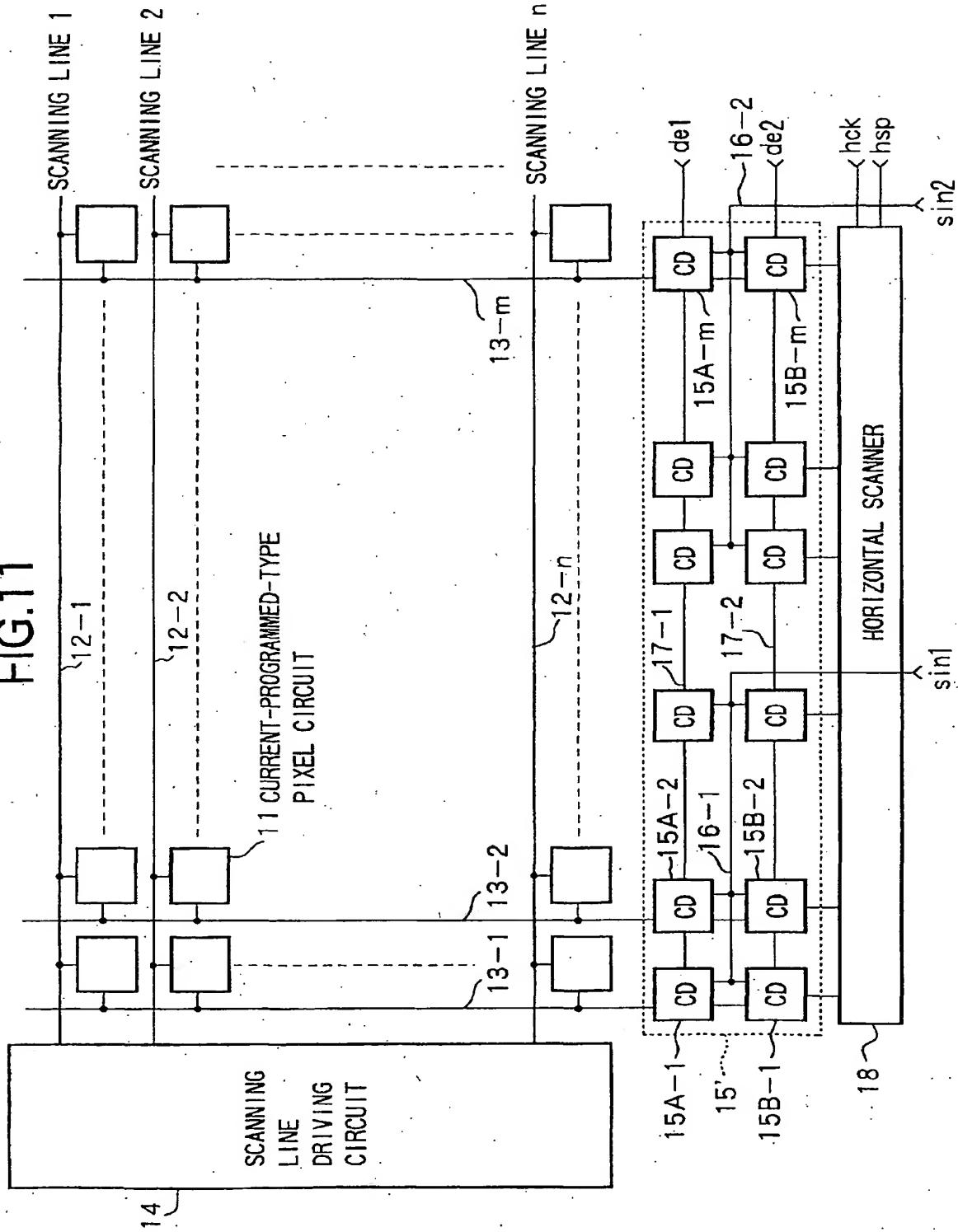


FIG.12

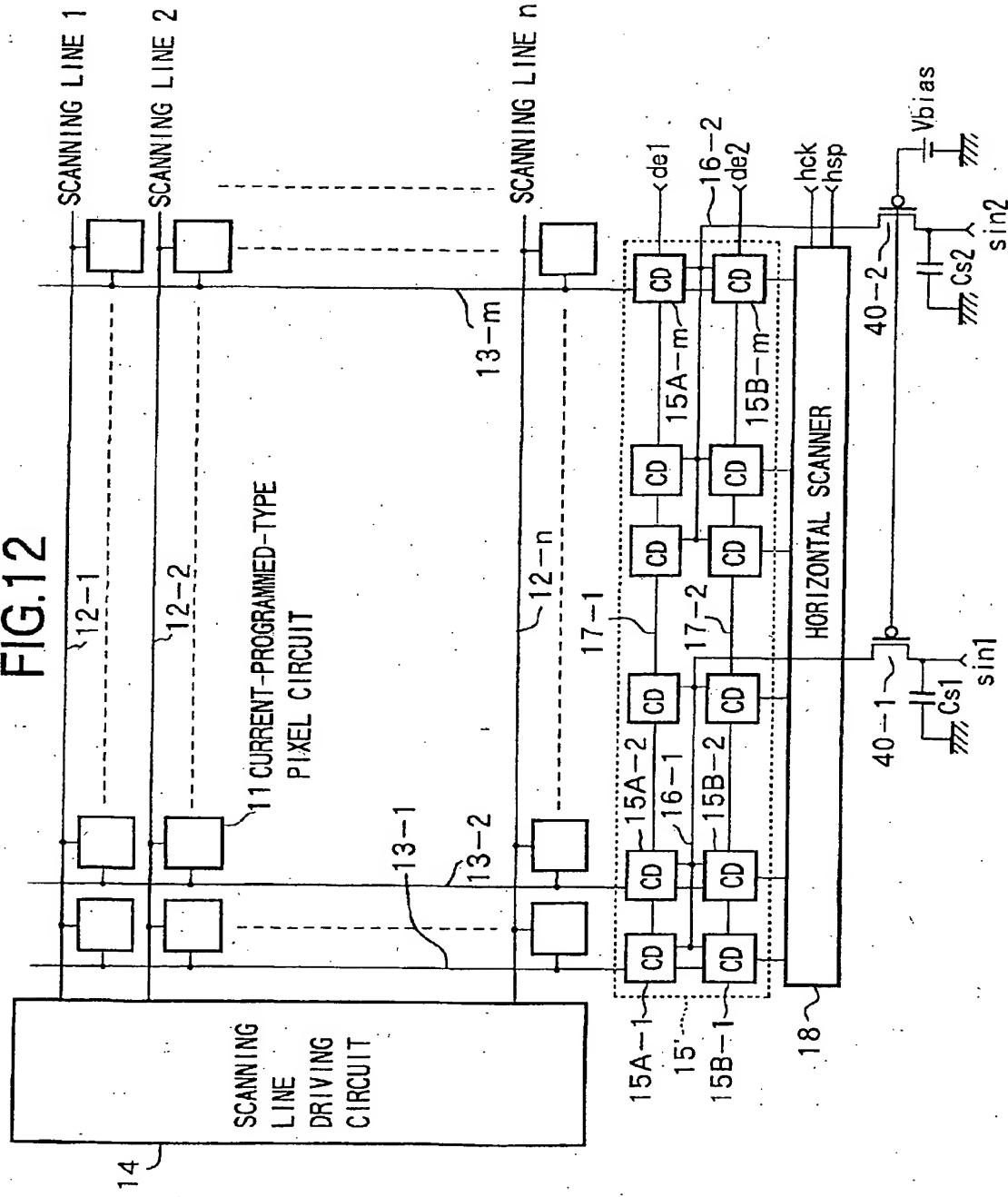


FIG.13

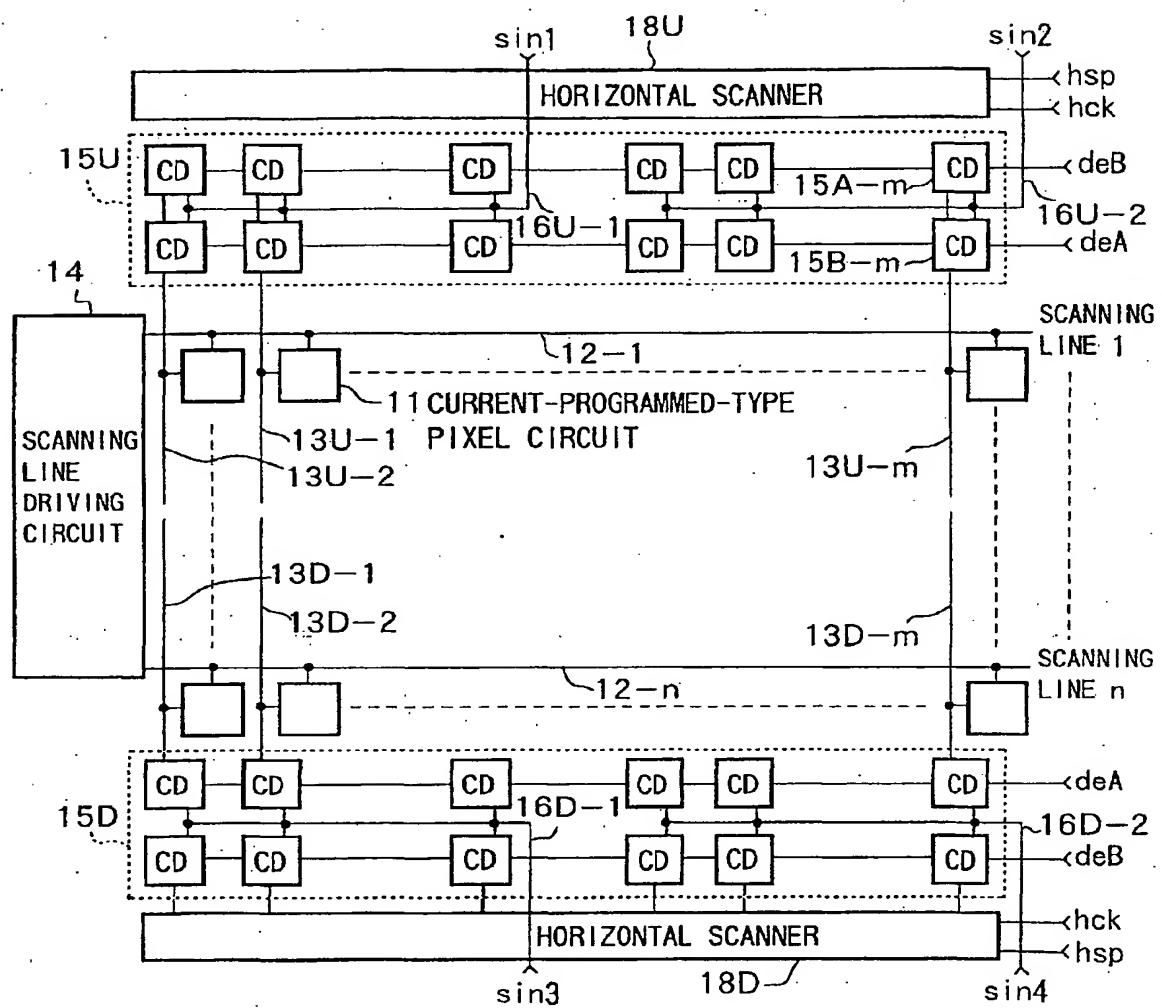
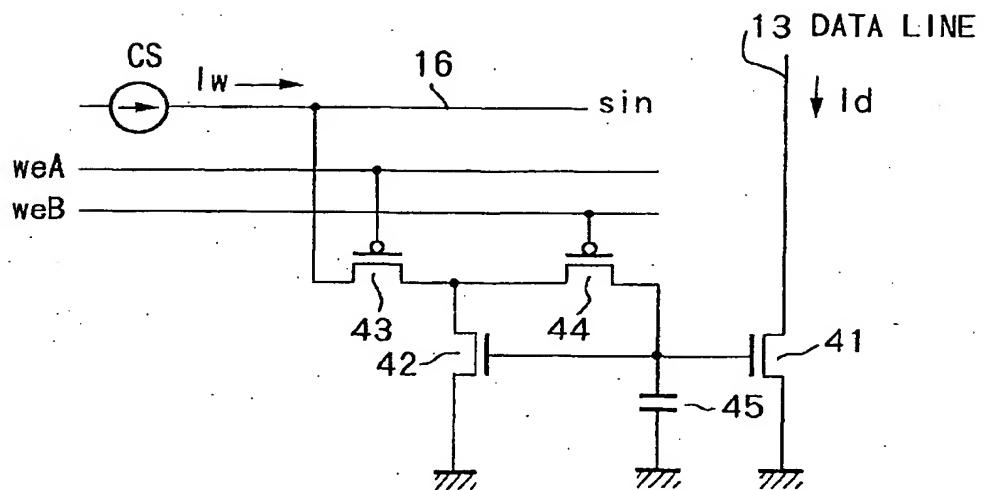


FIG.14



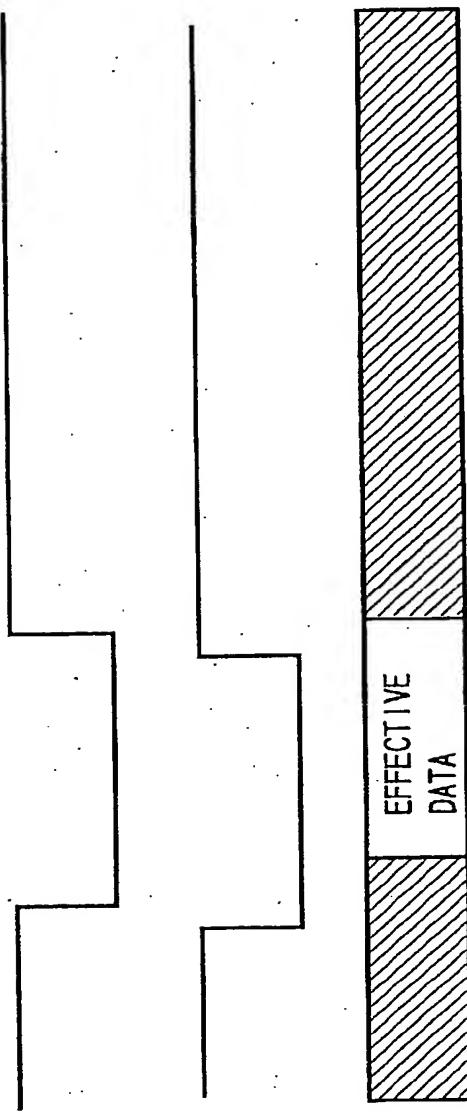


FIG. 15A w_{eA}

FIG. 15B w_{eB}

FIG. 15C l_w

FIG.16

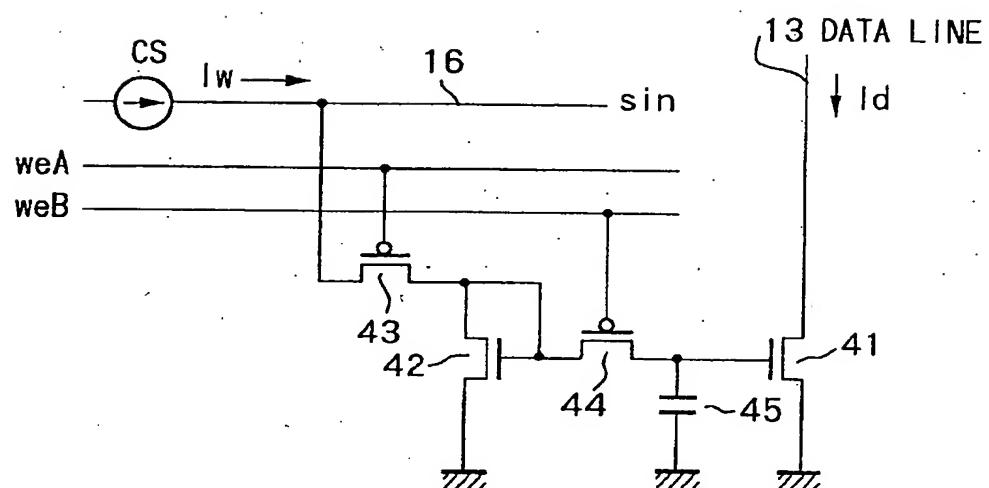


FIG.17

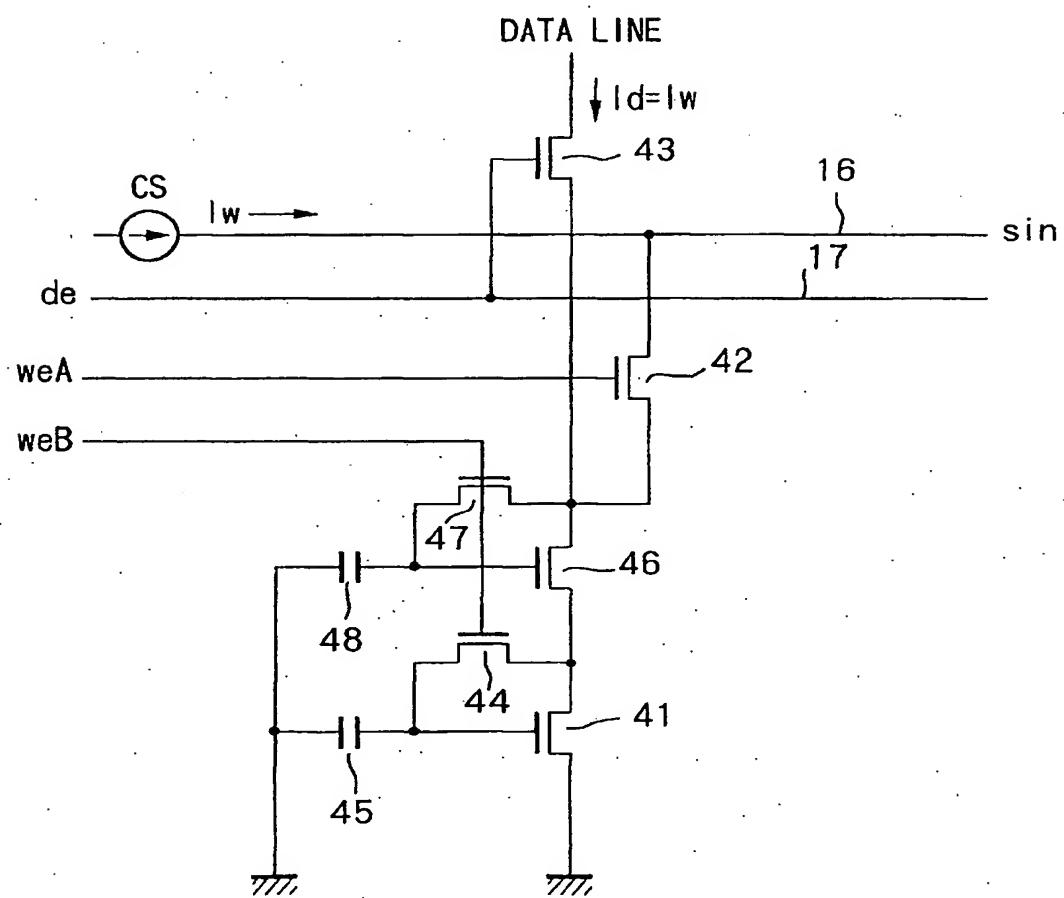


FIG.18

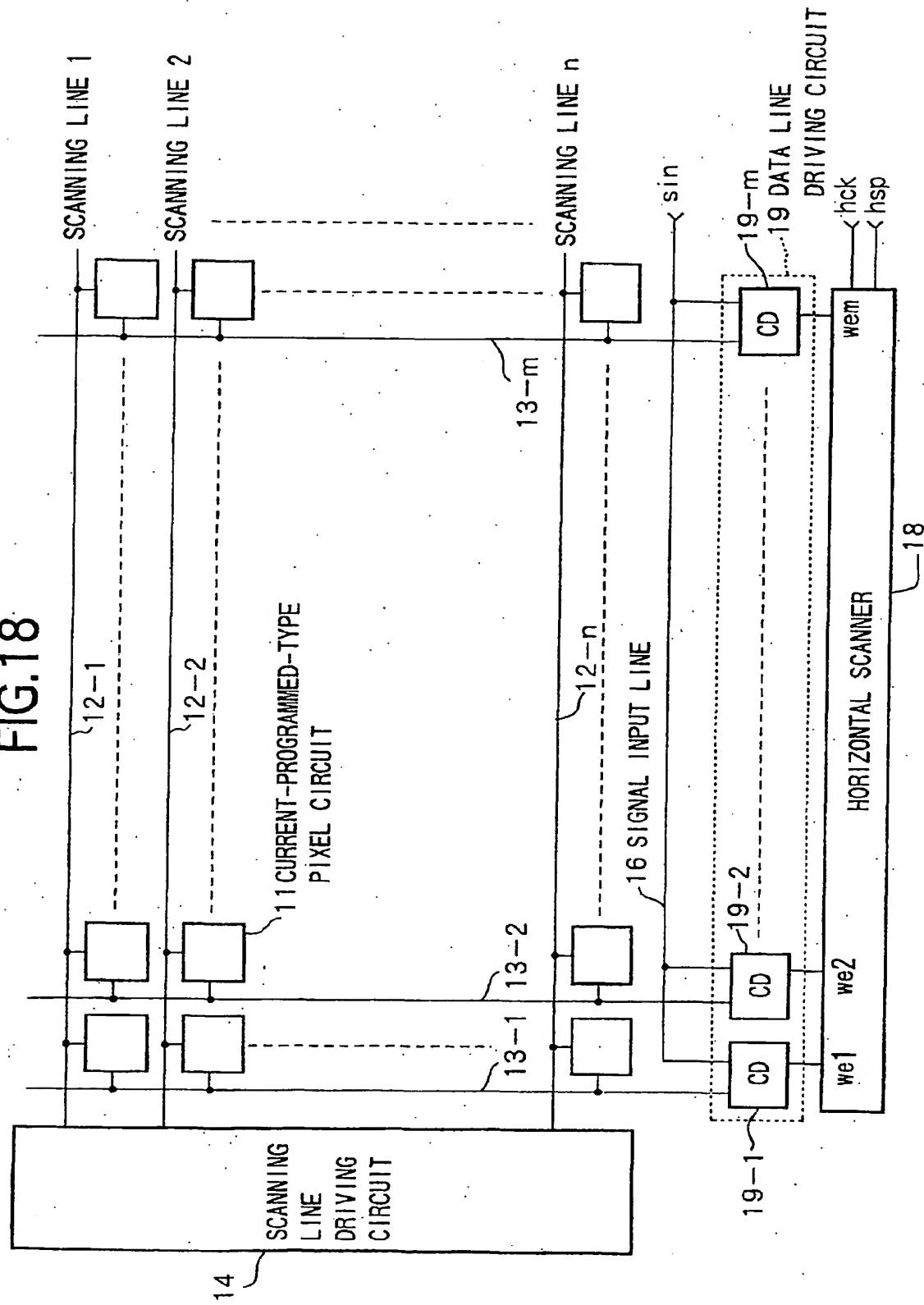
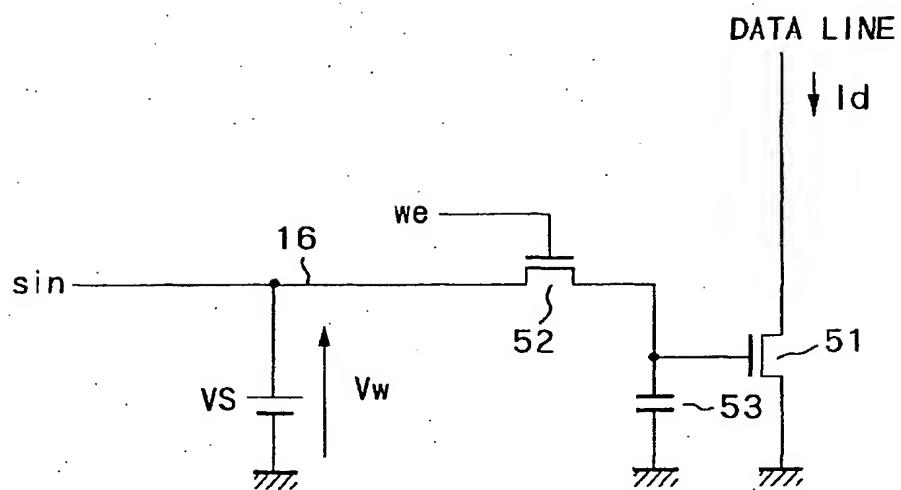


FIG.19



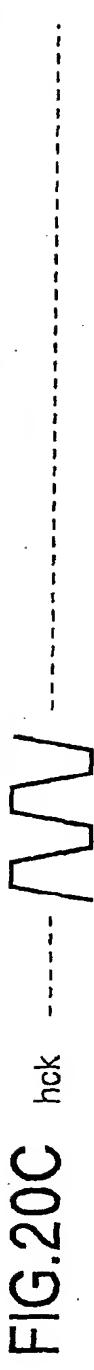
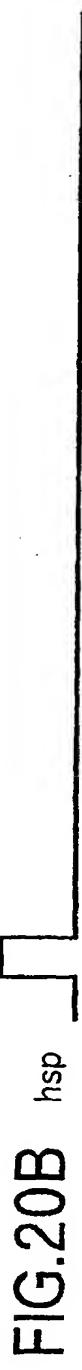
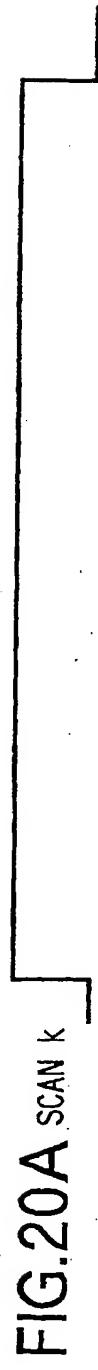


FIG.21

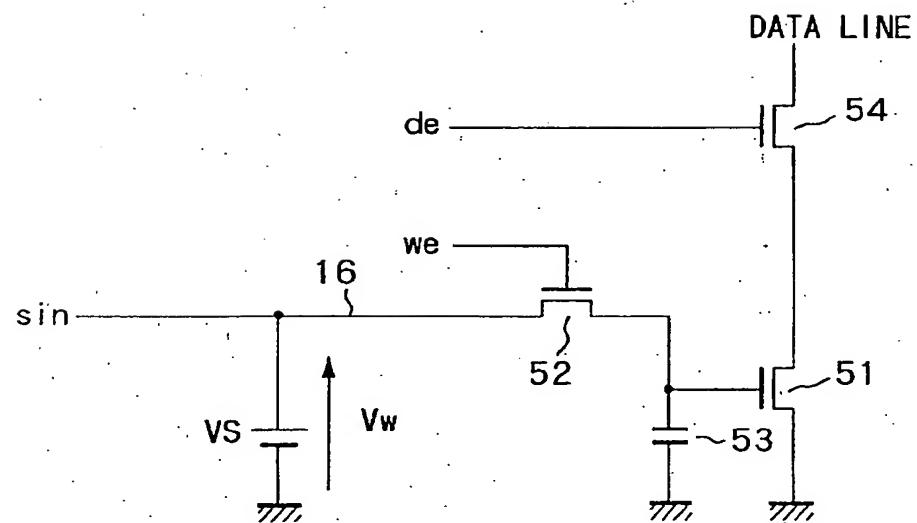


FIG.22

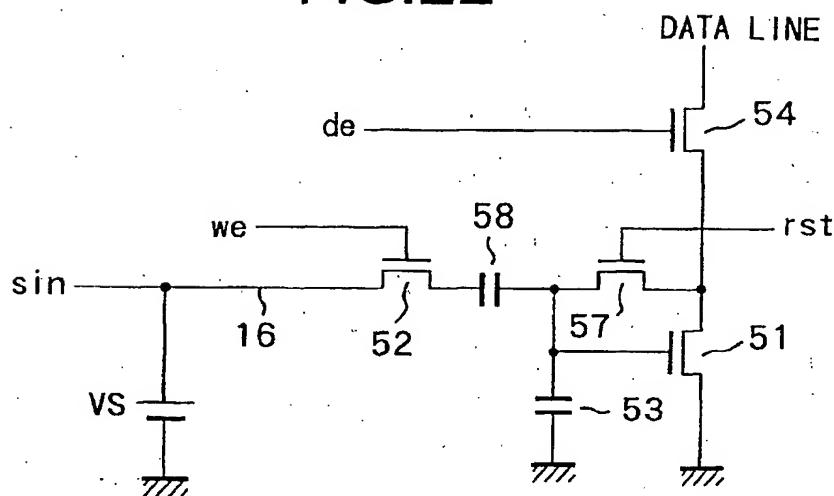


FIG.23A



FIG.23B



FIG.23C



FIG.23D

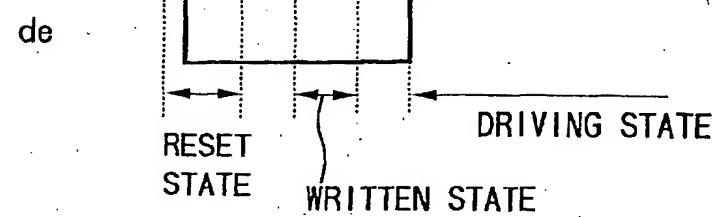


FIG.24

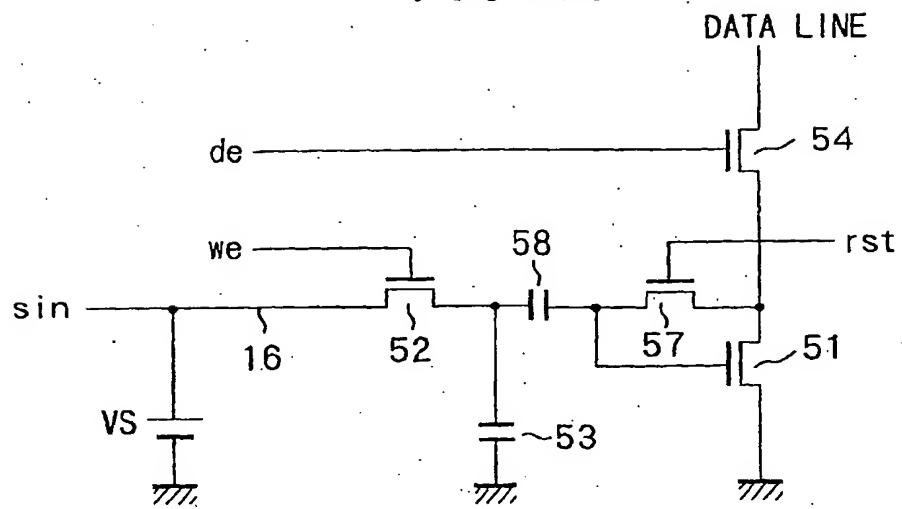


FIG.25

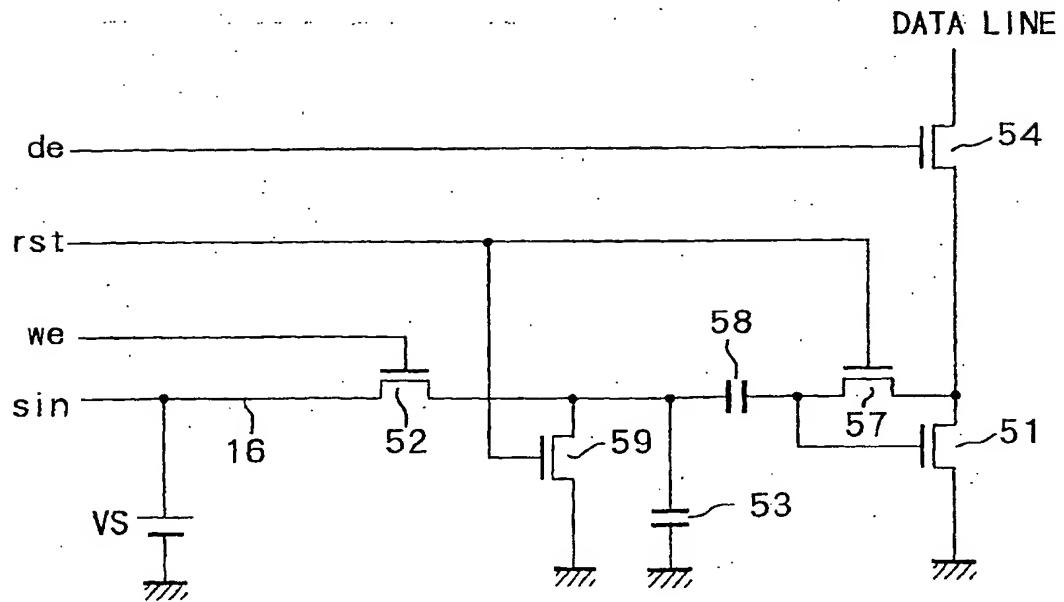


FIG.26A

rst



FIG.26B

we



FIG.26C

sin

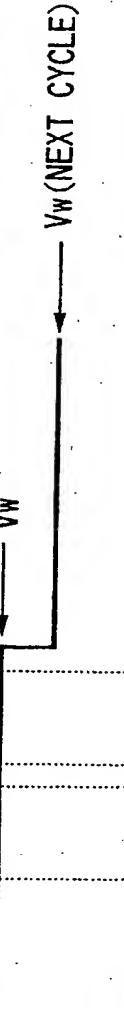
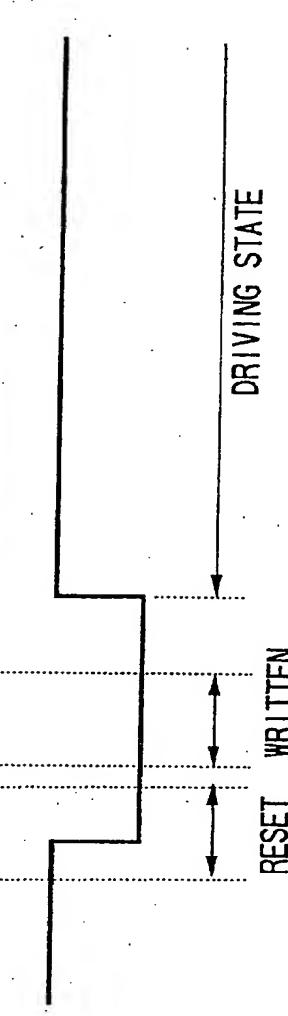
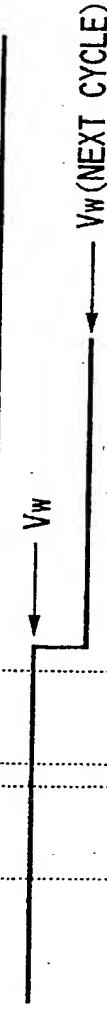
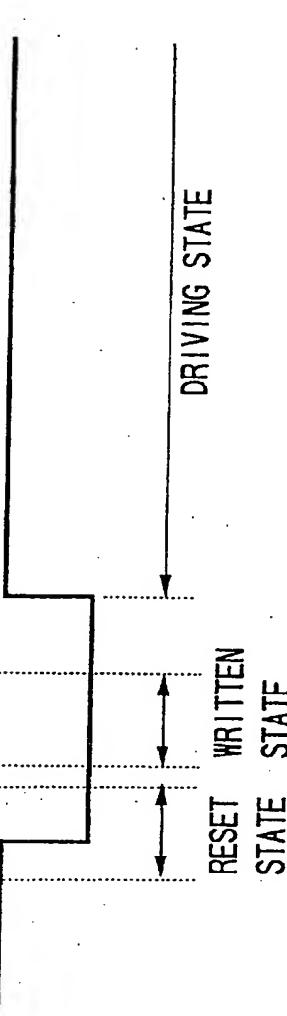


FIG.26D

de

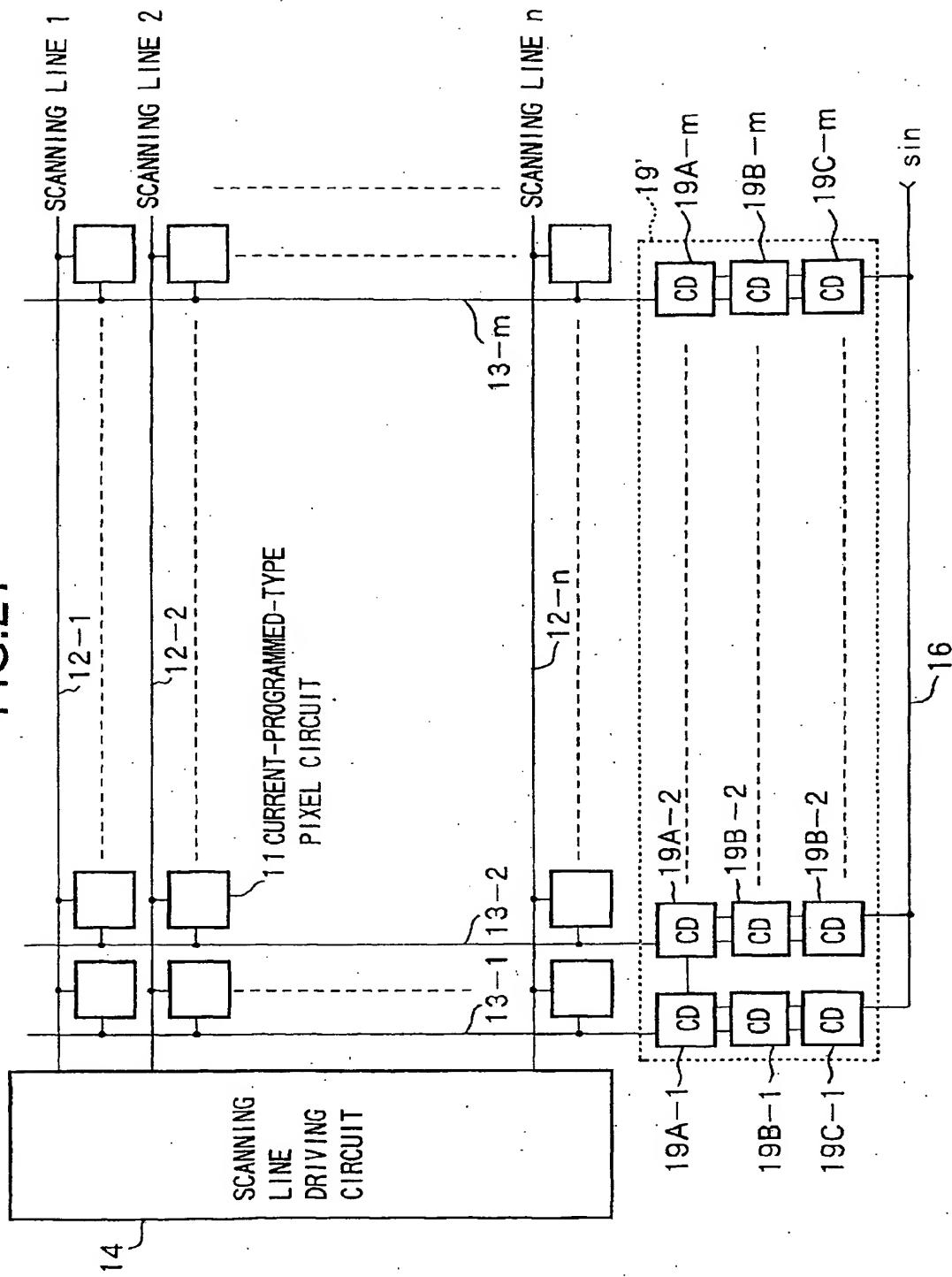


RESET STATE

WRITTEN STATE

DRIVING STATE

FIG.27



1-H(1 SCANNING LINE CYCLE)

OPERATION OF FIRST COLUMN OF DATA LINE			
RESET STATE	WRITTEN STATE	DRIVING STATE	RESET STATE

DRIVING CIRCUIT

FIG.28A

OPERATION OF SECOND COLUMN OF DATA LINE			
RESET STATE	WRITTEN STATE	DRIVING STATE	RESET STATE

DRIVING CIRCUIT

FIG.28B

OPERATION OF THIRD COLUMN OF DATA LINE			
RESET STATE	WRITTEN STATE	DRIVING STATE	RESET STATE

DRIVING CIRCUIT

FIG.28C

FIG.29

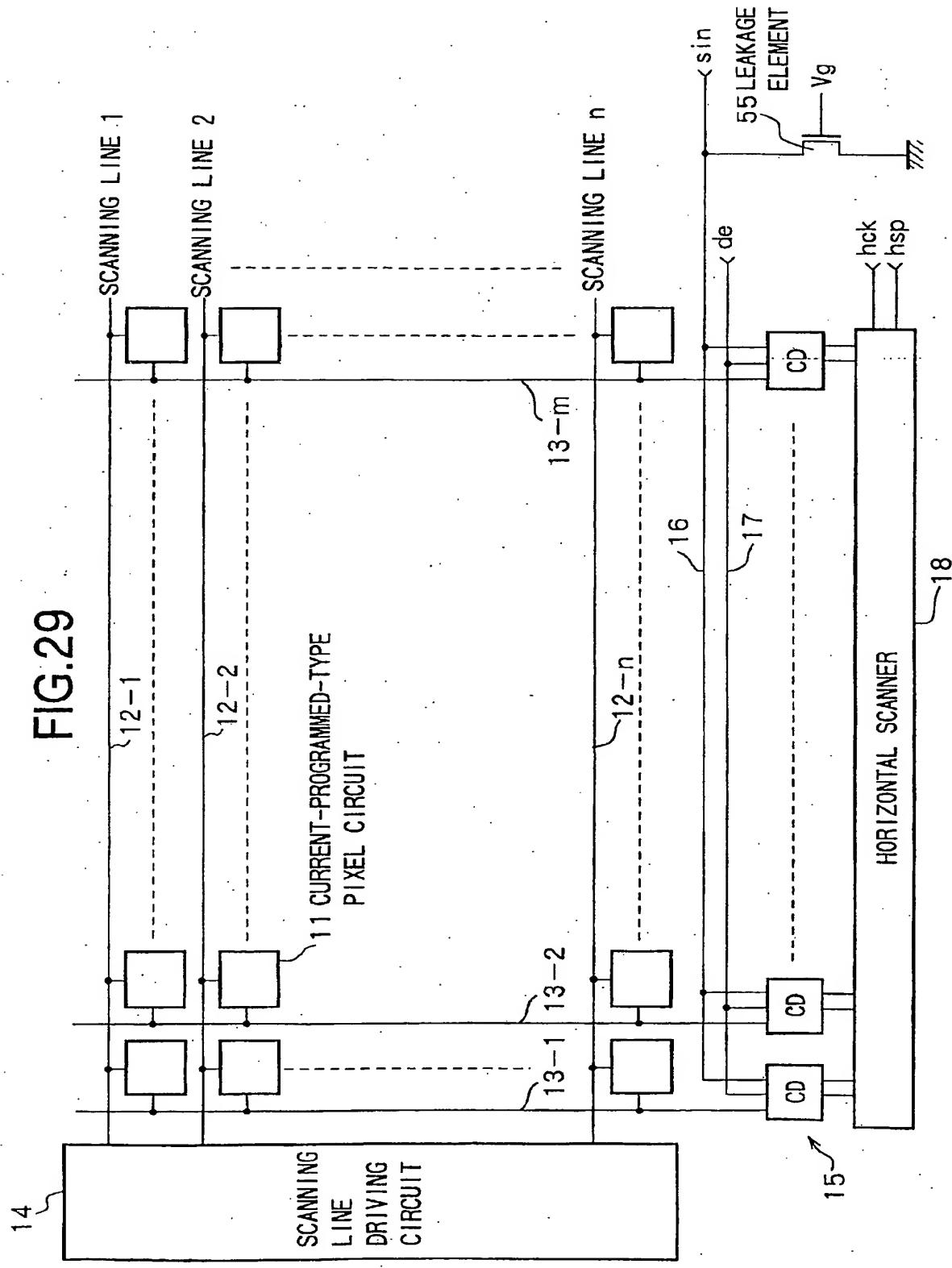


FIG.30

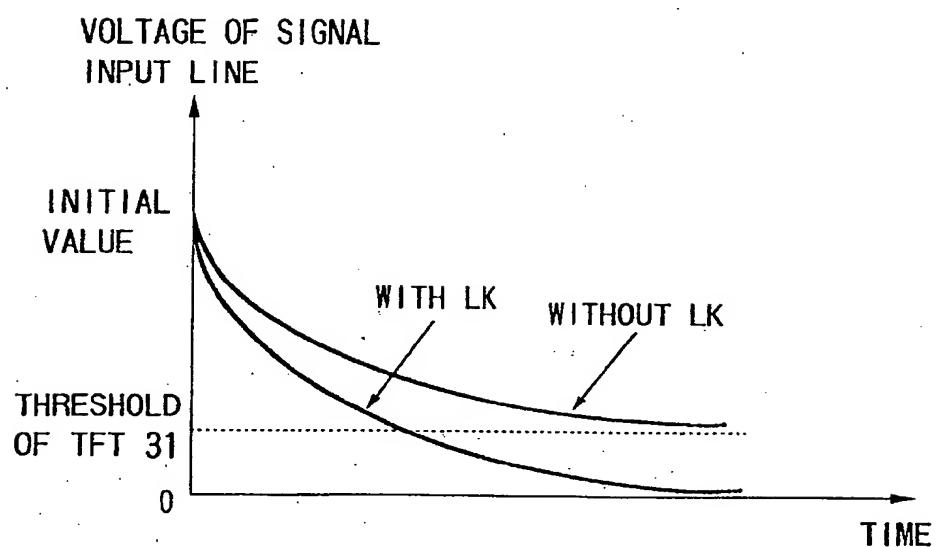


FIG. 31

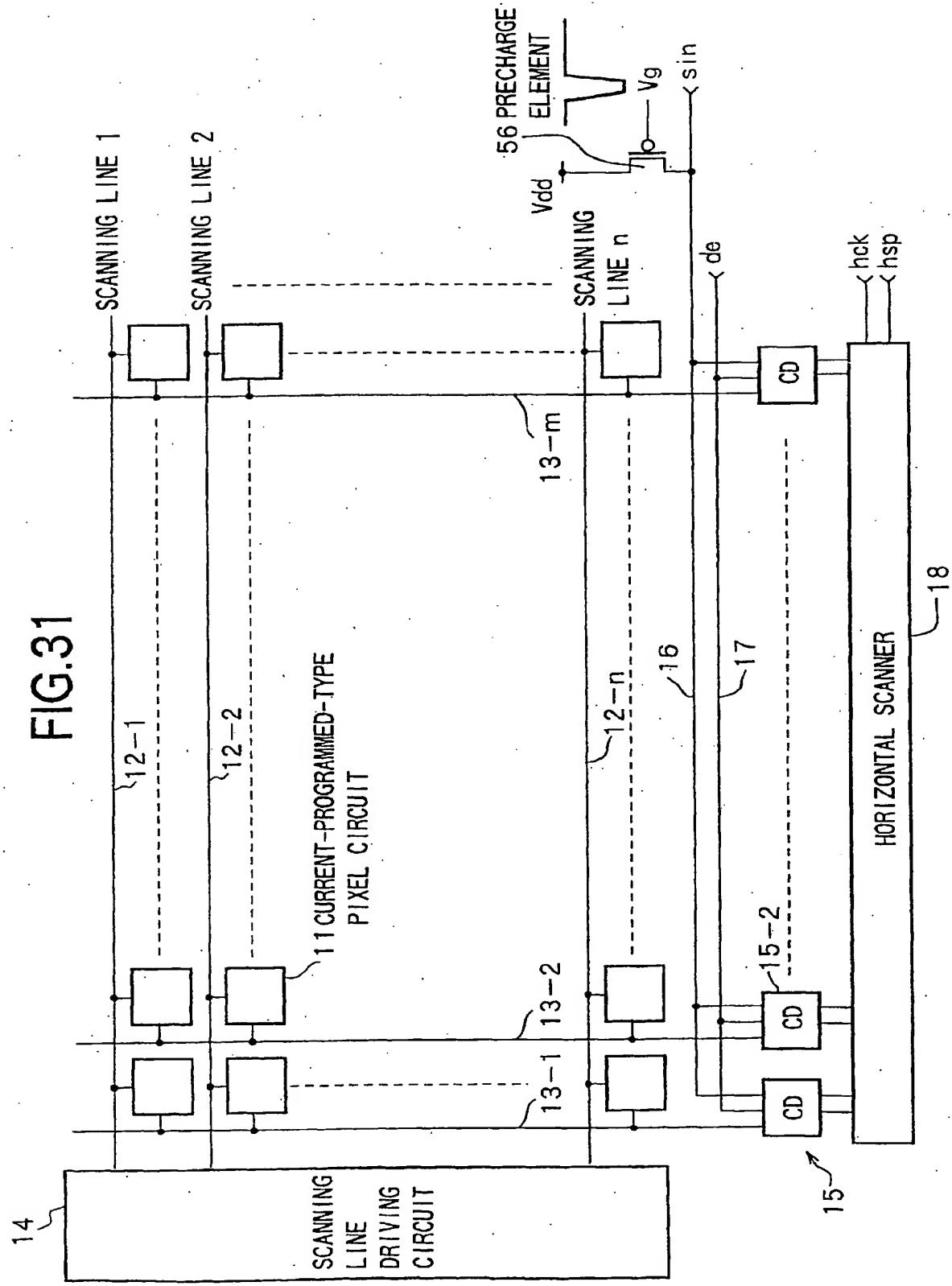


FIG.32

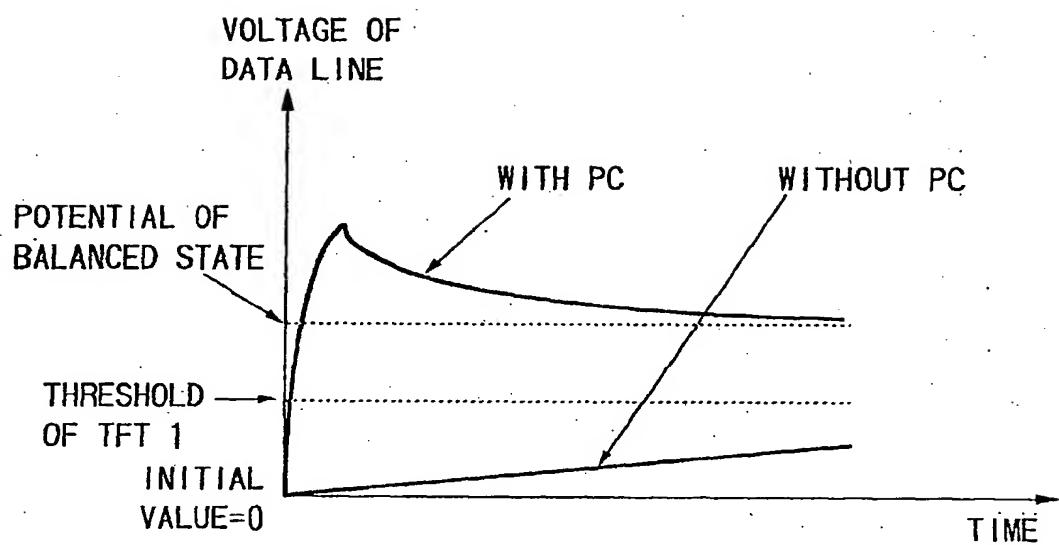


FIG.33

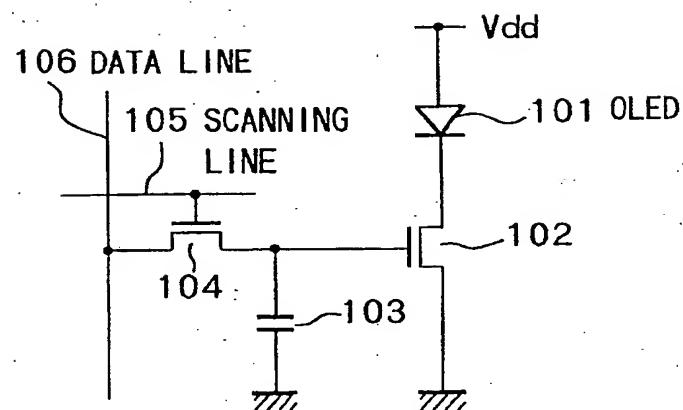


FIG.34

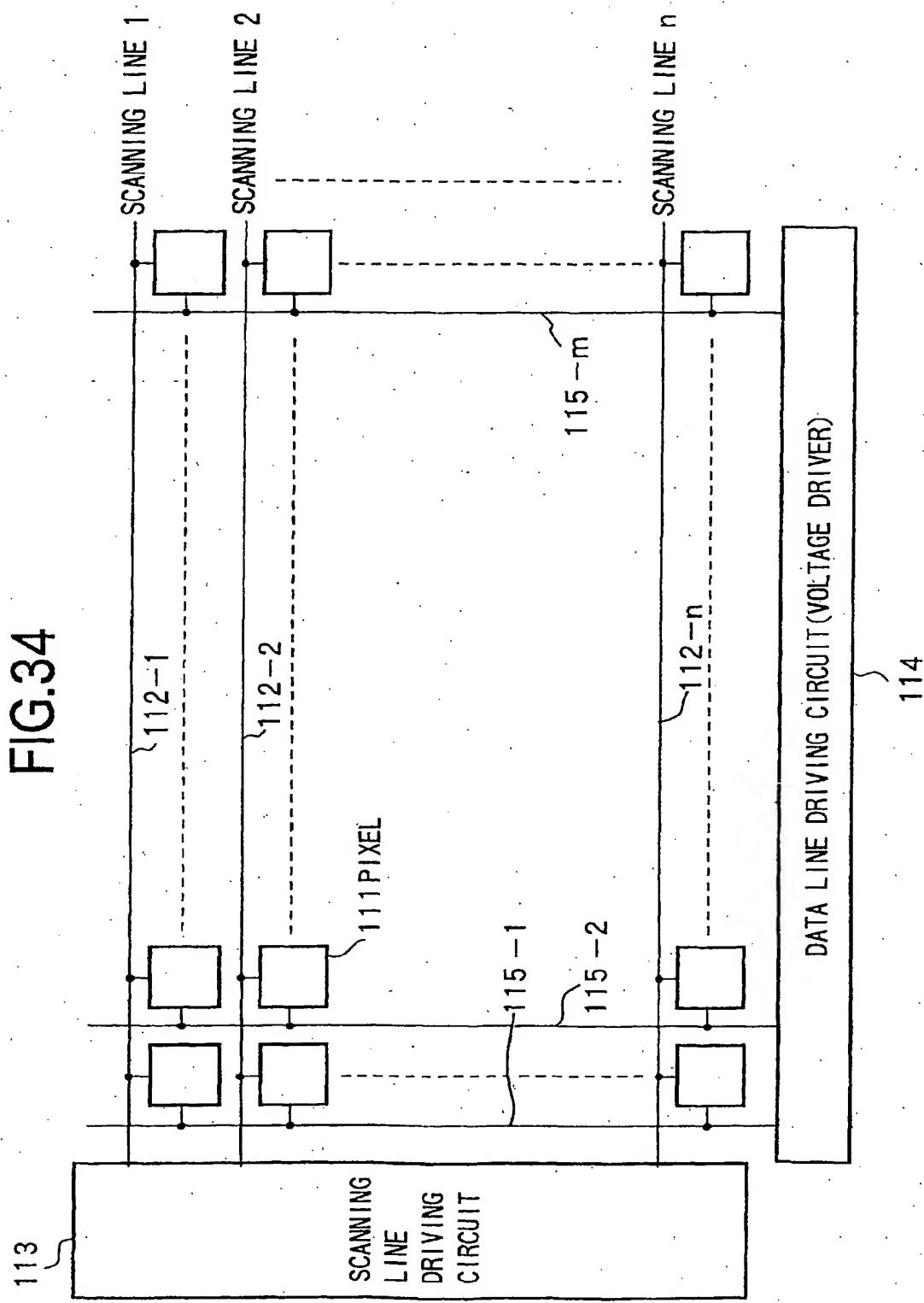


FIG.35

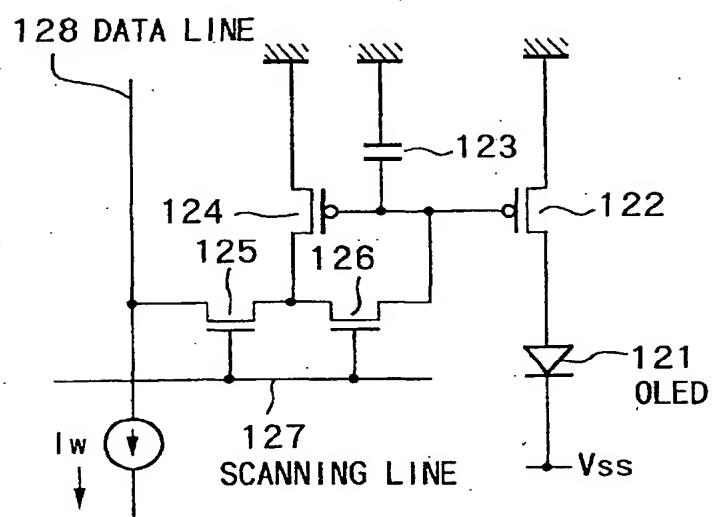


FIG.36A SCANNING LINE

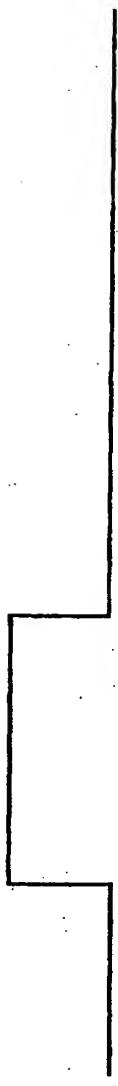


FIG.36B CURRENT OF DATA LINE

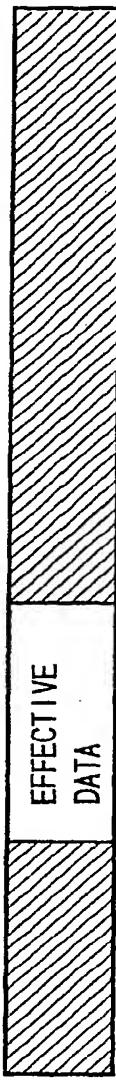


FIG.36C OLED LUMINANCE



FIG.37

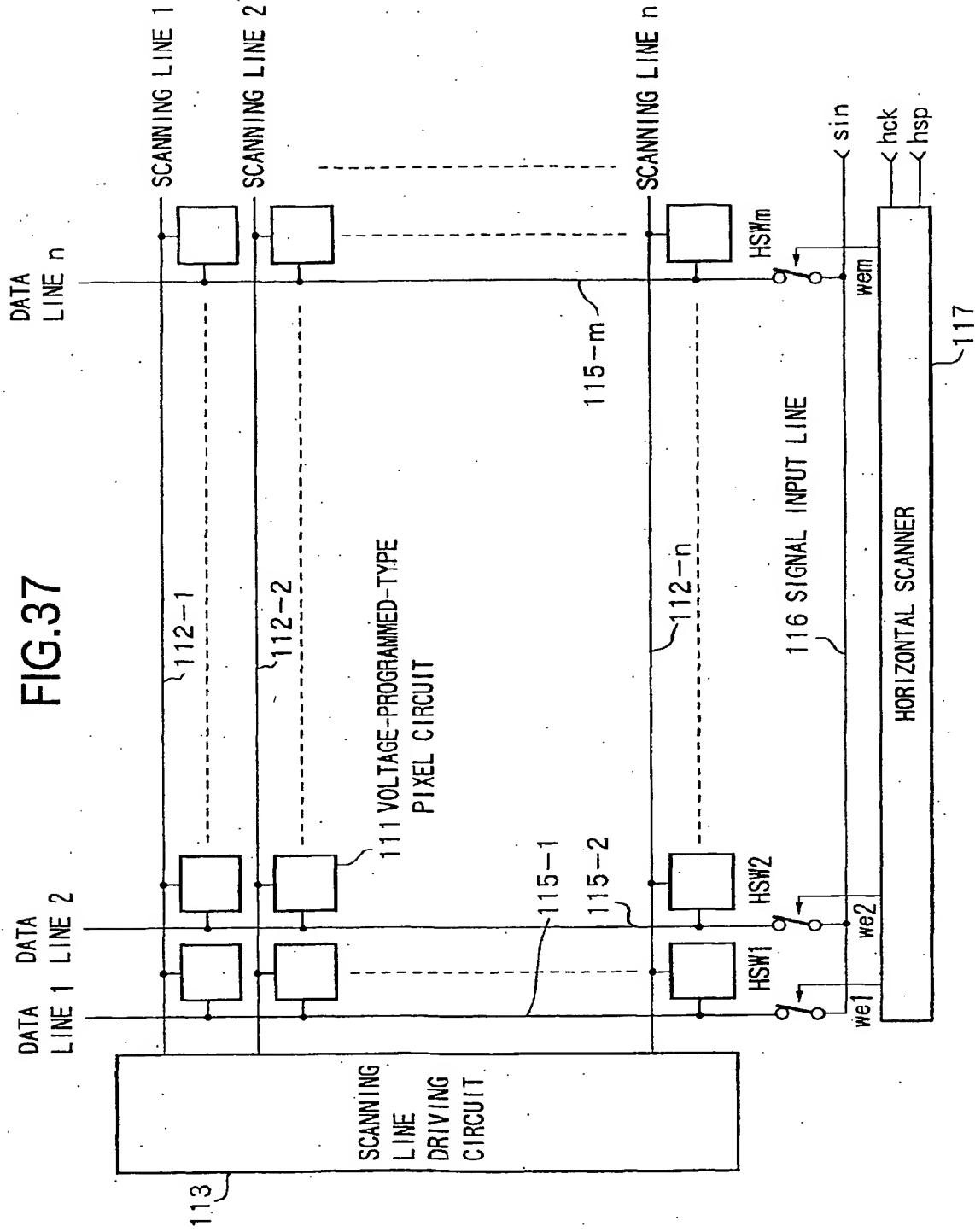


FIG.38A h_{sp}

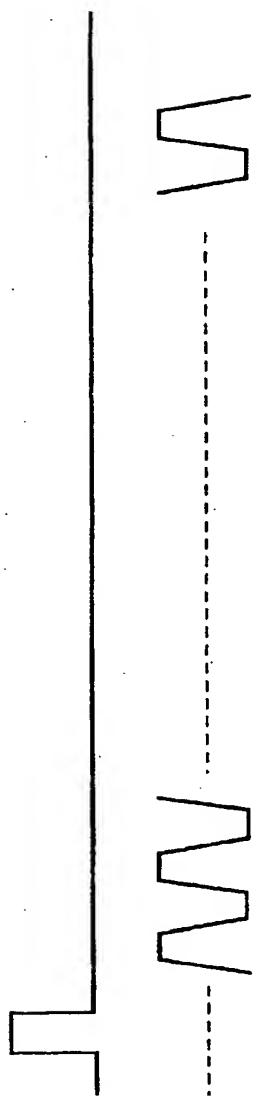


FIG.38B h_{ck}

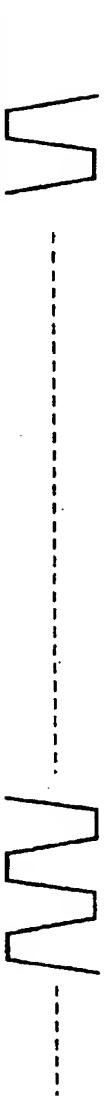


FIG.38C w_{e1}

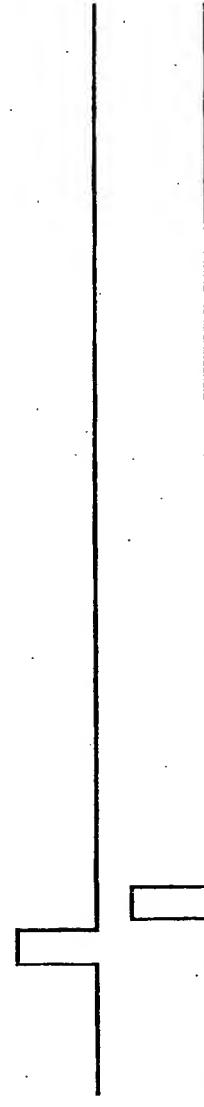


FIG.38D w_{e2}



FIG.38E w_{em}



FIG.38F \sin

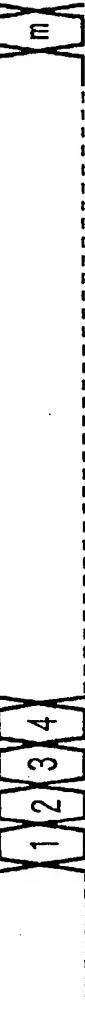
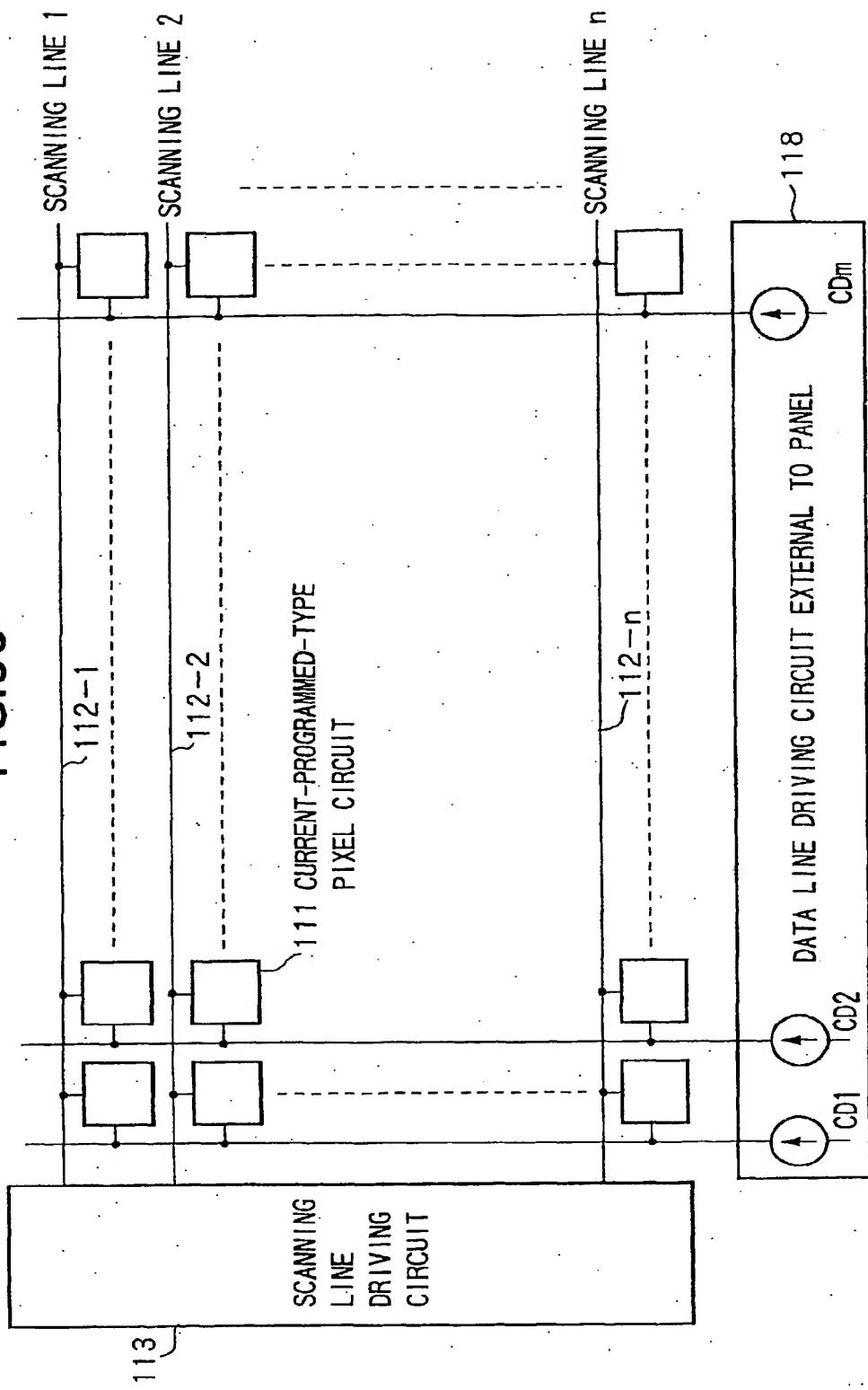


FIG.39



LIST OF REFERENCES

- 11... current-programmed-type pixel circuit
- 12-1 to 12-n... scanning line
- 13-1 to 13-m,
- 13U-1 to 13U-m,
- 13D-1 to 13D-3... data line
- 14... scanning line driving circuit
- 15, 19... data line driving circuit
- 15-1 to 15-m,
- 15A-1 to 15A-m,
- 15B-1 to 15B-m... current-programmed-type current driver
- 16, 16-1,
- 16-2, 16U-1,
- 16U-2, 16D-1,
- 16D-2... signal input line
- 18... horizontal scanner
- 19-1 to 19-m,
- 19A-1 to 19A-m,
- 19B-1 to 19B-m,
- 19C-1 to 19C-m... current-programmed-type current driver
- 55... leakage element
- 56... precharge element

INTERNATIONAL SEARCH REPORT

International application No.

PCT/JP01/09735

A. CLASSIFICATION OF SUBJECT MATTER

Int. Cl⁷ G09G3/30

According to International Patent Classification (IPC) or to both national classification and IPC

B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)

Int. Cl⁷ G09G3/30, 3/32, 3/36, G09F9/30Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched
Jitsuyo Shinan Koho 1922-1996 Toroku Jitsuyo Shinan Koho 1994-2002
Kokai Jitsuyo Shinan Koho 1971-2002 Jitsuyo Shinan Toroku Koho 1996-2002

Electronic data base consulted during the international search (name of data base and, where practicable, search terms used)

C. DOCUMENTS CONSIDERED TO BE RELEVANT

Category*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
Y	JP 2000-122607 A (Seiko Epson Corporation), 28 April, 2000 (28.04.2000), Par. Nos. [0051] to [0052]; Fig. 4	1-10, 12, 16-18, 20-21, 23-31, 33, 37-45, 47, 51-53, 55-56, 58-60
Y	Par. Nos. [0035] to [0040]; Fig. 1 (Family: none)	23, 58
Y	JP 2000-81920 A (Canon, Inc.), 21 March, 2000 (21.03.2000), Par. Nos. [0013] to [0023]; Fig. 1 & US 6222357 B1	1-10, 12, 16-18, 20-21, 23-31, 33, 37-45, 47, 51-53, 55-56, 58-60
Y	JP 9-114423 A (Sharp Corporation), 02 May, 1997 (02.05.1997), Par. Nos. [0052] to [0055]; Fig. 4 (Family: none)	3, 16, 20-21, 38-40, 44, 51, 55-56

 Further documents are listed in the continuation of Box C. See patent family annex.

- * Special categories of cited documents:
- "A" document defining the general state of the art which is not considered to be of particular relevance
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- "L" document which may throw doubts on priority claim(s) or which is cited to establish the publication date of another citation or other special reason (as specified)
- "O" document referring to an oral disclosure, use, exhibition or other means
- "P" document published prior to the international filing date but later than the priority date claimed

- "T" later document published after the international filing date or priority date and not in conflict with the application but cited to understand the principle or theory underlying the invention
- "X" document of particular relevance; the claimed invention cannot be considered novel or cannot be considered to involve an inventive step when the document is taken alone
- "Y" document of particular relevance; the claimed invention cannot be considered to involve an inventive step when the document is combined with one or more other such documents, such combination being obvious to a person skilled in the art
- "Z" document member of the same patent family

Date of the actual completion of the international search 23 January, 2002 (23.01.02)	Date of mailing of the international search report 05 February, 2002 (05.02.02)
Name and mailing address of the ISA/ Japanese Patent Office	Authorized officer
Faxsimile No.	Telephone No.

Form PCT/ISA/210 (second sheet) (July 1992)

INTERNATIONAL SEARCH REPORT

International application No.

PCT/JP01/09735

C (Continuation). DOCUMENTS CONSIDERED TO BE RELEVANT		
Category*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
Y	WO 98/48403 A1 (Sarnoff Corporation), 29 October, 1998 (29.10.1998), page 3, line 19 to page 6, line 14; Fig. 2	4-10, 26-31, 33-34, 40, 42-45
Y	page 6, line 15 to page 8, line 2; Fig. 3 & EP 978114 A1 & US 6229506 B1 & KR 2001020114 A	17-18, 52-53
Y	JP 11-282419 A (NEC Corporation), 15 October, 1999 (15.10.1999), Par. Nos. [0038] to [0070]; Fig. 1 & US 6091203 A & KR 99078420 A	4-9, 12, 26-30, 33, 42-44, 47
Y	JP 63-179336 A (Hitachi Maxell, Ltd.), 23 July, 1988 (23.07.1988), page 3, lower right column, line 2 to page 4, upper left column, line 19; Fig. 1 (Family: none)	6-9, 27-30, 41-44
Y	JP 11-202294 A (Seiko Epson Corporation), 30 July, 1999 (30.07.1999), Par. No. [0004] (Family: none)	24-25, 59-60
A	JP 7-36409 A (Pioneer Electronic Corporation), 07 February, 1995 (07.02.1995), & US 5594463 A	1-10, 12, 16-18, 20-21, 23-31, 33, 37-45, 47, 51-53, 55-56, 58-60
P, A	JP 2000-329798 A (Sony Corporation), 30 November, 2000 (30.11.2000), & EP 1054410 A1	4-10, 26-31, 33-34, 40, 42-45

Form PCT/ISA/210 (continuation of second sheet) (July 1992)

FIG.34

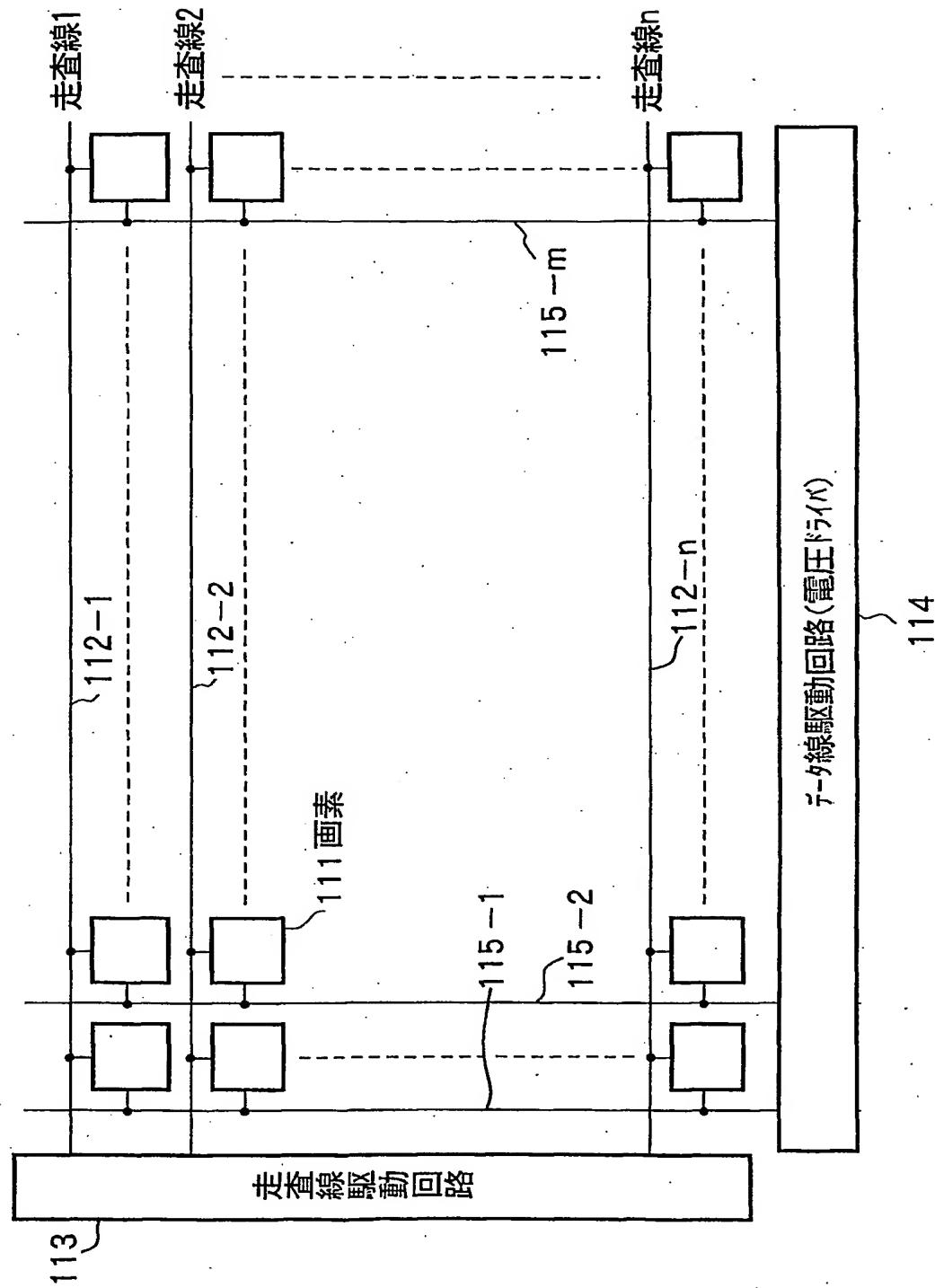


FIG.35

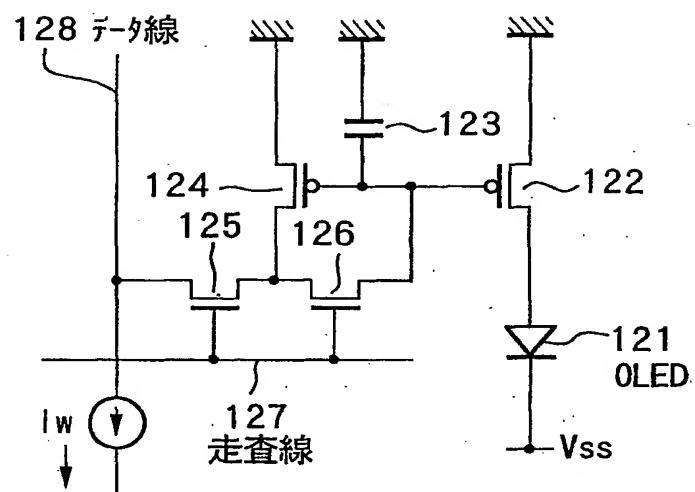


FIG.36

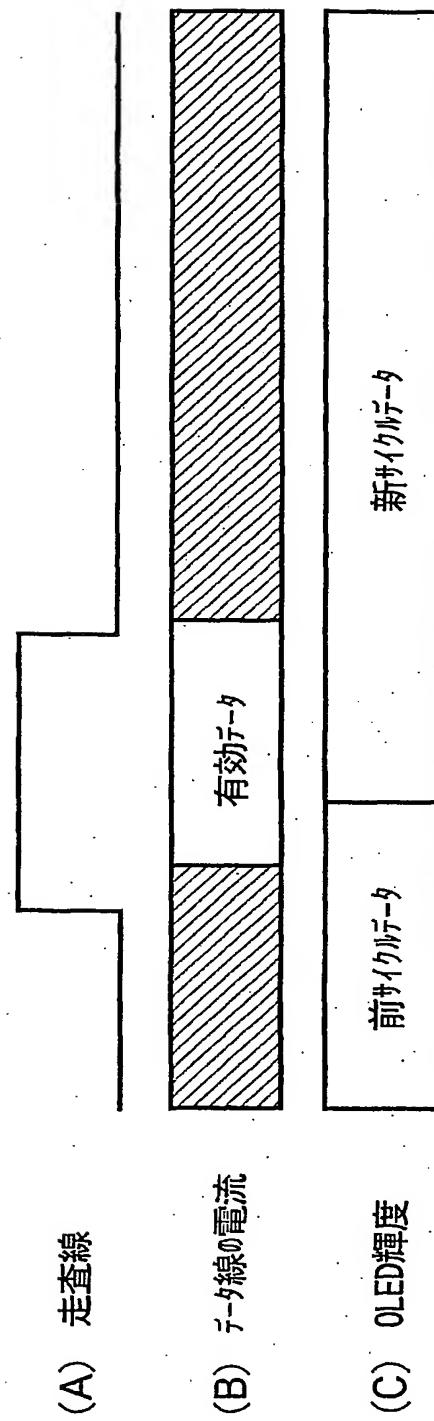


FIG. 37

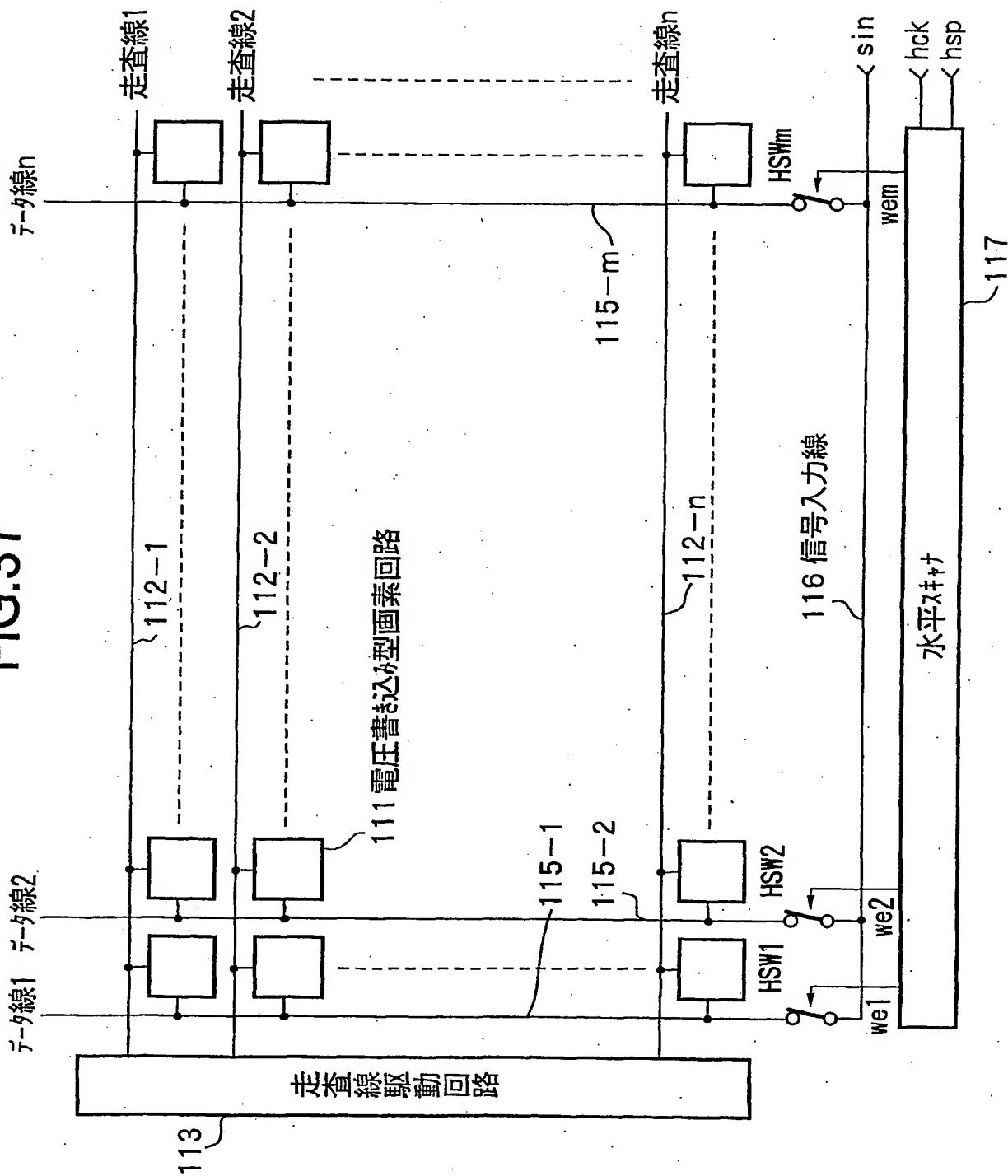


FIG.38

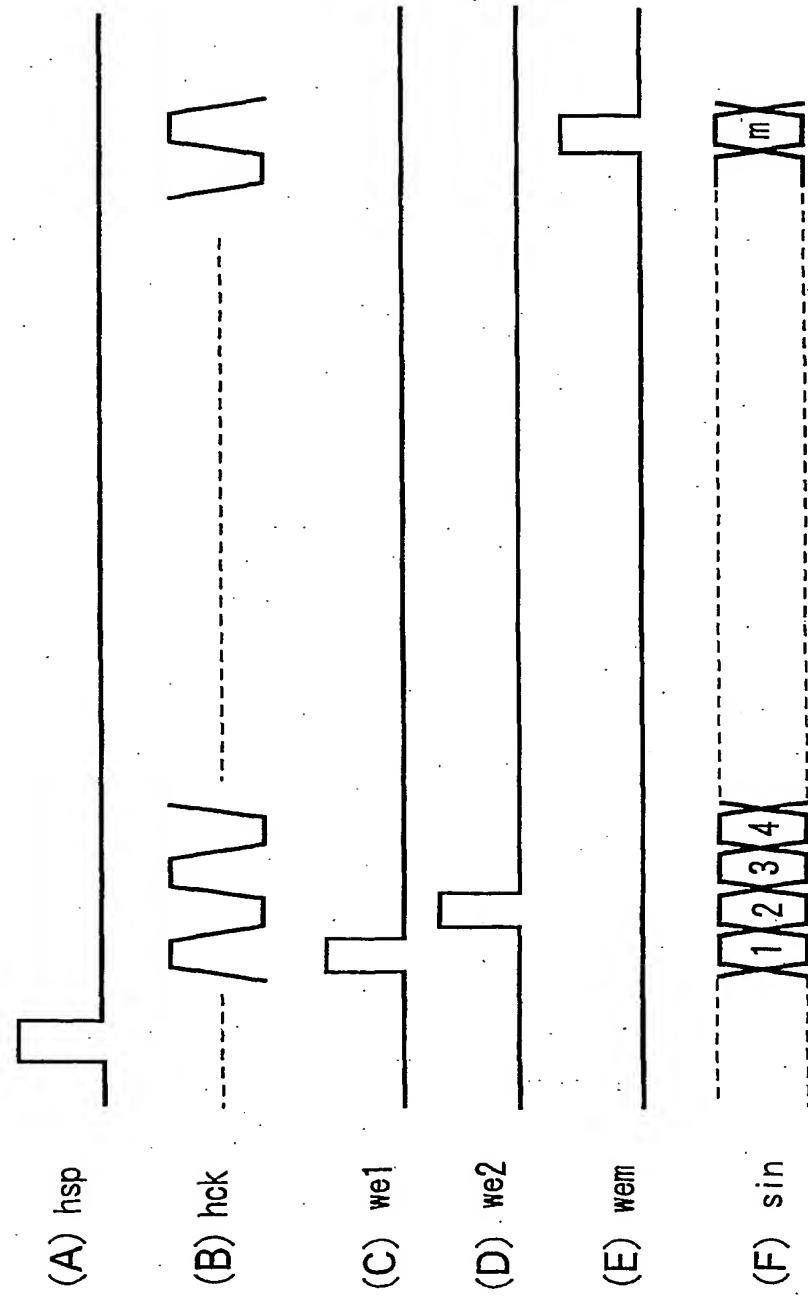
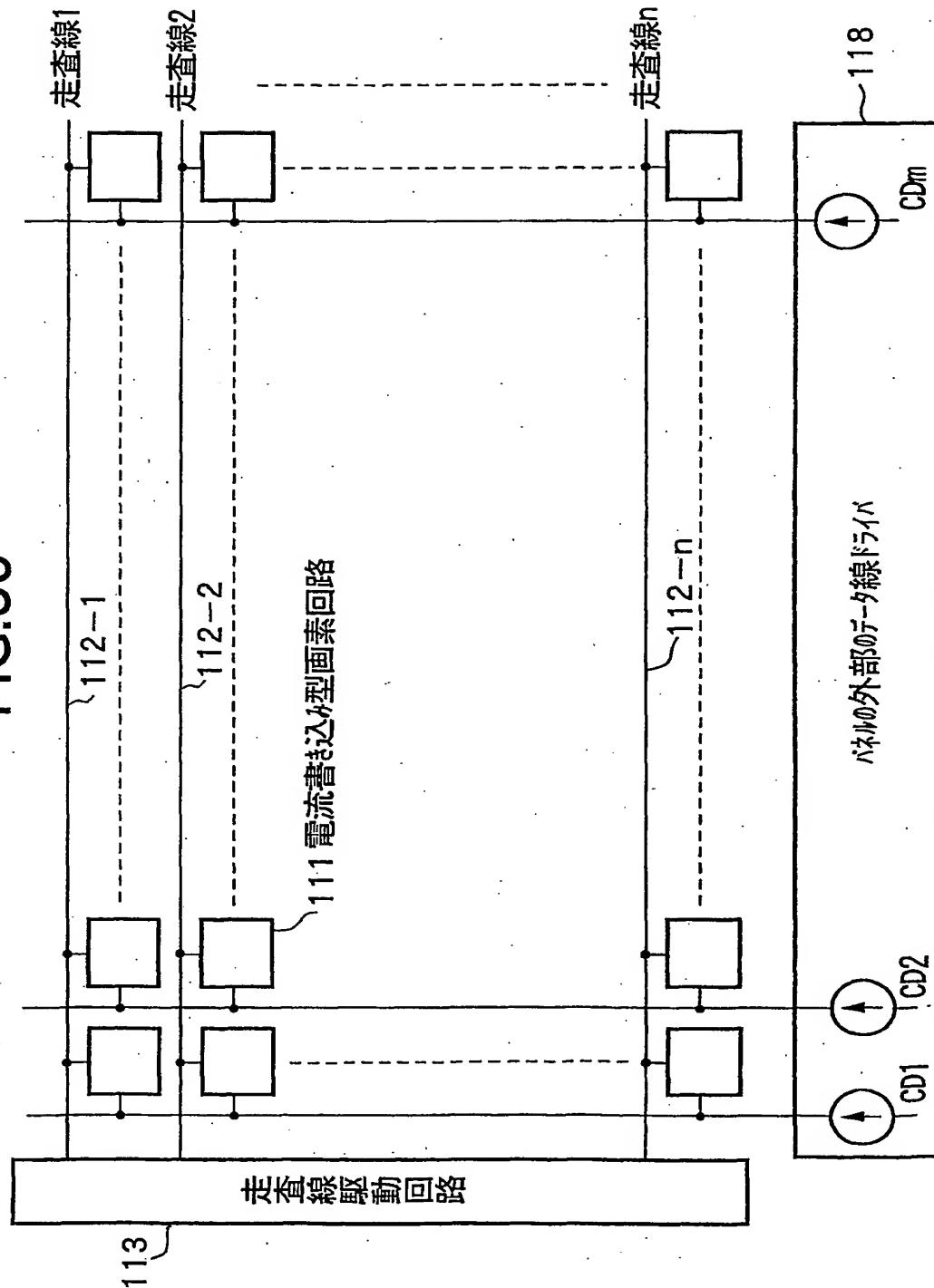


FIG.39



符号の説明

1 1 … 電流書き込み型画素回路

1 2 - 1 ~ 1 2 - n … 走査線

1 3 - 1 ~ 1 3 - m,

1 3 U - 1 ~ 1 3 U - m,

1 3 D - 1 ~ 1 3 D - m … データ線

1 4 … 走査線駆動回路

1 5, 1 9 … データ線ドライバ回路

1 5 - 1 ~ 1 5 - m,

1 5 A - 1 ~ 1 5 A - m,

1 5 B - 1 ~ 1 5 B - m … 電流書き込み型電流ドライバ回路

1 6, 1 6 - 1,

1 6 - 2, 1 6 U - 1,

1 6 U - 2, 1 6 D - 1,

1 6 D - 2 … 信号入力線

1 8 … 水平スキャナ (H S C A N)

1 9 - 1 ~ 1 9 - m,

1 9 A - 1 ~ 1 9 A - m,

1 9 B - 1 ~ 1 9 B - m,

1 9 C - 1 ~ 1 9 C - m … 電圧書き込み型電流ドライバ回路

5 5 … リーク素子

5 6 … プリチャージ素子

INTERNATIONAL SEARCH REPORT

International application No.

PCT/JP01/09735

A. CLASSIFICATION OF SUBJECT MATTER
Int.Cl⁷ G09G3/30

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Y	Par. Nos. [0035] to [0040]; Fig. 1 (Family: none)	23, 58
Y	JP 2000-81920 A (Canon, Inc.), 21 March, 2000 (21.03.2000), Par. Nos. [0013] to [0023]; Fig. 1 & US 6222357 B1	1-10, 12, 16-18, 20-21, 23-31, 33, 37-45, 47, 51-53, 55-56, 58-60
Y	JP 9-114423 A (Sharp Corporation), 02 May, 1997 (02.05.1997), Par. Nos. [0052] to [0055]; Fig. 4 (Family: none)	3, 16, 20-21, 38-40, 44, 51, 55-56

 Further documents are listed in the continuation of Box C. See patent family annex.

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 "P" document published prior to the international filing date but later than the priority date claimed

"T" later document published after the international filing date or priority date and not in conflict with the application but cited to understand the principle or theory underlying the invention
 "X" document of particular relevance; the claimed invention cannot be considered novel or cannot be considered to involve an inventive step when the document is taken alone
 "Y" document of particular relevance; the claimed invention cannot be considered to involve an inventive step when the document is combined with one or more other such documents, such combination being obvious to a person skilled in the art
 "&" document member of the same patent family

Date of the actual completion of the international search
23 January, 2002 (23.01.02)Date of mailing of the international search report
05 February, 2002 (05.02.02)Name and mailing address of the ISA/
Japanese Patent Office

Authorized officer

Facsimile No.

Telephone No.

INTERNATIONAL SEARCH REPORT

International application No.

PCT/JP01/09735

C (Continuation). DOCUMENTS CONSIDERED TO BE RELEVANT

Category*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
Y	WO 98/48403 A1 (Sarnoff Corporation), 29 October, 1998 (29.10.1998), page 3, line 19 to page 6, line 14; Fig. 2	4-10, 26-31, 33-34, 40, 42-45
Y	page 6, line 15 to page 8, line 2; Fig. 3 & EP 978114 A1 & US 6229506 B1 & KR 2001020114 A	17-18, 52-53
Y	JP 11-282419 A (NEC Corporation), 15 October, 1999 (15.10.1999), Par. Nos: [0038] to [0070]; Fig. 1 & US 6091203 A & KR 99078420 A	4-9, 12, 26-30, 33, 42-44, 47
Y	JP 63-179336 A (Hitachi Maxell, Ltd.), 23 July, 1988 (23.07.1988), page 3, lower right column, line 2 to page 4, upper left column, line 19; Fig. 1 (Family: none)	6-9, 27-30, 41-44
Y	JP 11-202294 A (Seiko Epson Corporation), 30 July, 1999 (30.07.1999), Par. No. [0004] (Family: none)	24-25, 59-60
A	JP 7-36409 A (Pioneer Electronic Corporation), 07 February, 1995 (07.02.1995), & US 5594463 A	1-10, 12, 16-18, 20-21, 23-31, 33, 37-45, 47, 51-53, 55-56, 58-60
P, A	JP 2000-329798 A (Sony Corporation), 30 November, 2000 (30.11.2000), & EP 1054410 A1	4-10, 26-31, 33-34, 40, 42-45

A. 発明の属する分野の分類 (国際特許分類 (IPC))

Int. Cl⁷ G09G 3/30

B. 調査を行った分野

調査を行った最小限資料 (国際特許分類 (IPC))

Int. Cl⁷ G09G 3/30, 3/32, 3/36, G09F 9/30

最小限資料以外の資料で調査を行った分野に含まれるもの

日本国実用新案公報	1922-1996年
日本国公開実用新案公報	1971-2002年
日本国登録実用新案公報	1994-2002年
日本国実用新案登録公報	1996-2002年

国際調査で使用した電子データベース (データベースの名称、調査に使用した用語)

C. 関連すると認められる文献

引用文献の カテゴリー*	引用文献名 及び一部の箇所が関連するときは、その関連する箇所の表示	関連する 請求の範囲の番号
Y	JP 2000-122607 A (セイコーエプソン株式会社) 2000. 04. 28 【0051】～【0052】，【図4】	1-10, 12, 16-1 8, 20-21, 23-3 1, 33, 37-45, 4 7, 51-53, 55-5 6, 58-60
Y	【0035】～【0040】，【図1】 (ファミリーなし)	23, 58

 C欄の続きにも文献が列挙されている。 パテントファミリーに関する別紙を参照。

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 「O」口頭による開示、使用、展示等に言及する文献
 「P」国際出願日前で、かつ優先権の主張の基礎となる出願

の日の後に公表された文献

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 「Y」特に関連のある文献であって、当該文献と他の1以上の文献との、当業者にとって自明である組合せによって進歩性がないと考えられるもの
 「&」同一パテントファミリー文献

国際調査を完了した日

23. 01. 02

国際調査報告の発送日

05.02.02

国際調査機関の名称及びあて先

日本国特許庁 (ISA/JP)
 郵便番号 100-8915
 東京都千代田区霞が関三丁目4番3号

特許庁審査官 (権限のある職員)

濱本 権広

2G 9509



電話番号 03-3581-1101 内線 3225

C(続き)	関連すると認められる文献	関連する 請求の範囲の番号
引用文献の カテゴリー*	引用文献名 及び一部の箇所が関連するときは、その関連する箇所の表示	
Y	JP 2000-81920 A (キヤノン株式会社) 2000. 03. 21, 【0013】 ~ 【0023】 , 【図1】 & US 6222357 B1	1-10, 12, 16-1 8, 20-21, 23-3 1, 33, 37-45, 4 7, 51-53, 55-5 6, 58-60
Y	JP 9-114423 A (シャープ株式会社) 1997. 05. 02, 【0052】 ~ 【0055】 , 【図4】 (ファミリーなし)	3, 16, 20-21, 3 8-40, 44, 51, 5 5-56
Y	WO 98/48403 A1 (SARNOFF CORPORATION) 1998. 10. 29 第3頁第19行~第6頁第14行, 図2	4-10, 26-31, 3 3-34, 40, 42-4 5
Y	第6頁第15行~第8頁第2行, 図3 & EP 978114 A1 & US 6229506 B1 & KR 2001020114 A	17-18, 52-53
Y	JP 11-282419 A (日本電気株式会社) 1999. 10. 15, 【0038】 ~ 【0070】 , 【図1】 & US 6091203 A & KR 99078420 A	4-9, 12, 26-3 0, 33, 42-44, 4 7
Y	JP 63-179336 A (日立マクセル株式会社) 1988. 07. 23, 第3頁右下欄第2行~第4頁左上欄第19行, 第1図 (ファミリーなし)	6-9, 27-30, 41 -44
Y	JP 11-202294 A (セイコーエプソン株式会社) 1999. 07. 30, 【0004】 (ファミリーなし)	24-25, 59-60
A	JP 7-36409 A (パイオニア株式会社) 1995. 02. 07 & US 5594463 A	1-10, 12, 16-1 8, 20-21, 23-3 1, 33, 37-45, 4 7, 51-53, 55-5 6, 58-60
P, A	JP 2000-329798 A (ソニー株式会社) 2000. 11. 30 & EP 1054410 A1	4-10, 26-31, 3 3-34, 40, 42-4 5